

CE/EMC COMPLIANCE REPORT

For

CHIPSEE CO., LIMITED.

Embedded Industrial Computer

Prepared for : CHIPSEE CO., LIMITED.

Address : Xinyuan Science Park B406,97 Changping Road, Changping
District, Beijing, 102206, China

Prepared by : EST Technology Co., Ltd.

Address : Chilingxiang, Qishantou, Santun, Houjie, Dongguan,
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Report Number : ESTE-E2102009

Date of Report : Feb. 04, 2021

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EST Technology Co., Ltd.

Applicant:	CHIPSEE CO., LIMITED.		
Address:	Xinyuan Science Park B406,97 Changping Road, Changping District, Beijing, 102206, China		
Manufacturer:	CHIPSEE CO., LIMITED.		
Address:	Xinyuan Science Park B406,97 Changping Road, Changping District, Beijing, 102206, China		
Factory:	CHIPSEE CO., LIMITED.		
Address:	Xinyuan Science Park B406,97 Changping Road, Changping District, Beijing, 102206, China		
E.U.T:	Embedded Industrial Computer		
Model Number:	CSxyRzP (x, y, z are variable, Please see section 1.3 of the report)		
Trade Name:	Chipsee	Serial No:	-----
Date of Receipt:	Jan. 22, 2021	Date of Test:	Jan. 26~Feb. 02, 2021
Test Specification:	EN 55032:2015+A11:2020 EN 55035:2017 EN IEC 61000-3-2:2019 EN 61000-3-3:2013+A1:2019		
Test Result:	The equipment under test was found to be compliance with the requirements of the standards applied.		
		Issue Date: Feb. 04, 2021	
Prepared by:	Reviewed by:	Approved by:	
 Lena / Assistant	 Sean/ Engineer	 Iceman Hu / Manager	
Other Aspects: None.			
Abbreviations: OK/P=passed fail/F=failed n.a/N=not applicable E.U.T=equipment under tested			
This test report is based on a single evaluation of one sample of above mentioned products ,It is not permitted to be duplicated in extracts without written approval of EST Technology Co., Ltd. The statement of compliance in this report is based on the limit in the test standard, the measurement uncertainty is not considered.			

1. GENERAL PRODUCT INFORMATION

1.1. Product Function

Refer to Technical Construction Form and User Manual.

1.2. Description of Device (EUT)

Description	: Embedded Industrial Computer
Model No.	: CS19108R236P
System Input Voltage	: AC 100-240V, 50-60Hz
Power	: 8.4 W
LAN Line	: Unshielded, Detachable 0.8m
AC Line	: Unshielded, Detachable 1.5m
DC Line	: Unshielded, Detachable 1.0m

1.3. Difference between Model Numbers

Note: CSxyRzP

x =80,10,12,14,19 represent different horizontal resolutions, For example
80 Means 800 Pixel; 10 Means 1024 Pixel; 12 Means 1280 Pixel; 14 Means 1440 Pixel
19 Means 1 920 Pixel;
y=480,600,768,800,900,102,108, represents different vertical resolutions
480 Means 480 Pixel; 600 Means 600 Pixel; 768 Means 768 Pixel; 800 Means 800 Pixel
900 Means 900 Pixel; 102 Means 1024 Pixel; 108 Means 1080 Pixel
z=050,070,080,097,101,104,125,133,156,173,190,215,236, represents size difference:
For example, 050 Means 5.0 Inch, 070 Means 7 .0 Inch; 080 Means 8.0 Inch
097 Means 9.7 Inch; 101 Means 10.1 Inch; 104 Means 10.4 Inch; 125 Means 12.5 Inch
133 Means 13.3 Inch; 156 Means 15.6 Inch; 173 Means 17.3 Inch; 190 Means 19.0 Inch
215 Means 21.5 Inch; 236 Means 23.6 Inch

1.4. Independent Operation Modes

The basic operation modes are:

1.4.1. LAN Mode

1.4.2. Bluetooth Mode

1.4.3. Wi-Fi Mode

1.4.4. USB Mode

1.4.5. Type-C Mode

1.5. Test Supporting System

2. TEST SITES

2.1. Description of Standards and Results

The EUT have been tested according to the applicable standards as referenced below.

EMISSION(EN 55032:2015+A11:2020)				
Description of Test Item	Standard	Limits		Results
Conducted emissions (AC mains power ports)	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 8.97dB at 29.84MHz		
Asymmetric mode conducted emissions	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 24.59dB at 15.31MHz		
Conducted differential voltage emissions	EN 55032:2015+A11:2020	-----		N/A
		More than ** dB below the limit line.		
Radiated Emission	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 10.54dB at 30.00MHz		
Radiated Emission Test (above 1GHz)	EN 55032:2015+A11:2020	Class A		PASS
		Minimum passing margin is 6.94dB at 4825.00MHz		
Harmonic current emissions	EN IEC 61000-3-2:2019	Class A		N/A
Voltage fluctuations & flicker	EN 61000-3-3:2013+A1:2019	Section 4.6		PASS
IMMUNITY (EN 55035:2017)				
Description of Test Item	Basic Standard	Performanc e Criteria	Observation Criteria	Results
Electrostatic discharge (ESD)	EN 61000-4-2:2009	B	B	PASS
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3:2006+A1: 2008+A2:2010	A	A	PASS
Electrical fast transient (EFT)	EN 61000-4-4:2012	B	B	PASS
Surge (Input a.c. power port)	EN 61000-4-5:2014	B	B	PASS
Radio-frequency, Continuous conducted disturbance	EN 61000-4-6:2014	A	A	PASS
Power frequency magnetic field	EN 61000-4-8:2010	A	A	PASS
Voltage dips, >95% reduction	EN 61000-4-11:2004	B	B	PASS
Voltage dips, 30% reduction		C	C	PASS
Voltage interruptions		C	C	PASS
N/A is an abbreviation for Not Applicable.				

2.2. Test Facilities

EMC Lab : Certificated by CNAS, CHINA
Registration No.: L5288
This Certificate is valid until: November 12, 2023

Certificated by FCC, USA
Designation Number: CN1215
This Certificate is valid until: January 31, 2022

Certificated by A2LA, USA
Registration No.: 4366.01
This Certificate is valid until: January 31, 2022

Certificated by Industry Canada
CAB identifier No.: CN0035
This Certificate is valid until: January 31, 2022

Certificated by VCCI, Japan
Registration No.: C-14103; T-20073; R-13663;
R-20103; G-20097
Date of registration: Apr. 20, 2020
This Certificate is valid until: Apr. 19, 2023

Certificated by TUV Rheinland, Germany
Registration No.: UA 50413872 0001
Date of registration: July 31, 2018

Certificated by Intertek
Registration No.: 2011-RTL-L2-64
Date of registration: November 08, 2018

Name of Firm : EST Technology Co., Ltd.

Site Location : Chilingxiang, Qishantou, Santun, Houjie, Dongguan,
Guangdong, China

2.3.List of Test and Measurement Instruments

2.3.1. For conducted emission at the mains terminals test (1# conduction)

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESHS30	EST-E001	June 13,20	1 Year
Artificial Mains Network	Rohde & Schwarz	ENV216	EST-E002	June 13,20	1 Year
Pulse Limiter	Rohde & Schwarz	ESH3-Z2	EST-E078	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

2.3.2. For asymmetric mode conducted emissions test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESPR3	EST-E070	June 13,20	1 Year
ISN	Teseq	T8	EST-E041	June 13,20	1 Year
Current Transformer	SCHWARZBECK	SW9605	EST-E045	June 13,20	1 Year
Voltage Probe	SCHWARZBECK	TK9420	EST-E046	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

2.3.3. For radiated emission test (2# 966 radiation)

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESCI3	EST-E071	June 13,20	1 Year
Bilog Antenna	Teseq	CBL 6111D	EST-E053	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

2.3.4. For radiated emission test (above 1GHz)

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EMI Test Receiver	Rohde & Schwarz	ESR7	EST-E047	June 13,20	1 Year
Horn Antenna	SCHWARZBECK	BBHA 9120 D	EST-E031	June 13,20	1 Year
Test Software	Audix	e3-6.111221a	N/A	N/A	N/A

2.3.5. For harmonic current emissions and voltage fluctuations/flicker test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Power Analyzer	California Instruments	3001IX-208-CTS	EST-E011	June 13,20	1 Year
Voltage Source	California Instruments	3001IX-208	EST-E012	June 13,20	1 Year
Test Software	California Instruments	CTS	N/A	N/A	N/A

2.3.6. For electrostatic discharge immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
ESD Generator	HAEFELY	ONYX16	EST-E013	June 13,20	1 Year

2.3.7. For electrical fast transient/burst immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
EFT Generator	EMC PARTNER	TRANSIENT 2000	EST-E074	June 13,20	1 Year
Capacitive Coupling Clamp	HAEFELY	IP4A	EST-E040	June 13,20	1 Year

2.3.8. Radio Frequency Electromagnetic Field Immunity (R/S) Test\

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Agilent	N5181A	EST-E060	June 13,20	1 Year
Power Amplifier	SKET	HAP801000M-250W	EST-E061	N/A	N/A
Power Amplifier	SKET	HAP0103G-75W	EST-E062	N/A	N/A
Power Amplifier	SKET	HAP0306G-50W	EST-E063	N/A	N/A
Power Meter	Agilent	E4419B	EST-E064	June 13,20	1 Year
Power sensor	Agilent	E9301A	EST-E065	June 13,20	1 Year
Power sensor	HP	E9301A	EST-E066	June 13,20	1 Year
Antenna	Schwarzbeck	STLP 9129	EST-E059	N/A	N/A
E-Field Probe	Narda	EP-601	EST-E067	June 13,20	1 Year
Audio Analyzer	Rohde &Schwarz	UPV	EST-E024	June 13,20	1 Year
Test Software	SKET	EMC-S	V1.2.0.48	N/A	N/A

2.3.9. For surge immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Surge Controller	HAEFELY	PSURGE8000	EST-E015	June 13,20	1 Year
Surge Impulse Module	HAEFELY	PIM100	EST-E016	June 13,20	1 Year
Surge Coupling Network	HAEFELY	PCD100	EST-E017	June 13,20	1 Year

2.3.10.For injected currents susceptibility test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Signal Generator	Rohde &Schwarz	SMB100A	EST-E025	June 13,20	1 Year
Power Amplifier	FRANKONIA	CIT-10	EST-E021	June 13,20	1 Year
Power Meter	Rohde &Schwarz	NRVS	EST-E027	June 13,20	1 Year
Audio Analyzer	Rohde &Schwarz	UPV	EST-E024	June 13,20	1 Year
CDN	FRANKONIA	CDN-M2+M3	EST-E022	June 13,20	1 Year
EM-Clamp	FRANKONIA	EMCL-20	EST-E042	June 13,20	1 Year
Test Software	SKET	EMC-S	V1.2.0.80	N/A	N/A

2.3.11.For power frequency magnetic field immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
Magnetic Field Tester	HAEFELY	MFS 100	EST-E018	June 13,20	1 Year

2.3.12.For voltage dips and short interruptions immunity test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Next Cal.
DIPS Tester	EMC PARTNER	TRANSIENT 2000	EST-E074	June 13,20	1 Year

Note: All calibration reports of the equipment were provided by LiSai calibration and Testing

3. TEST SET-UP AND OPERATION MODES

3.1. Principle of Configuration Selection

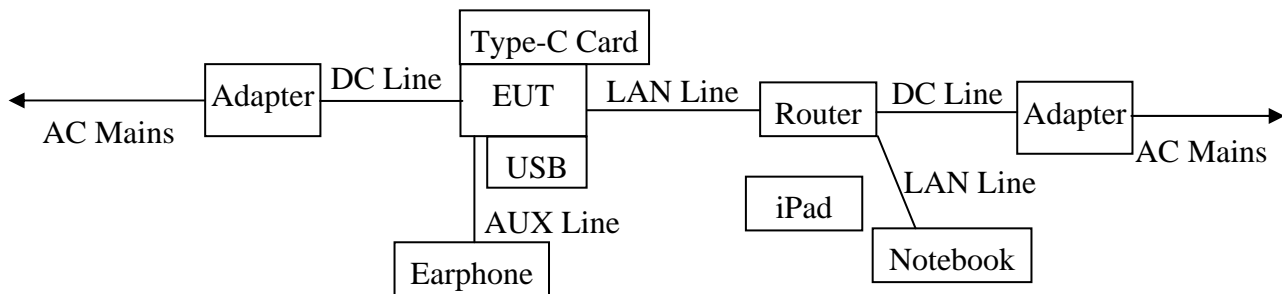
Emission: The equipment under test (EUT) was configured to measure its highest possible radiation level. The test modes were adapted accordingly in reference to the Operating Instructions.

Immunity: The equipment under test (EUT) was configured to the representative operating mode and conditions.

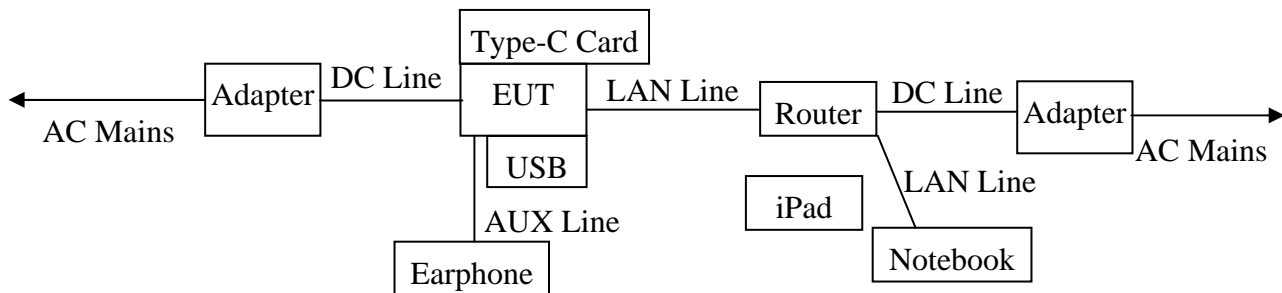
3.2. Block Diagram of Test Set-up

System Diagram of Connections Between EUT and Simulators

3.2.1. For emission test



3.2.2. For immunity test



(EUT: Embedded Industrial Computer)

3.3. Test Operation Mode and Test Software

Refer to Test Setup in clause 4 & 5.

3.4. Special Accessories and Auxiliary Equipment

3.4.1. Router

M / N	:	RT-AC66U
S / N	:	G1ICGG000260
Manufacturer	:	ASUS
Ethernet Line	:	Shielded, Detachable 1.5m

3.4.2.Notebook

M / N : Lutitude 3379
S / N : 73CMNA00DPC
Manufacturer : DELL

3.4.3.iPad

M / N : A1893
S / N : DMPY3KL5JF8K
Manufacturer : Apple

3.4.4.U Disc

M / N : SDCZ7-4096
S / N : BH0701AGOB
Manufacturer : SanDisk

3.4.5.SD Card

M / N : SDSQUNC-032G-ZN6MA
Manufacturer : SanDisk

3.4.6.Earphone

M / N : KDM-430
Manufacturer : KEENION
Data Cable : Unshielded, Undetachable, 1.6m

3.4.7.Adapter

M / N : ADP-60E24
Input : AC 100-240V, 50-60Hz, 1.5A MAX
Output : DC 24V $\overline{=}$ 2.5A

3.5. Countermeasures to Achieve EMC Compliance

None.

4. EMISSION TEST RESULTS

4.1. Conducted Emission at the Mains Terminals Test

RESULT : **Pass**
Test procedure : EN 55032:2015+A11:2020
Frequency range : 0.15~30MHz
Test Site : 1# Conduction Shielded Room
Limits : EN 55032:2015+A11:2020 Class A

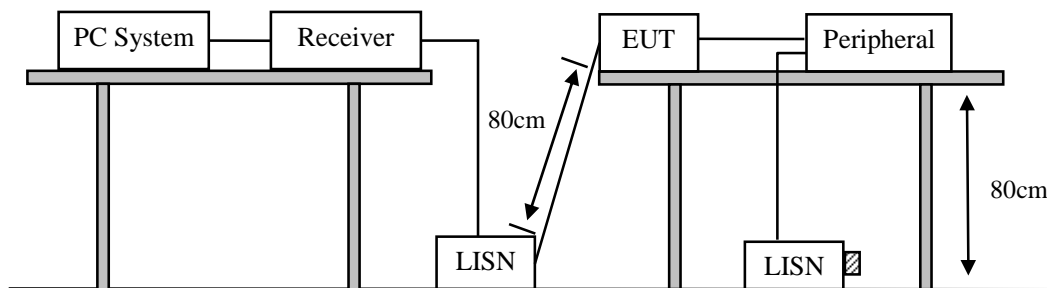
Test Setup

Date of test : Jan. 30, 2021
Model No. : CS19108R236P
Input Voltage : DC 24V From Adapter Input AC 230V/50Hz,
DC 24V From Adapter Input AC 110V/60Hz
Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode,
Type-C Mode

The bandwidth of the test receiver was set at 9kHz.

The frequency range from 150 kHz to 30 MHz was investigated.

The test data of the worst case condition(s) was reported on the following page.

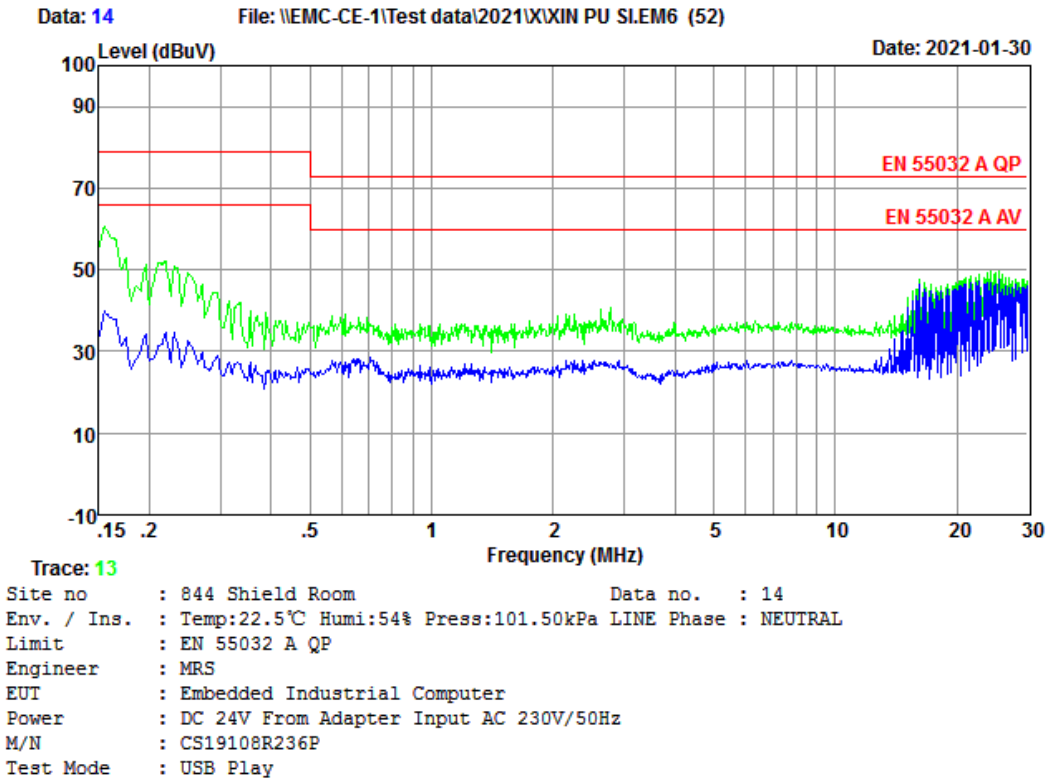


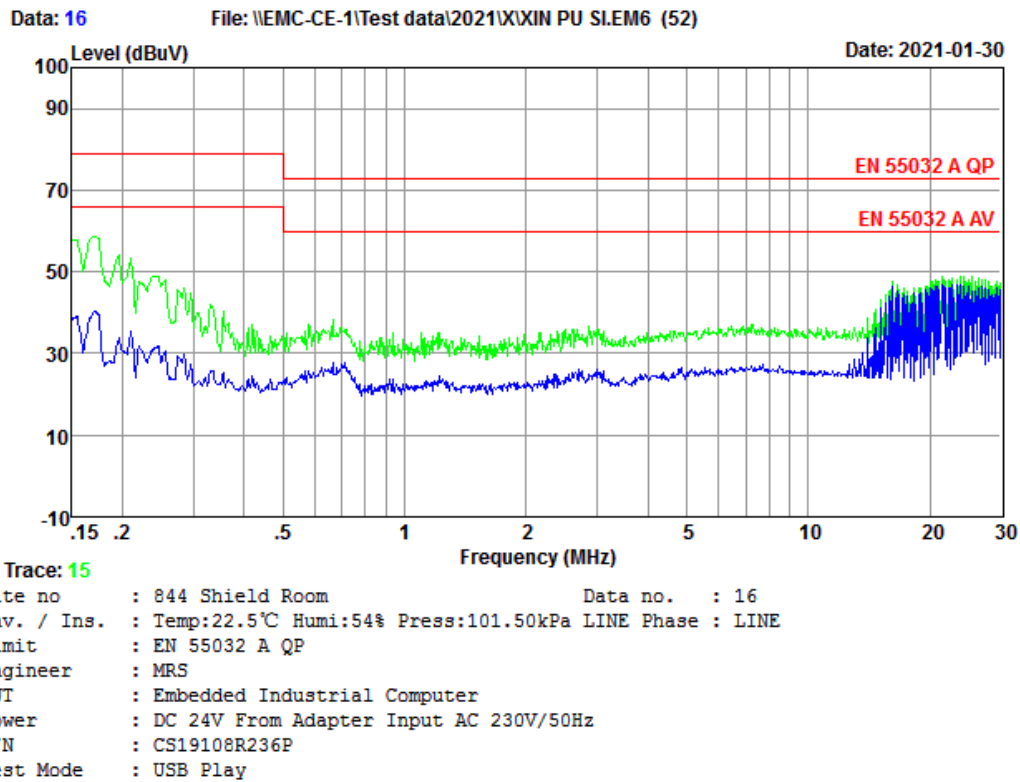
Note: Test uncertainty: $\pm 3.38\text{dB}$ at a level of confidence of 95%.(1#CE)

Test Data

EST Technology

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Houjie, Dongguan, Guangdong, China
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Fax: +86-769-83081878

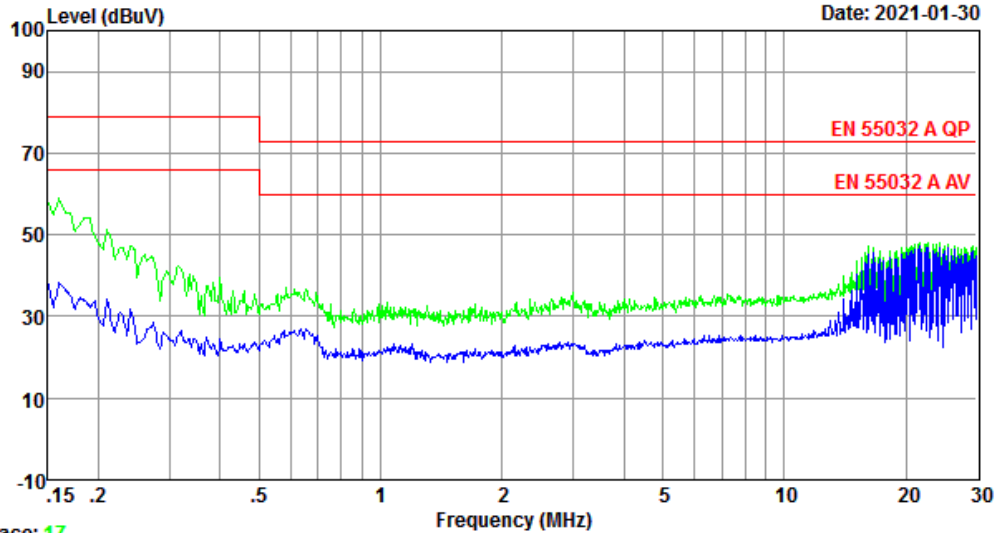




Data: 18

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30



Trace: 17

Site no : 844 Shield Room Data no. : 18

Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : LINE

Limit : EN 55032 A QP

Engineer : MRS

EUT : Embedded Industrial Computer

Power : DC 24V From Adapter Input AC 110V/60Hz

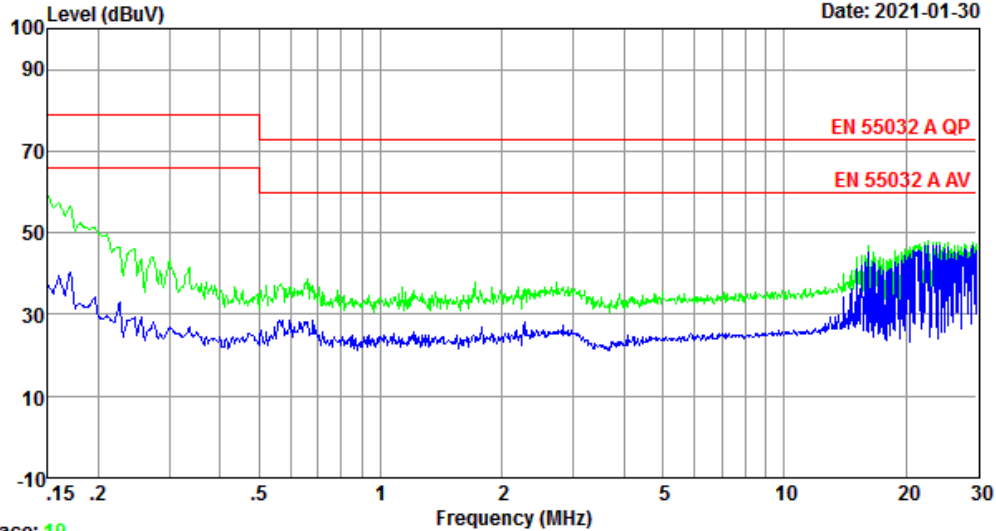
M/N : CS19108R236P

Test Mode : USB Play

Data: 20

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30

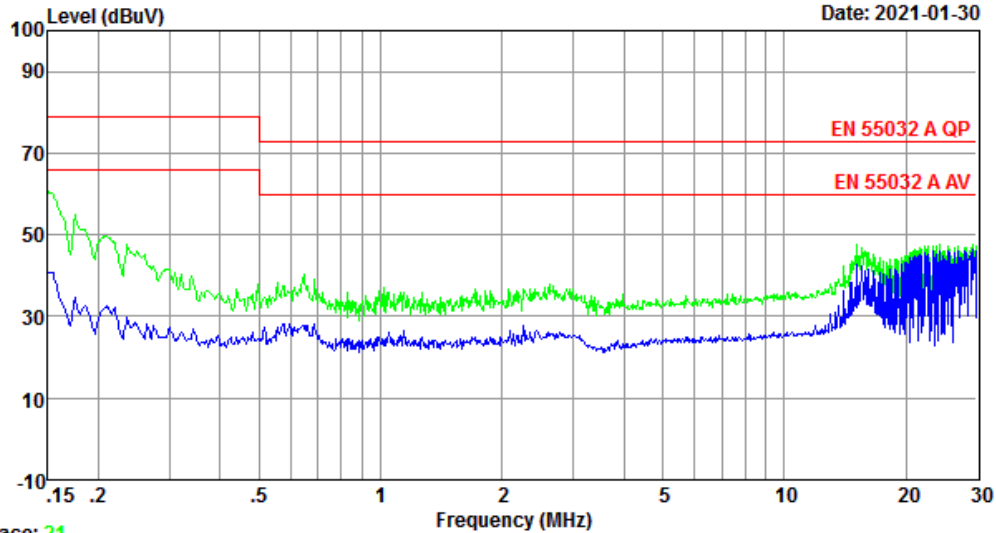


Trace: 19
Site no : 844 Shield Room Data no. : 20
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : USB Play

Data: 22

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30

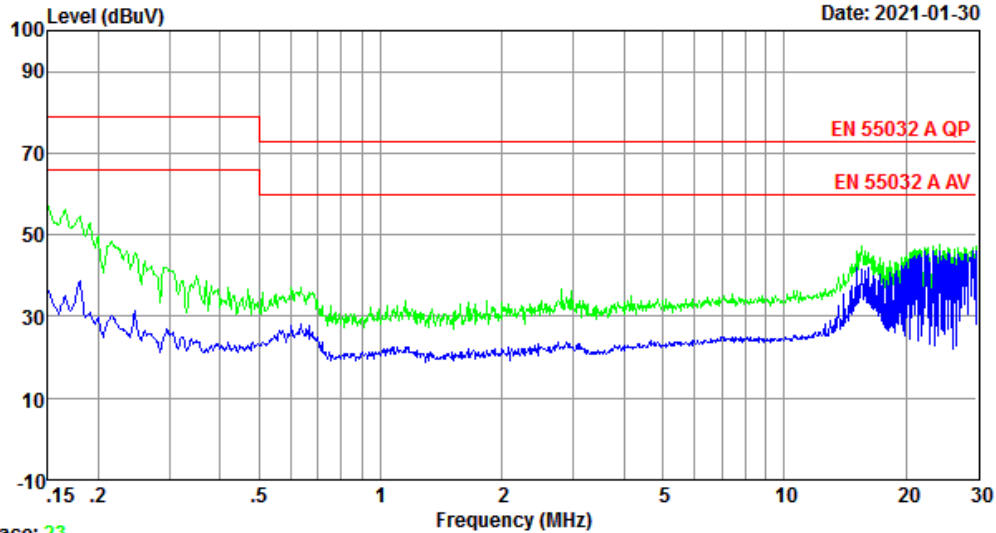


Trace: 21
Site no : 844 Shield Room Data no. : 22
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 24

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30



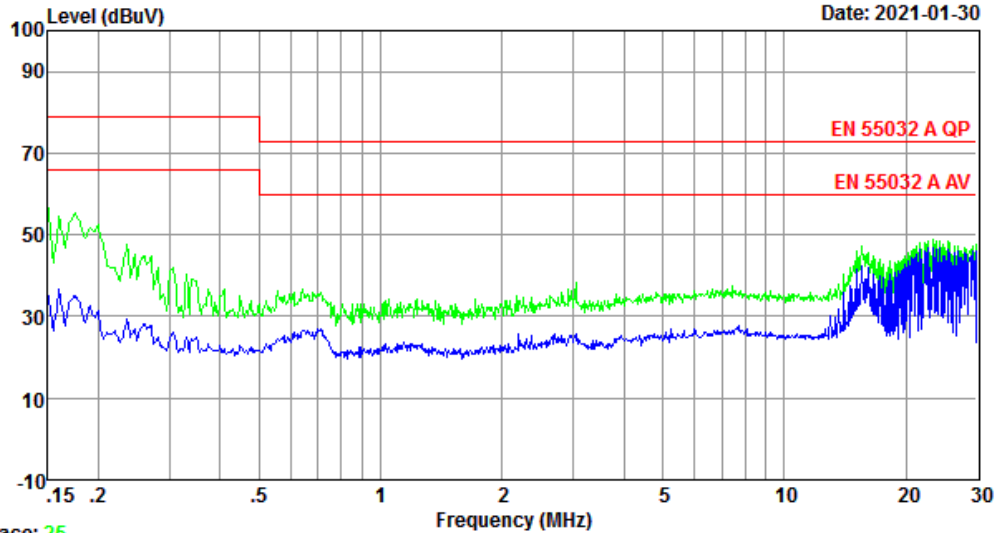
Trace: 23

Site no : 844 Shield Room Data no. : 24
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : LINE
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 26

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30



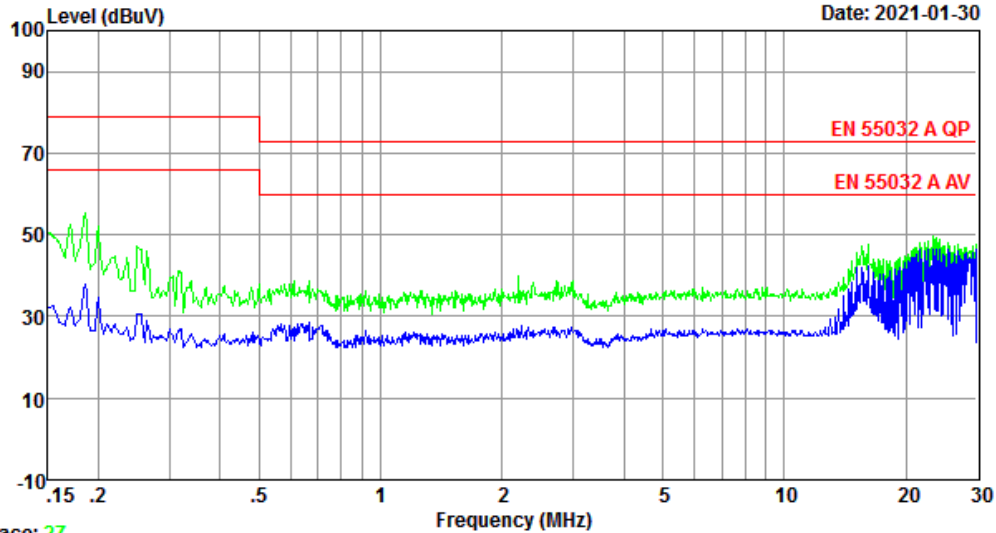
Trace: 25

Site no : 844 Shield Room Data no. : 26
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : LINE
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 28

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30

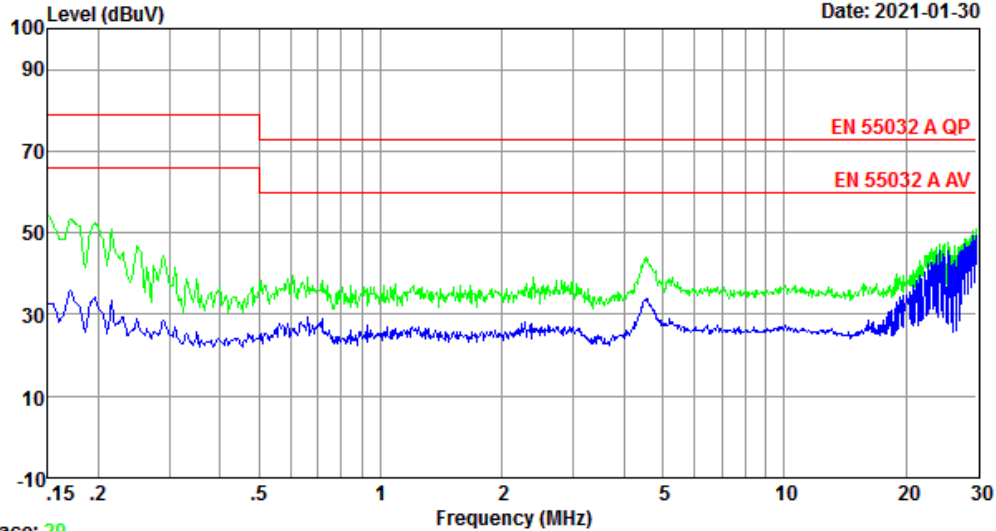


Site no : 844 Shield Room Data no. : 28
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 30

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30

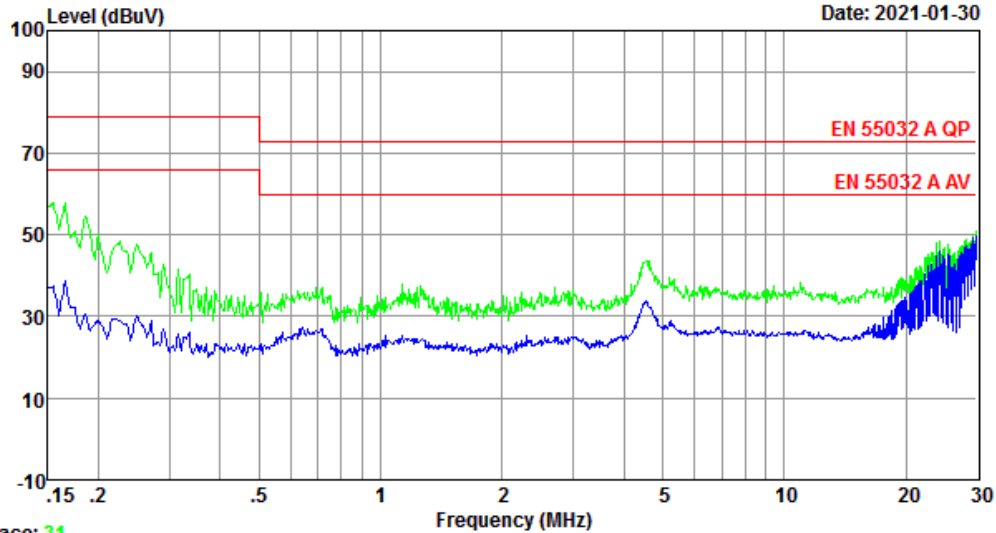


Trace: 29
Site no : 844 Shield Room Data no. : 30
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 32

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30



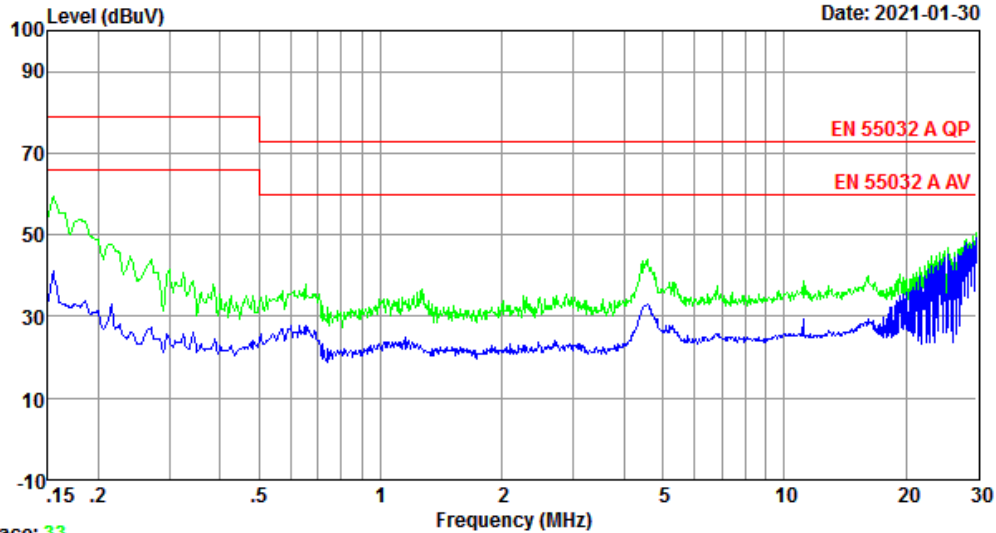
Trace: 31

Site no : 844 Shield Room Data no. : 32
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : LINE
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 34

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30



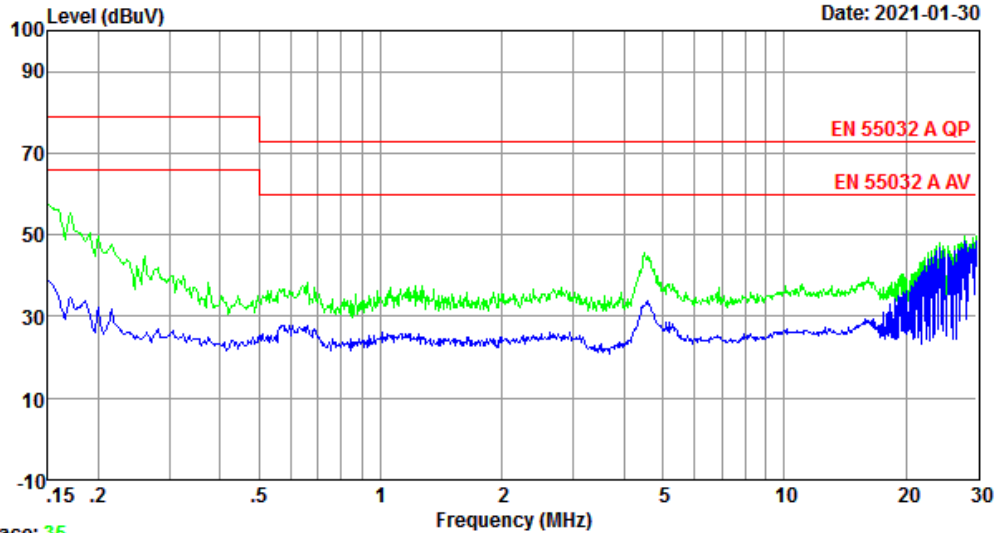
Trace: 33

Site no : 844 Shield Room Data no. : 34
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : LINE
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 36

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30



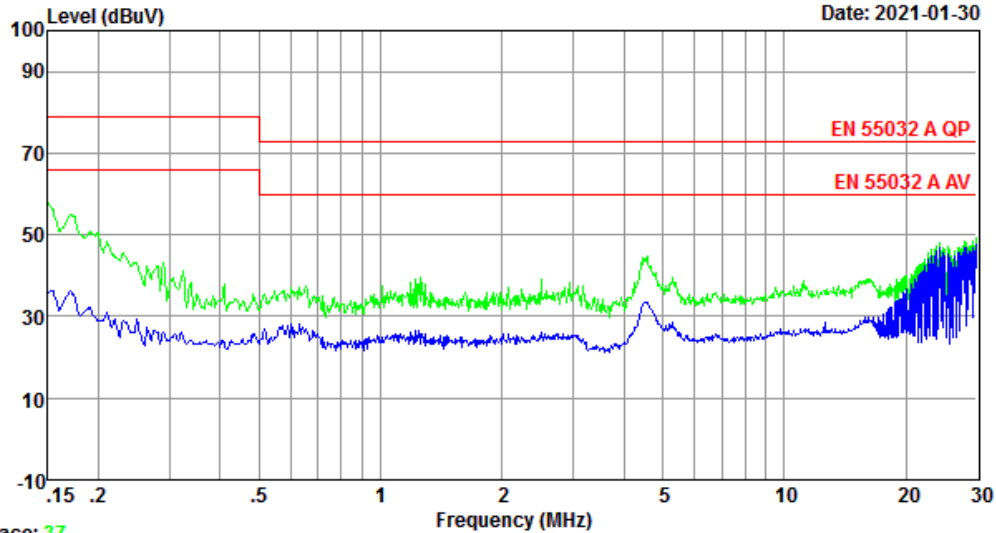
Trace: 35

Site no : 844 Shield Room Data no. : 36
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 38

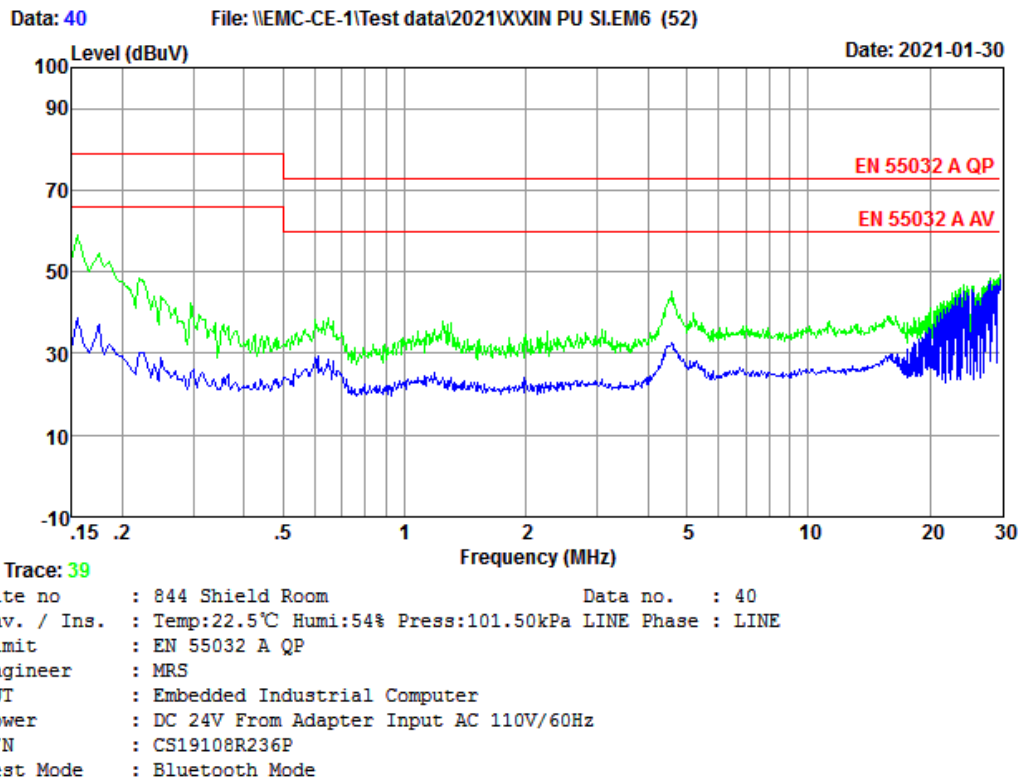
File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

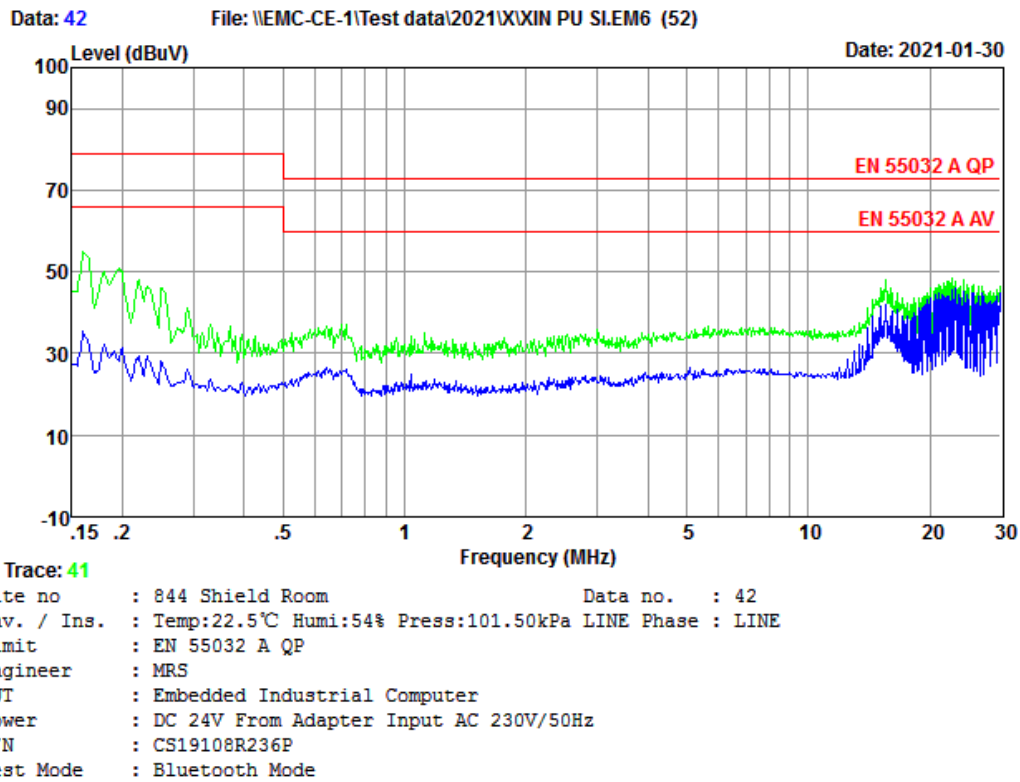
Date: 2021-01-30

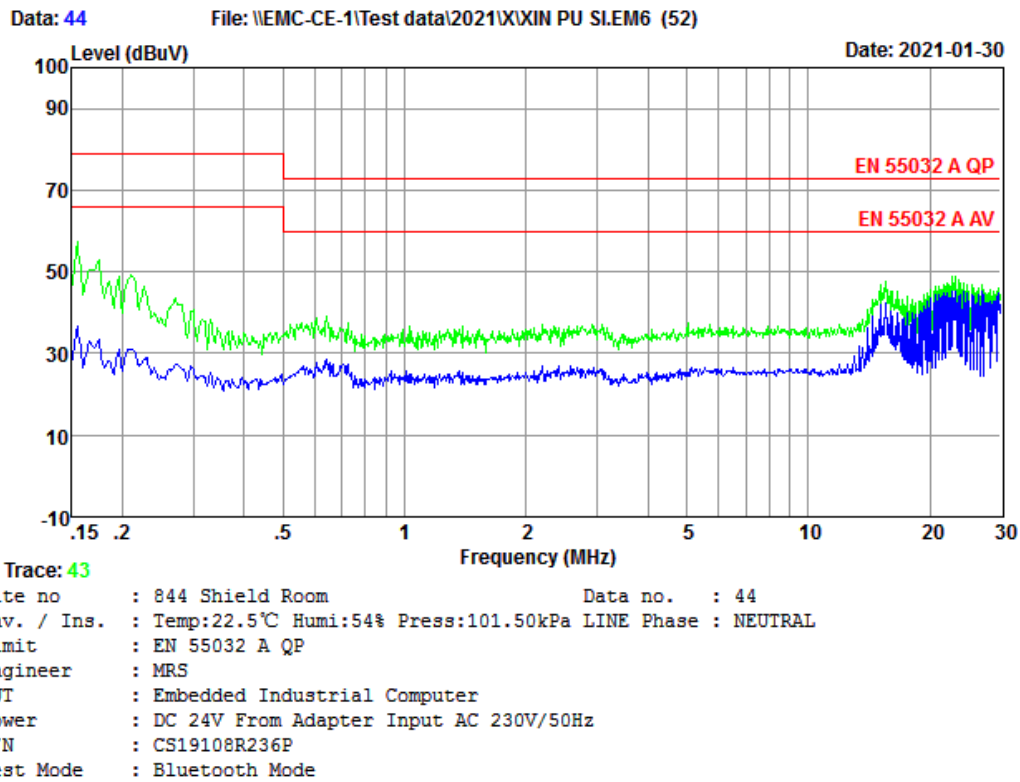


Trace: 37

Site no : 844 Shield Room Data no. : 38
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode



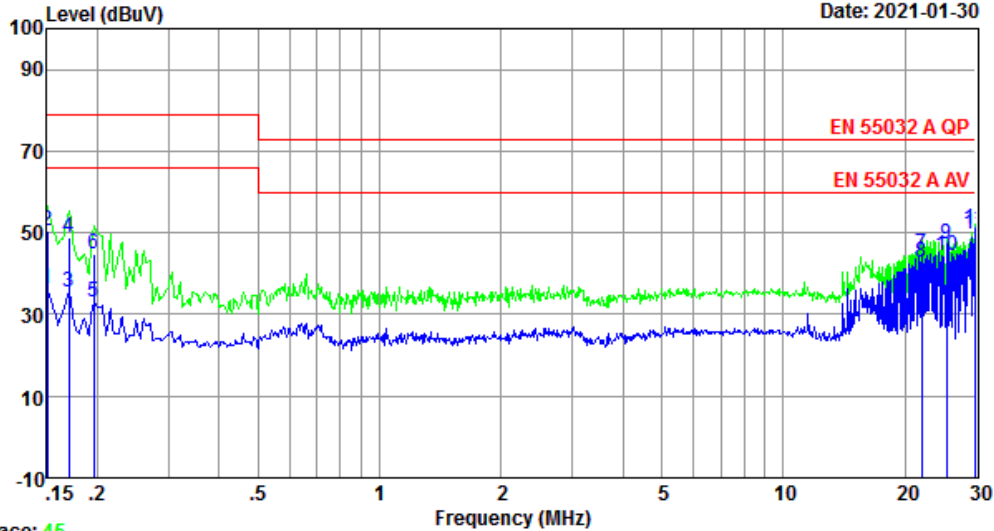




Data: 46

File: \\EMC-CE-1\Test data\2021\X\XIN PU SIEM6 (52)

Date: 2021-01-30



Trace: 45

Site no : 844 Shield Room Data no. : 46
 Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
 Limit : EN 55032 A QP
 Engineer : MRS
 EUT : Embedded Industrial Computer
 Power : DC 24V From Adapter Input AC 230V/50Hz
 M/N : CS19108R236P
 Test Mode : WiFi Mode

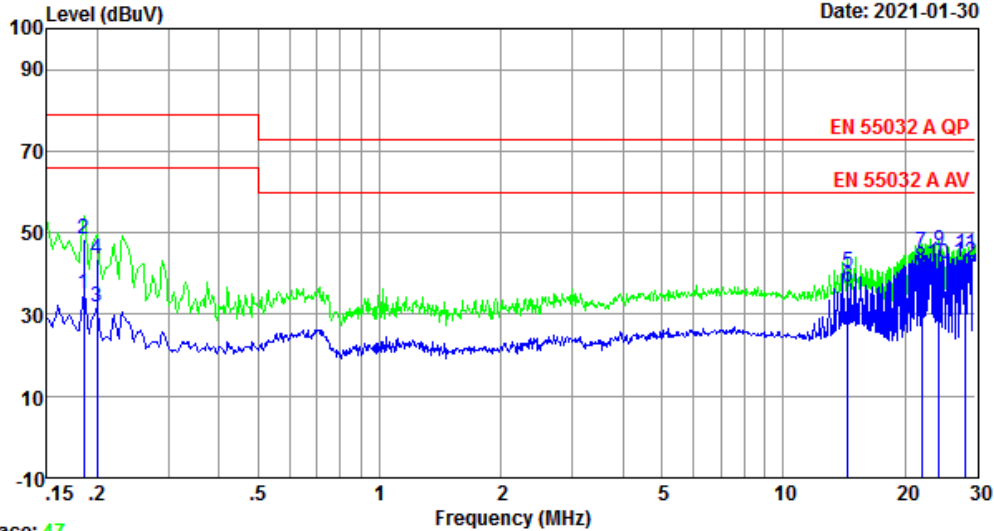
	Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.15	9.62	9.69	17.08	36.39	66.00	29.61	Average
2	0.15	9.62	9.69	31.17	50.48	79.00	28.52	QP
3	0.17	9.62	9.69	16.15	35.46	66.00	30.54	Average
4	0.17	9.62	9.69	29.57	48.88	79.00	30.12	QP
5	0.20	9.69	9.77	13.74	33.20	66.00	32.80	Average
6	0.20	9.69	9.77	25.28	44.74	79.00	34.26	QP
7	22.06	9.74	10.16	24.84	44.74	60.00	15.26	Average
8	22.06	9.74	10.16	22.80	42.70	73.00	30.30	QP
9	25.32	9.92	10.17	27.24	47.33	60.00	12.67	Average
10	25.32	9.92	10.17	24.29	44.38	73.00	28.62	QP
11	29.84	9.61	10.15	31.27	51.03	60.00	8.97	Average
12	29.84	9.61	10.15	29.85	49.61	73.00	23.39	QP

Remarks: 1. Emission Level= LISN Factor + Cable Loss + Reading.
 2. Margin= Limit - Emission Level.
 3. If the average limit is met when using a quasi-peak detector,
 the EUT shall be deemed to meet both limits and measurement
 with average detector is unnecessary.

Data: 48

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30

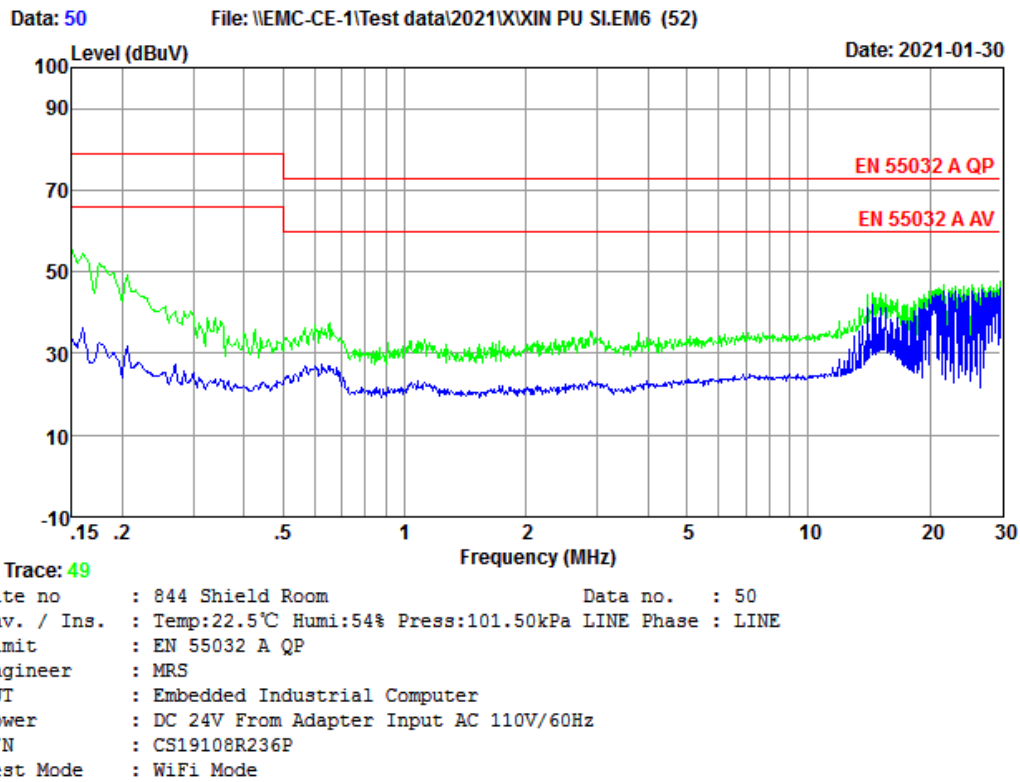


Trace: 47

Site no : 844 Shield Room Data no. : 48
 Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : LINE
 Limit : EN 55032 A QP
 Engineer : MRS
 EUT : Embedded Industrial Computer
 Power : DC 24V From Adapter Input AC 230V/50Hz
 M/N : CS19108R236P
 Test Mode : WiFi Mode

	Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.19	9.80	9.77	15.35	34.92	66.00	31.08	Average
2	0.19	9.80	9.77	28.69	48.26	79.00	30.74	QP
3	0.20	9.80	9.77	12.23	31.80	66.00	34.20	Average
4	0.20	9.80	9.77	23.96	43.53	79.00	35.47	QP
5	14.44	9.87	10.12	20.20	40.19	60.00	19.81	Average
6	14.44	9.87	10.12	16.71	36.70	73.00	36.30	QP
7	22.06	9.86	10.16	25.31	45.33	60.00	14.67	Average
8	22.06	9.86	10.16	21.62	41.64	73.00	31.36	QP
9	24.27	9.85	10.17	25.46	45.48	60.00	14.52	Average
10	24.27	9.85	10.17	22.28	42.30	73.00	30.70	QP
11	28.30	9.92	10.15	24.83	44.90	60.00	15.10	Average
12	28.30	9.92	10.15	22.52	42.59	73.00	30.41	QP

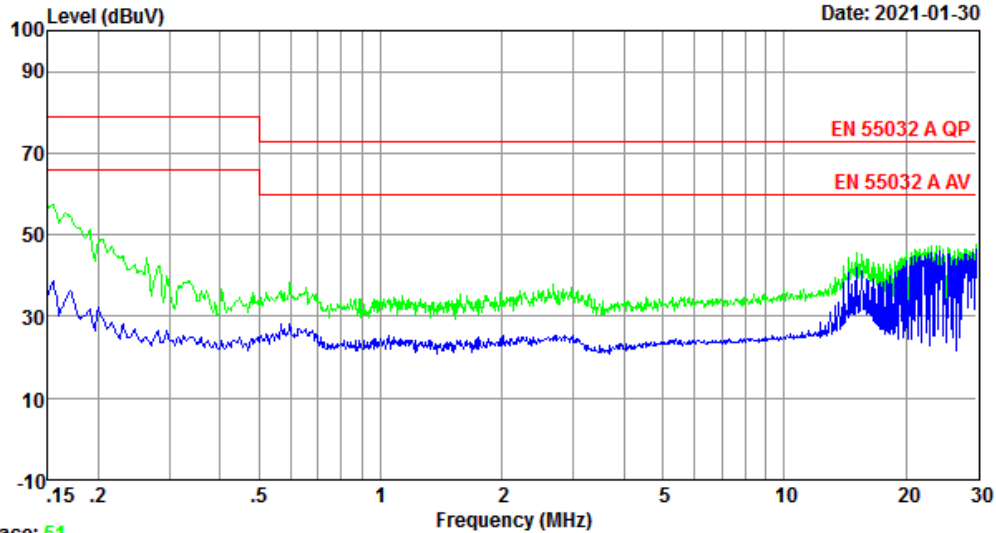
Remarks: 1. Emission Level= LISN Factor + Cable Loss + Reading.
 2. Margin= Limit - Emission Level.
 3. If the average limit is met when using a quasi-peak detector,
 the EUT shall be deemed to meet both limits and measurement
 with average detector is unnecessary.



Data: 52

File: \\EMC-CE-1\Test data\2021\X\XIN PU SLEM6 (52)

Date: 2021-01-30



Site no : 844 Shield Room Data no. : 52
Env. / Ins. : Temp:22.5°C Humi:54% Press:101.50kPa LINE Phase : NEUTRAL
Limit : EN 55032 A QP
Engineer : MRS
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : WiFi Mode

4.2. Asymmetric Mode Conducted Emissions Test

RESULT : Pass

Test procedure : EN 55032:2015+A11:2020

Frequency range : 0.15~30MHz

Test Site : Shielded Room

Limits : EN 55032:2015+A11:2020 Class A

Test Setup

Date of test : Jan. 29, 2021

Model No. : CS19108R236P

Input Voltage : DC 24V From Adapter Input AC 230V/50Hz

Operation Mode : LAN Mode

The frequency range from 150 kHz to 30 MHz was investigated.

The bandwidth of the test receiver was set at 9 kHz.

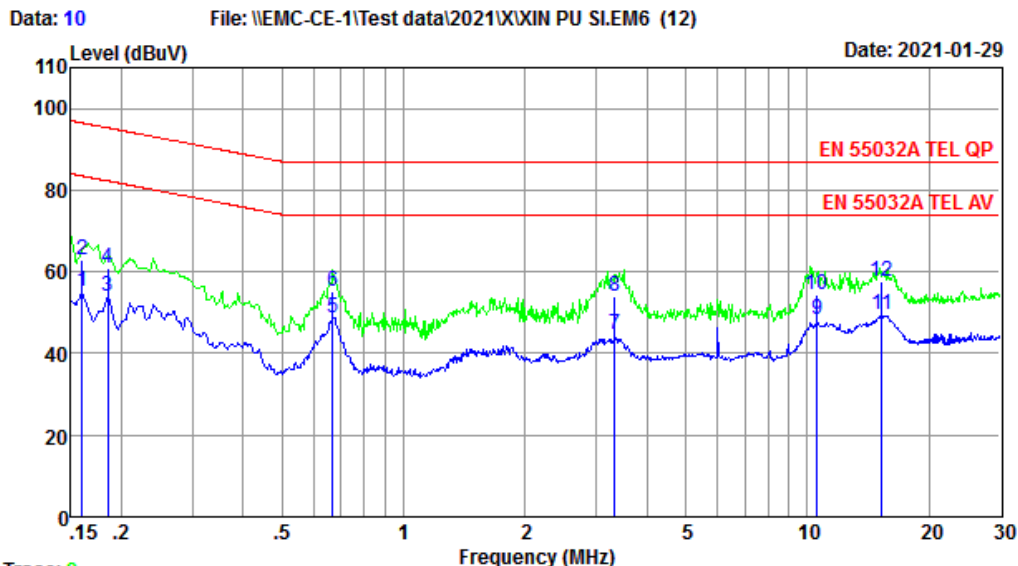
The test data of the worst case condition(s) was reported on the following page.

Note: Test uncertainty: $\pm 4.18\text{dB}$ at a level of confidence of 95%.

Test Data

EST Technology

Chilingxiang, Qishantou, Santun,
Houjie, Dongguan, Guangdong, China
Tel: +86-769-83081888
Fax: +86-769-83081878



Trace: 9
 Site no : 844 Shield Room Data no. : 10
 Env. / Ins. : Temp:24.6°C Humi:58% Press:101.50kPa LINE Phase :
 Limit : EN 55032A TEL QP
 Engineer : JACK
 EUT : Embedded Industrial Computer
 Power : DC 24V From Adapter Input AC 230V/50Hz
 M/N : CS19108R236P
 Test Mode : LAN Mode

	Freq. (MHz)	LISN Factor (dB)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV)	Limits (dBuV)	Margin (dB)	Remark
1	0.16	10.45	9.69	35.14	55.28	83.47	28.19	Average
2	0.16	10.45	9.69	42.98	63.12	96.47	33.35	QP
3	0.19	10.42	9.77	33.95	54.14	82.24	28.10	Average
4	0.19	10.42	9.77	40.72	60.91	95.24	34.33	QP
5	0.67	9.99	9.92	28.77	48.68	74.00	25.32	Average
6	0.67	9.99	9.92	35.26	55.17	87.00	31.83	QP
7	3.33	9.86	9.98	24.83	44.67	74.00	29.33	Average
8	3.33	9.86	9.98	34.29	54.13	87.00	32.87	QP
9	10.56	9.81	10.08	28.34	48.23	74.00	25.77	Average
10	10.56	9.81	10.08	34.62	54.51	87.00	32.49	QP
11	15.31	9.81	10.12	29.48	49.41	74.00	24.59	Average
12	15.31	9.81	10.12	37.71	57.64	87.00	29.36	QP

Remarks: 1. Emission Level= LISN Factor + Cable Loss + Reading.
 2. Margin= Limit - Emission Level.
 3. If the average limit is met when using a quasi-peak detector,
 the EUT shall be deemed to meet both limits and measurement
 with average detector is unnecessary.

4.3. Radiated Emission Test

RESULT : **Pass**
Test procedure : EN 55032:2015+A11:2020
Frequency range : 30~1000MHz
Test Site : 2#966 Chamber
Limits : EN 55032:2015+A11:2020 Class A

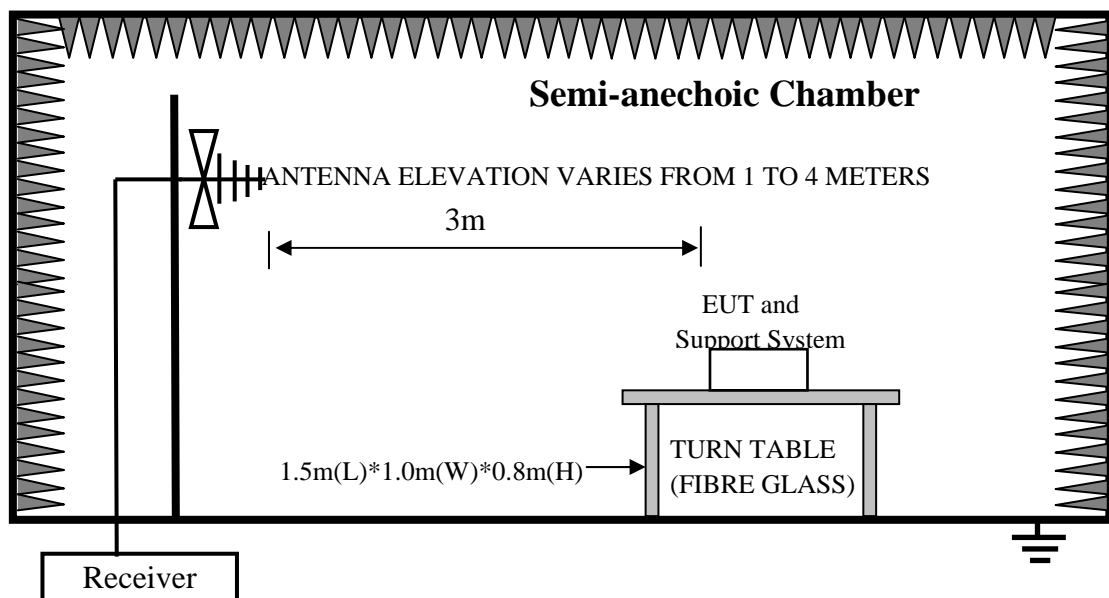
Test Setup

Date of test : Jan. 26, 2021
Model No. : CS19108R236P
Input Voltage : DC 24V From Adapter Input AC 230V/50Hz,
DC 24V From Adapter Input AC 110V/60Hz
Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode, Type-C Mode

The EUT was placed on a turn table which was 0.8 m above the ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT was set 3 m away from the receiving antenna which was mounted on an antenna tower. The measuring antenna moved up and down to find out the maximum emission level. It moved from 1 m to 4 m for both horizontal and vertical polarizations.

The EUT was tested in the Chamber Site. It was pre-scanned with a Peak detector from the spectrum, and all the final readings from the test receiver were measured with the Quasi-Peak detector.

The bandwidth setting on the test receiver was 120 kHz.



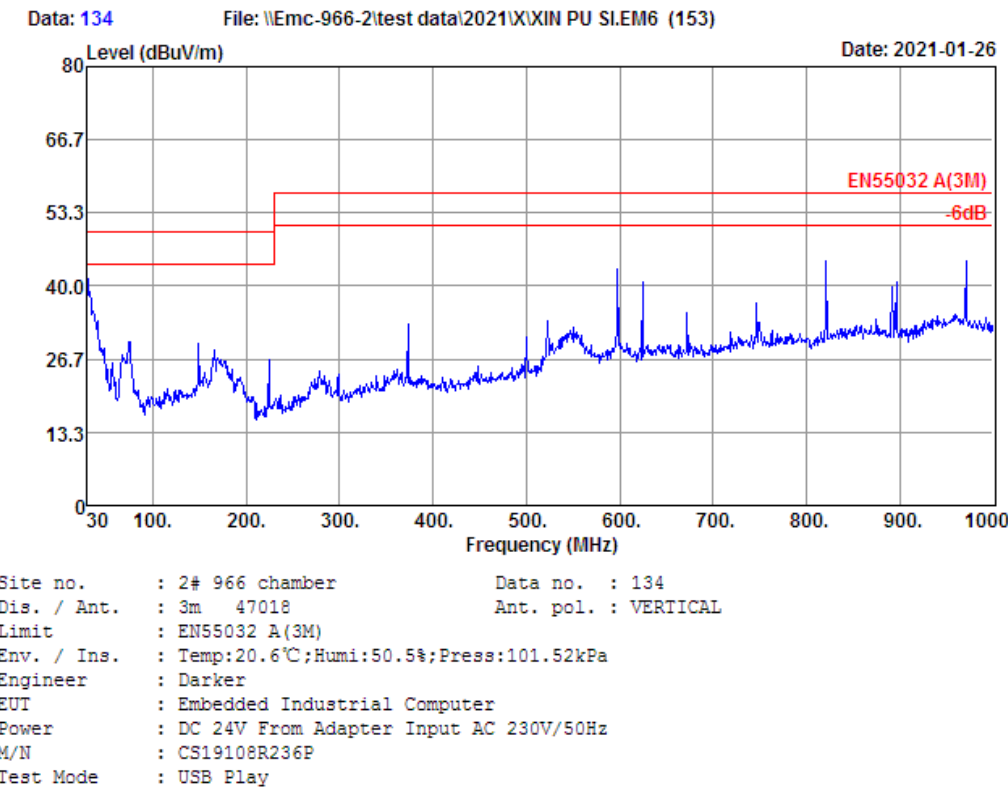
Note:

Test uncertainty: ± 4.26 dB (H); ± 4.74 dB (V) at a level of confidence of 95%. (2#966)

Test Data

EST Technology

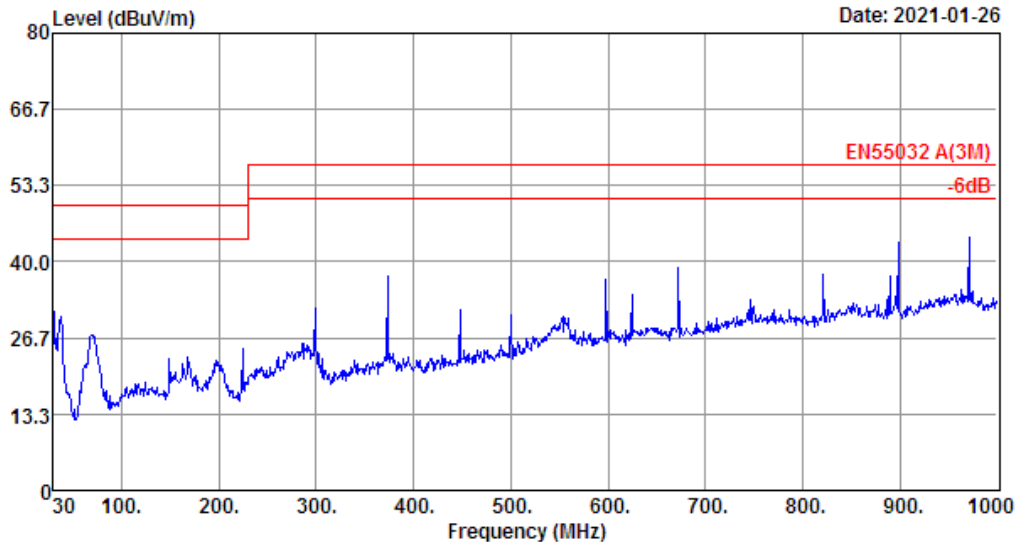
Chilingxiang, Qishantou, Santun,
Houjie, Dongguan, Guangdong, China
Tel: +86-769-83081888
Fax: +86-769-83081878



Data: 135

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

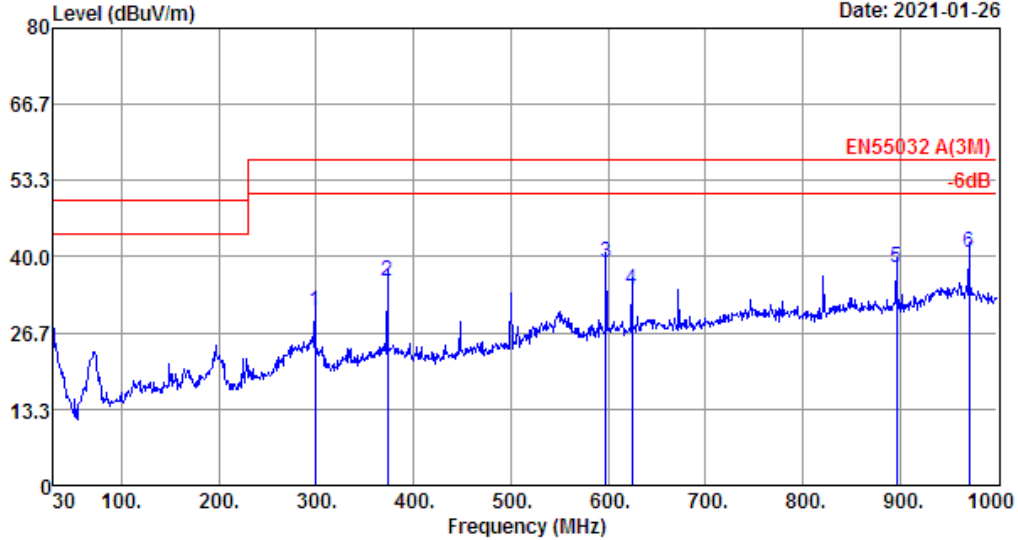


Site no.	: 2# 966 chamber	Data no.	: 135
Dis. / Ant.	: 3m 47018	Ant. pol.	: HORIZONTAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6℃;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 230V/50Hz		
M/N	: CS19108R236P		
Test Mode	: USB Play		

Data: 136

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26



Site no. : 2# 966 chamber Data no. : 136
 Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL
 Limit : EN55032 A(3M)
 Env. / Ins. : Temp:20.6°C;Humi:50.5%;Press:101.52kPa
 Engineer : Darker
 EUT : Embedded Industrial Computer
 Power : DC 24V From Adapter Input AC 230V/50Hz
 M/N : CS19108R236P
 Test Mode : WI-FI Mode

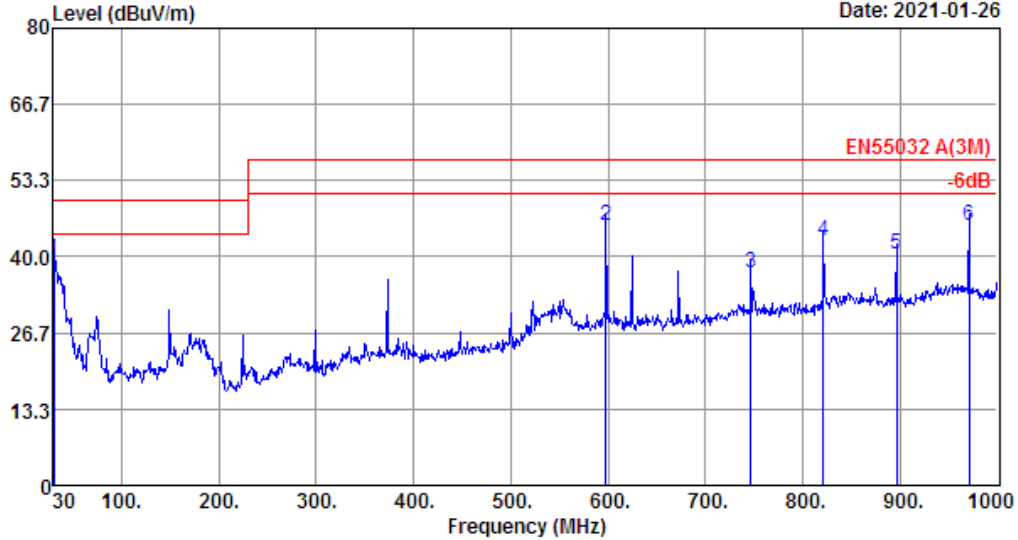
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	298.69	12.91	1.61	15.92	30.44	57.00	26.56	QP
2	373.38	14.99	1.86	18.85	35.70	57.00	21.30	QP
3	597.45	19.77	2.52	16.59	38.88	57.00	18.12	QP
4	624.61	19.71	2.64	11.99	34.34	57.00	22.66	QP
5	896.21	23.04	3.30	11.61	37.95	57.00	19.05	QP
6	970.90	25.05	3.95	11.62	40.62	57.00	16.38	QP

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.
 2. Margin= Limit - Emission Level.
 3. The emission levels that are 20dB below the official limit are not reported.

Data: 137

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26



Site no. : 2# 966 chamber Data no. : 137
 Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL
 Limit : EN55032 A(3M)
 Env. / Ins. : Temp:20.6°C;Humi:50.5%;Press:101.52kPa
 Engineer : Darker
 EUT : Embedded Industrial Computer
 Power : DC 24V From Adapter Input AC 230V/50Hz
 M/N : CS19108R236P
 Test Mode : WI-FI Mode

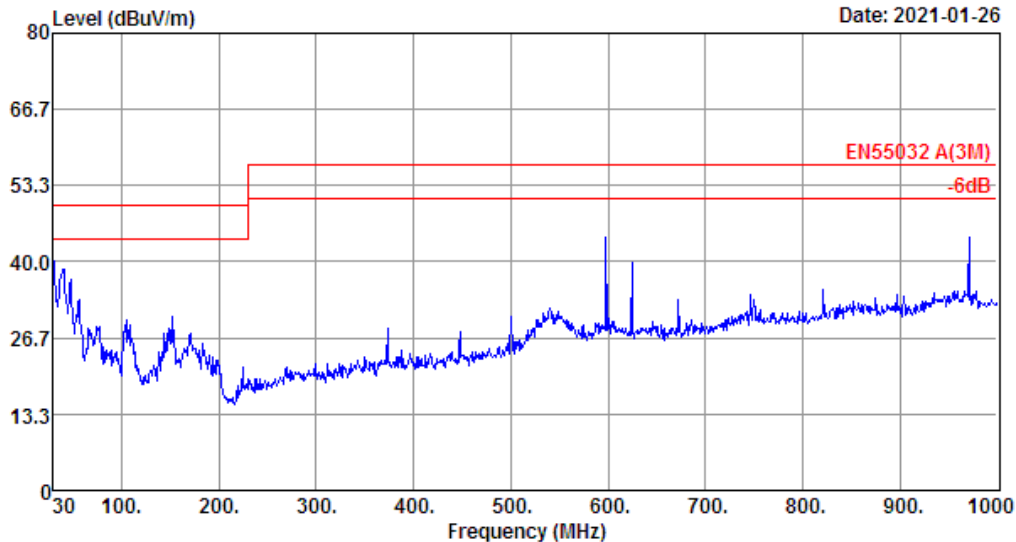
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	30.00	18.22	0.19	21.05	39.46	50.00	10.54	QP
2	597.45	19.77	2.52	23.10	45.39	57.00	11.61	QP
3	746.83	22.26	3.07	11.86	37.19	57.00	19.81	QP
4	821.52	22.14	3.15	17.38	42.67	57.00	14.33	QP
5	896.21	23.04	3.30	13.99	40.33	57.00	16.67	QP
6	970.90	25.05	3.95	16.48	45.48	57.00	11.52	QP

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.
 2. Margin= Limit - Emission Level.
 3. The emission levels that are 20dB below the official limit are not reported.

Data: 138

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

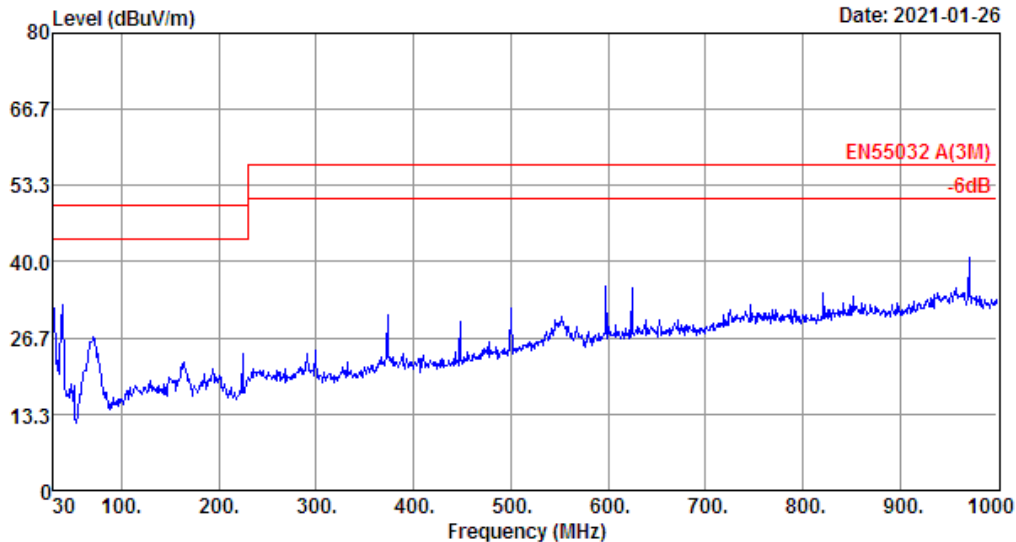


Site no. : 2# 966 chamber Data no. : 138
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6℃;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 139

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

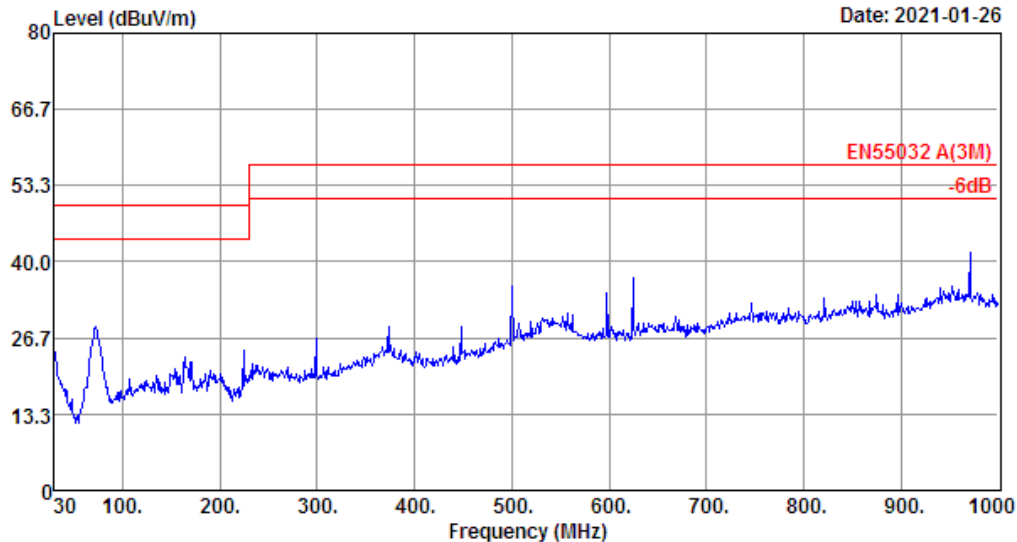


Site no. : 2# 966 chamber Data no. : 139
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6°C;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 140

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

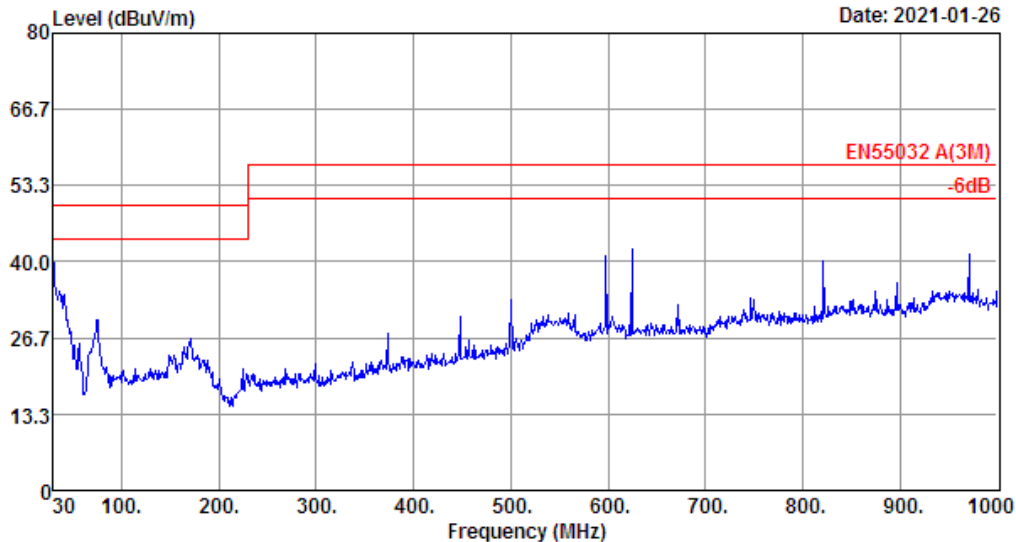


Site no. : 2# 966 chamber Data no. : 140
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6°C;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 141

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

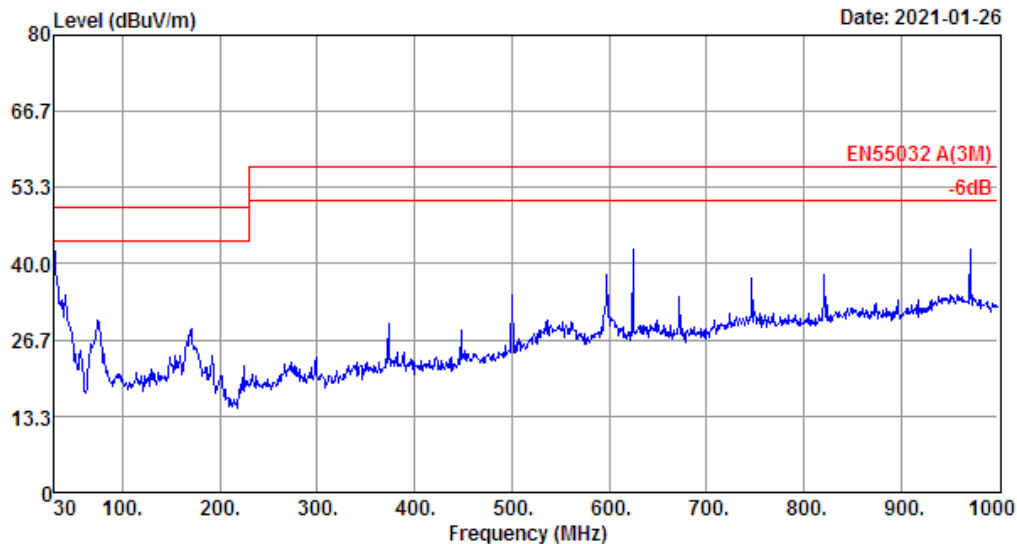


Site no.	: 2# 966 chamber	Data no.	: 141
Dis. / Ant.	: 3m 47018	Ant. pol.	: VERTICAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6℃;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 230V/50Hz		
M/N	: CS19108R236P		
Test Mode	: Type-C Play		

Data: 142

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

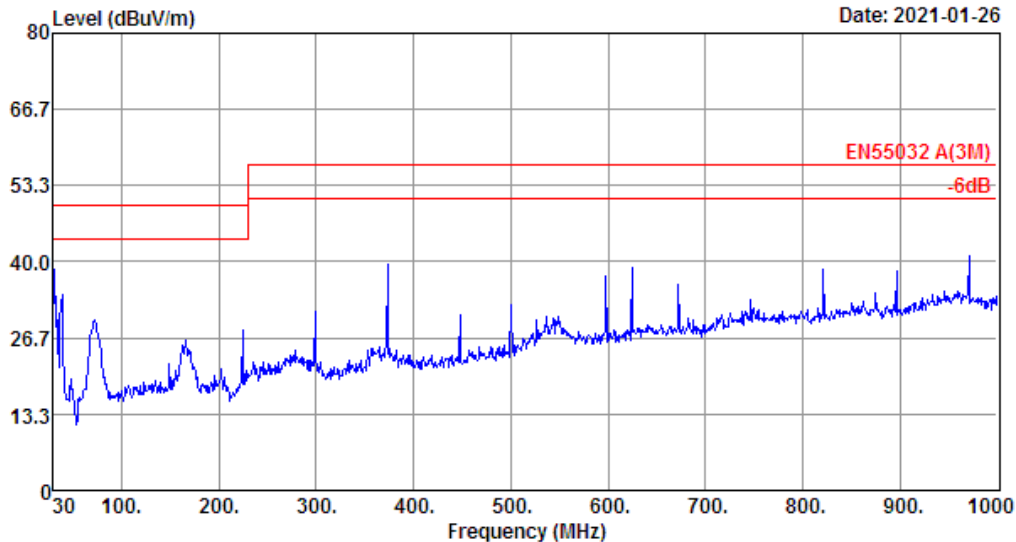


Site no. : 2# 966 chamber Data no. : 142
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6℃;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode

Data: 143

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

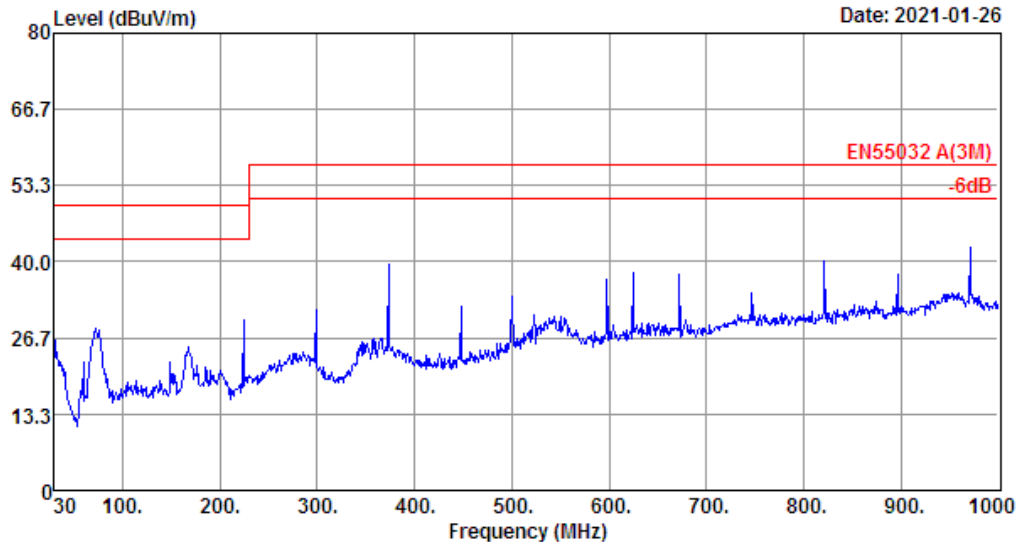


Site no. : 2# 966 chamber Data no. : 143
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6°C;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode

Data: 144

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

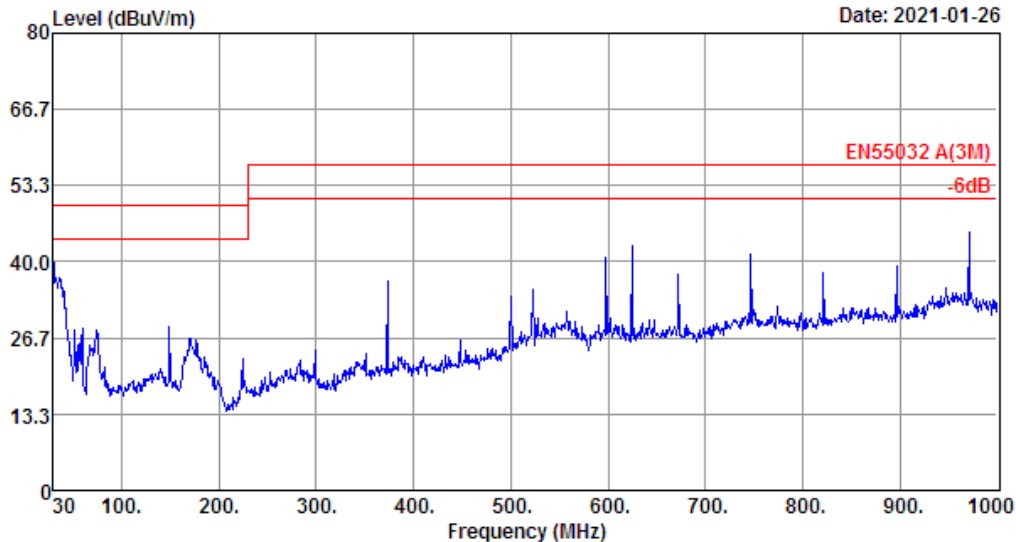


Site no.	: 2# 966 chamber	Data no.	: 144
Dis. / Ant.	: 3m 47018	Ant. pol.	: HORIZONTAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6℃;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 110V/60Hz		
M/N	: CS19108R236P		
Test Mode	: Bluetooth Mode		

Data: 145

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

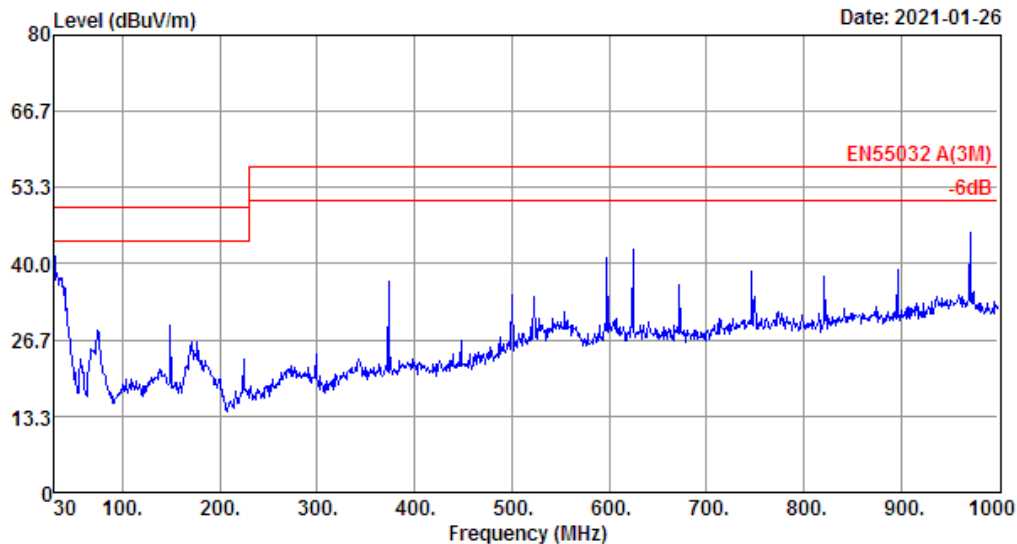


Site no. : 2# 966 chamber Data no. : 145
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6°C;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode

Data: 146

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

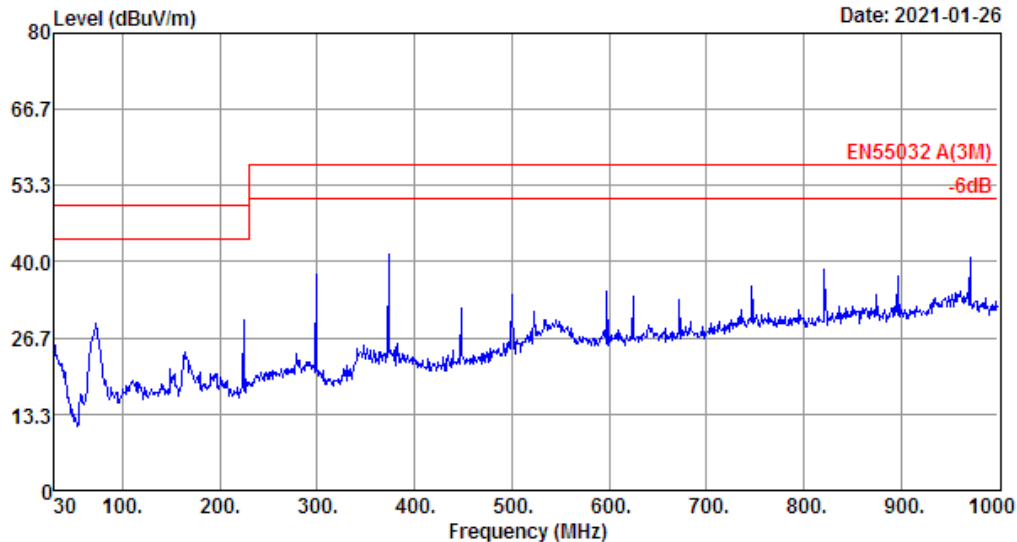


Site no. : 2# 966 chamber Data no. : 146
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6℃;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : WI-FI Mode

Data: 147

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

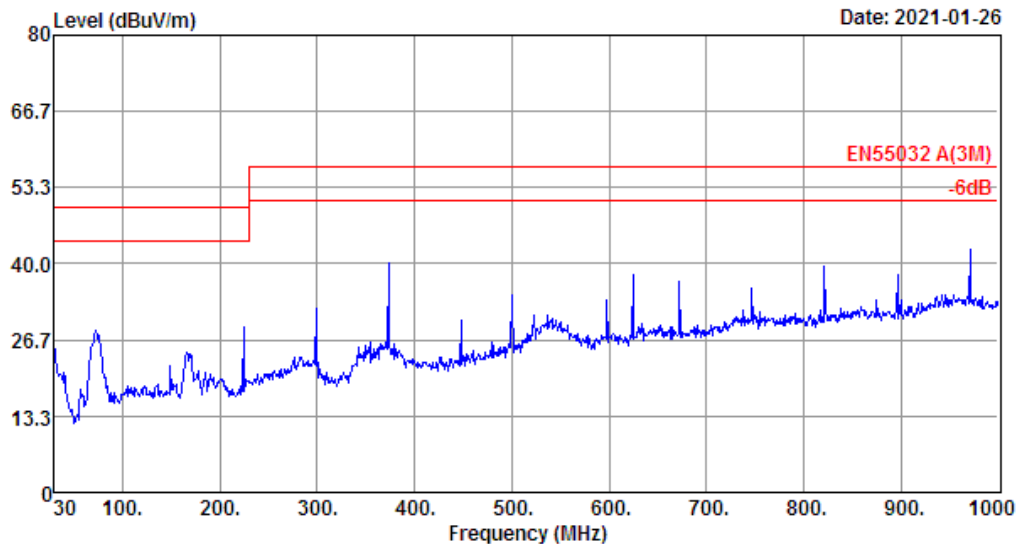


Site no. : 2# 966 chamber Data no. : 147
Dis. / Ant. : 3m 47018 Ant. pol. : HORIZONTAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6℃;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : WI-FI Mode

Data: 148

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

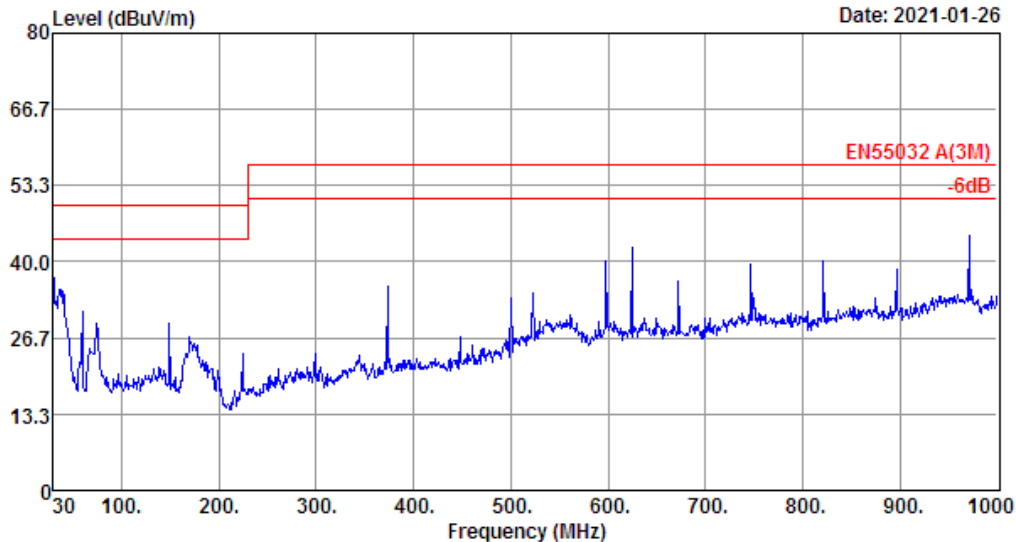


Site no.	: 2# 966 chamber	Data no.	: 148
Dis. / Ant.	: 3m 47018	Ant. pol.	: HORIZONTAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6℃;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 110V/60Hz		
M/N	: CS19108R236P		
Test Mode	: LAN Mode		

Data: 149

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

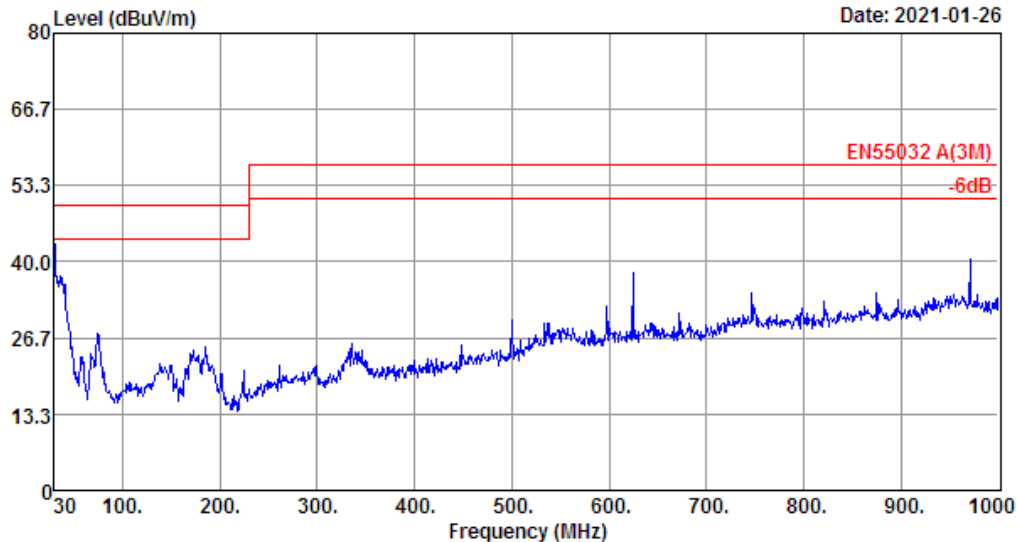


Site no.	: 2# 966 chamber	Data no.	: 149
Dis. / Ant.	: 3m 47018	Ant. pol.	: VERTICAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6℃;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 110V/60Hz		
M/N	: CS19108R236P		
Test Mode	: LAN Mode		

Data: 150

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

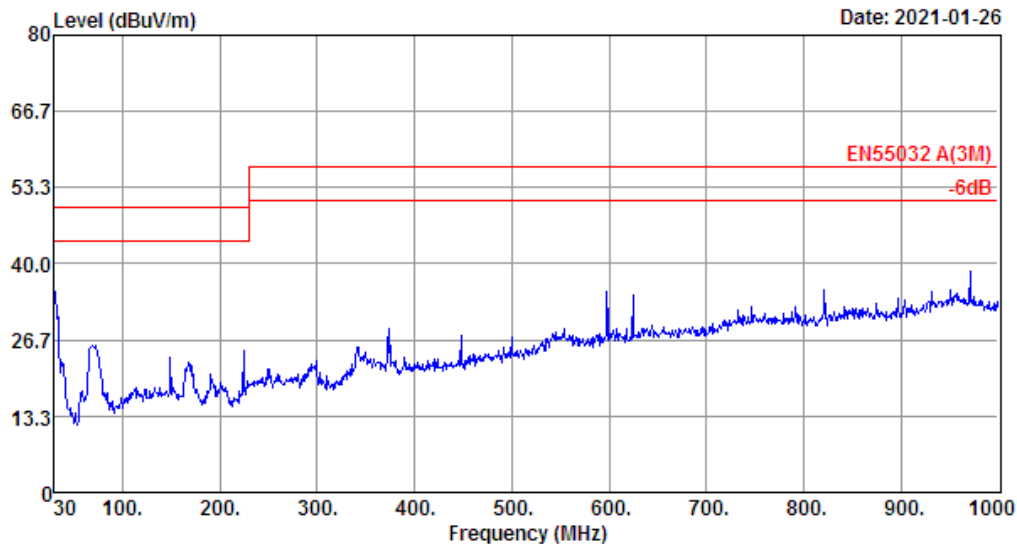


Site no.	: 2# 966 chamber	Data no.	: 150
Dis. / Ant.	: 3m 47018	Ant. pol.	: VERTICAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6℃;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 110V/60Hz		
M/N	: CS19108R236P		
Test Mode	: Type-C Play		

Data: 151

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

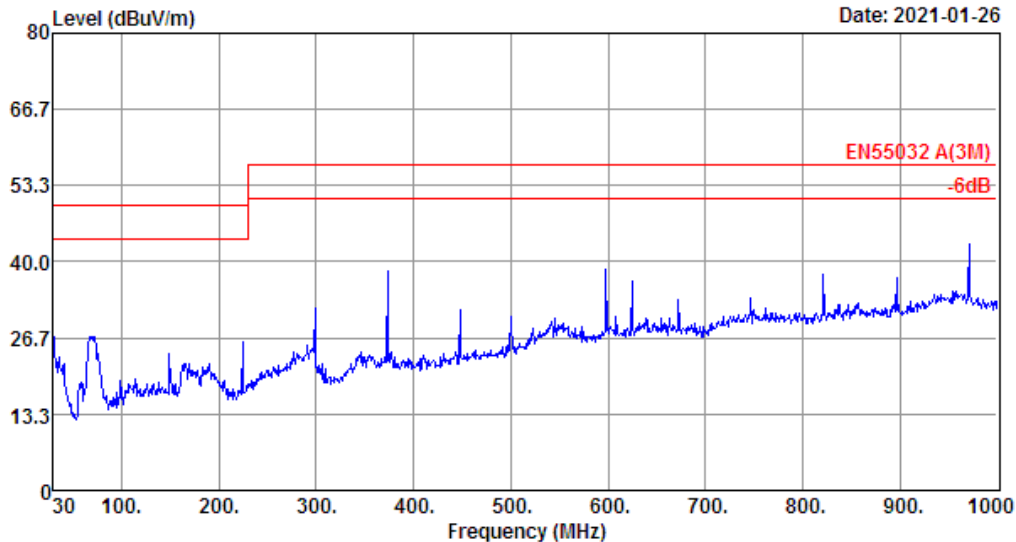


Site no.	: 2# 966 chamber	Data no.	: 151
Dis. / Ant.	: 3m 47018	Ant. pol.	: HORIZONTAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6℃;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 110V/60Hz		
M/N	: CS19108R236P		
Test Mode	: Type-C Play		

Data: 152

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SLEM6 (153)

Date: 2021-01-26

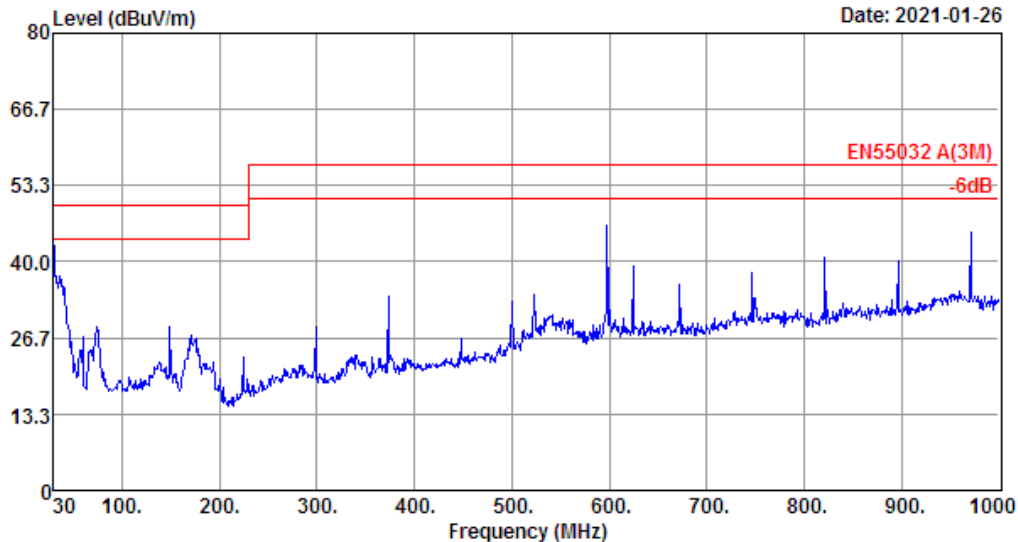


Site no.	: 2# 966 chamber	Data no.	: 152
Dis. / Ant.	: 3m 47018	Ant. pol.	: HORIZONTAL
Limit	: EN55032 A(3M)		
Env. / Ins.	: Temp:20.6°C;Humi:50.5%;Press:101.52kPa		
Engineer	: Darker		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 110V/60Hz		
M/N	: CS19108R236P		
Test Mode	: USB Play		

Data: 153

File: \\Emc-966-2\\test data\\2021\\X\\XIN PU SI.EM6 (153)

Date: 2021-01-26



Site no. : 2# 966 chamber Data no. : 153
Dis. / Ant. : 3m 47018 Ant. pol. : VERTICAL
Limit : EN55032 A(3M)
Env. / Ins. : Temp:20.6℃;Humi:50.5%;Press:101.52kPa
Engineer : Darker
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : USB Play

4.4. Radiated Emission Test (above 1GHz)

RESULT : **Pass**
Test procedure : EN 55032:2015+A11:2020
Frequency range : 1GHz-6GHz
Test Site : 966 Chamber
Limits : EN 55032:2015+A11:2020 Class A

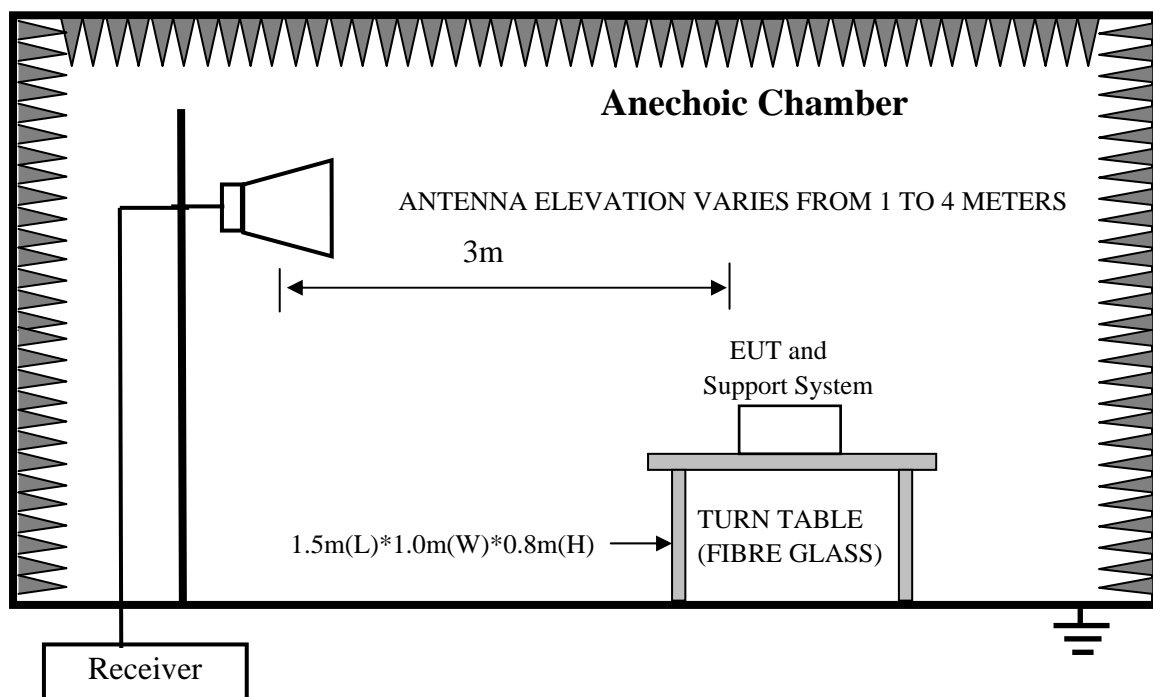
Test Setup

Date of test : Jan. 27, 2021
Model No. : CS19108R236P
Input Voltage : DC 24V From Adapter Input AC 230V/50Hz,
DC 24V From Adapter Input AC 110V/60Hz
Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode,
Type-C Mode

The EUT was placed on a turn table which was 0.8 m above the ground. The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT was set 3 m away from the receiving antenna which was mounted on an antenna tower. The measuring antenna moved up and down to find out the maximum emission level. It moved from 1 m to 4 m for both horizontal and vertical polarizations.

The EUT was tested in the Chamber Site. It was pre-scanned with a Peak detector and Average detector from the spectrum, and all the final readings from the test receiver were measured with the Peak detector and Average detector.

The bandwidth setting on the test receiver was 1MHz(above 1GHz).

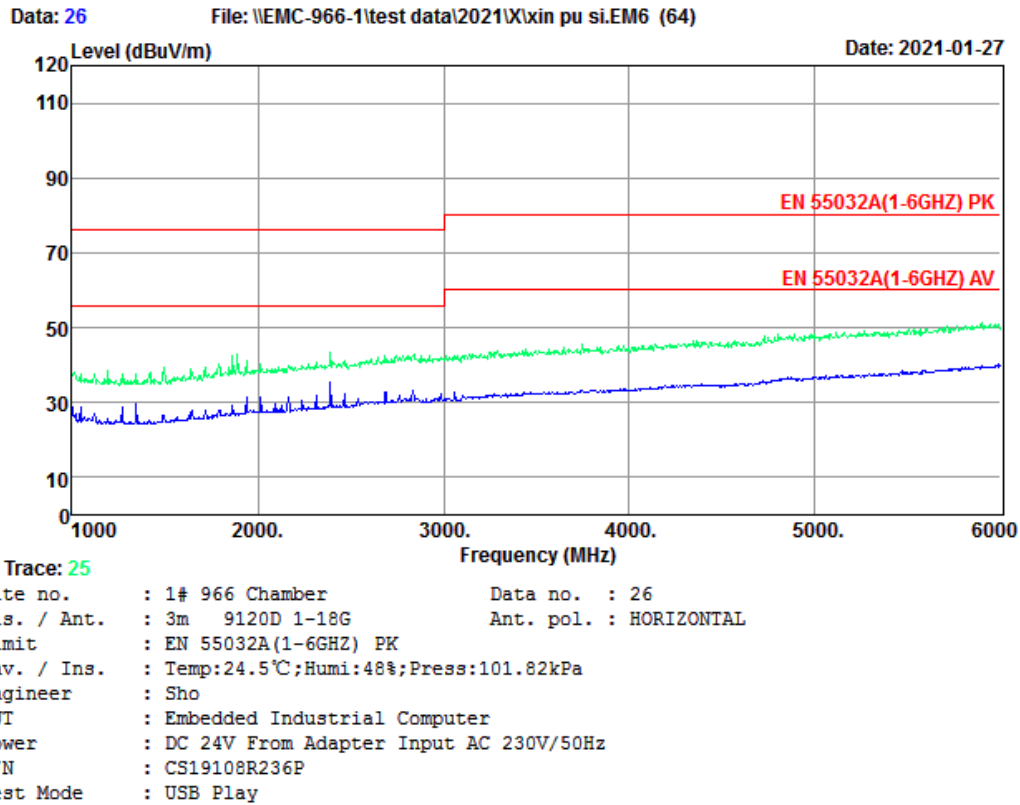


Note: Test uncertainty: $\pm 4.72\text{dB}$ at a level of confidence of 95%.

Test Data

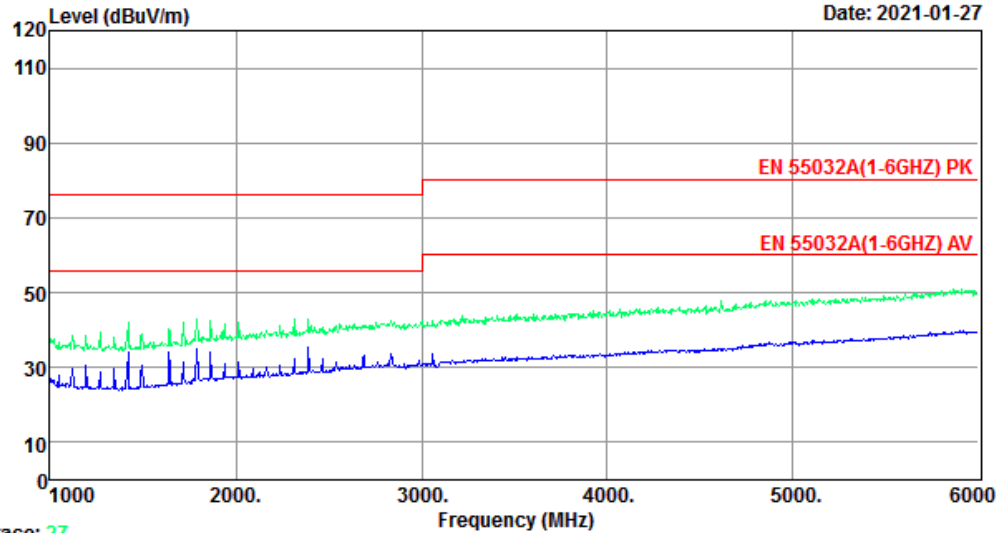
EST Technology

Chilingxiang, Qishantou, Santun,
Houjie, Dongguan, Guangdong, China
Tel: +86-769-83081888
Fax: +86-769-83081878



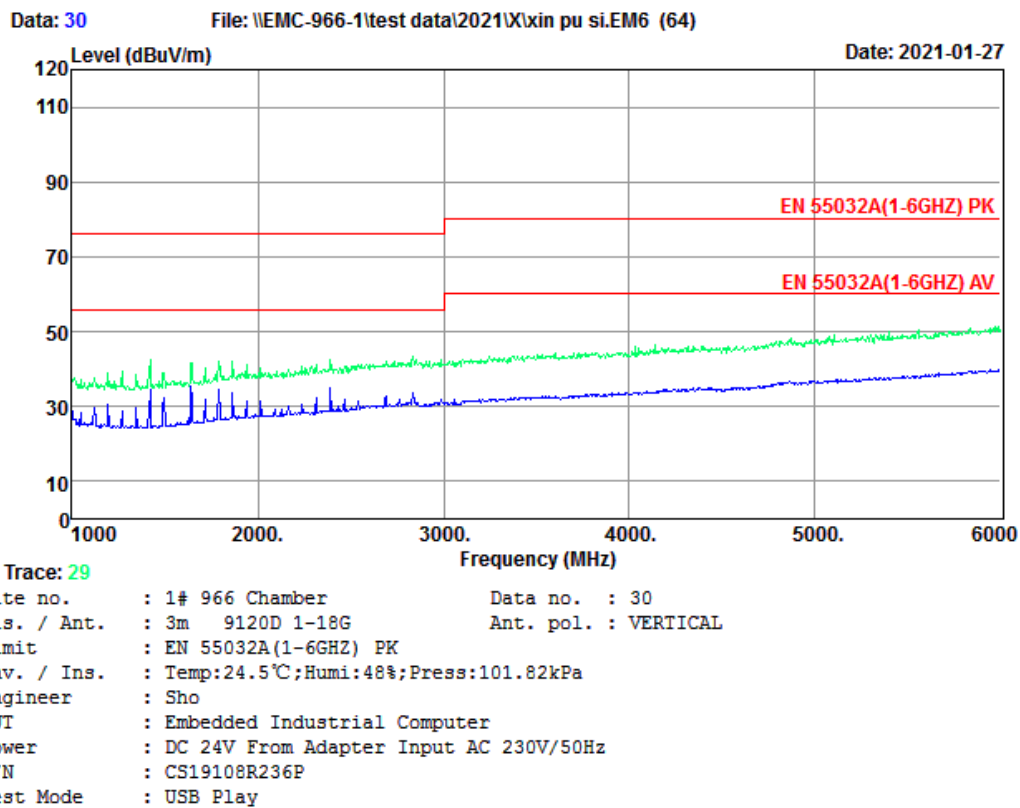
Data: 28 File: \\EMC-966-1\test data\2021\X\xin pu si.EM6 (64)

Date: 2021-01-27



Trace: 27

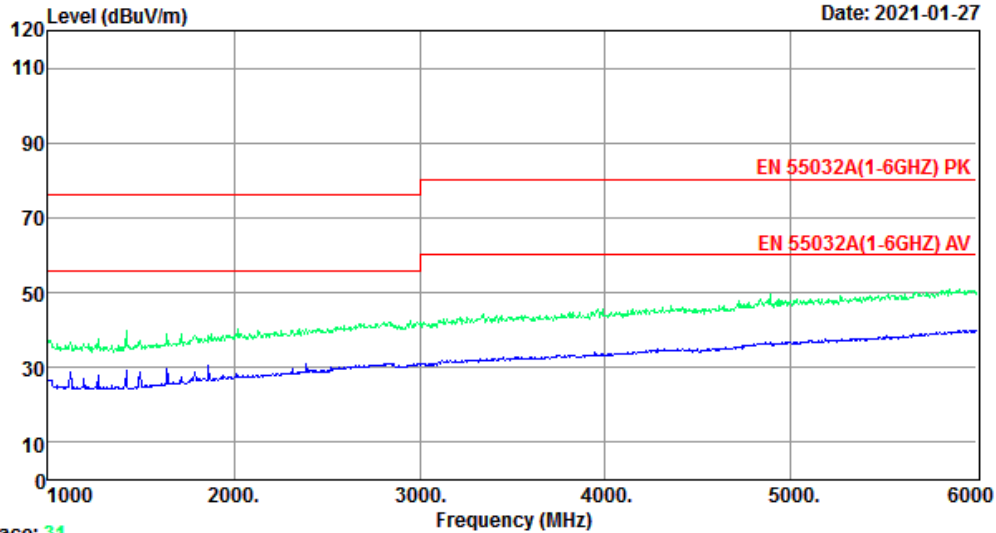
Site no.	: 1# 966 Chamber	Data no.	: 28
Dis. / Ant.	: 3m 9120D 1-18G	Ant. pol.	: VERTICAL
Limit	: EN 55032A(1-6GHZ) PK		
Env. / Ins.	: Temp:24.5°C;Humi:48%;Press:101.82kPa		
Engineer	: Sho		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 230V/50Hz		
M/N	: CS19108R236P		
Test Mode	: USB Play		



Data: 32

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



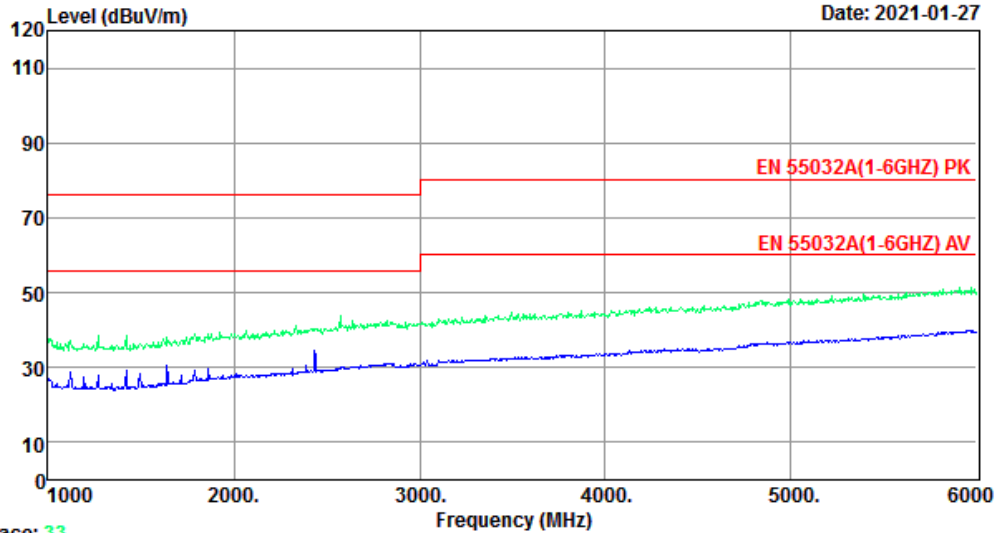
Trace: 31

Site no. : 1# 966 Chamber Data no. : 32
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : USB Play

Data: 34

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27

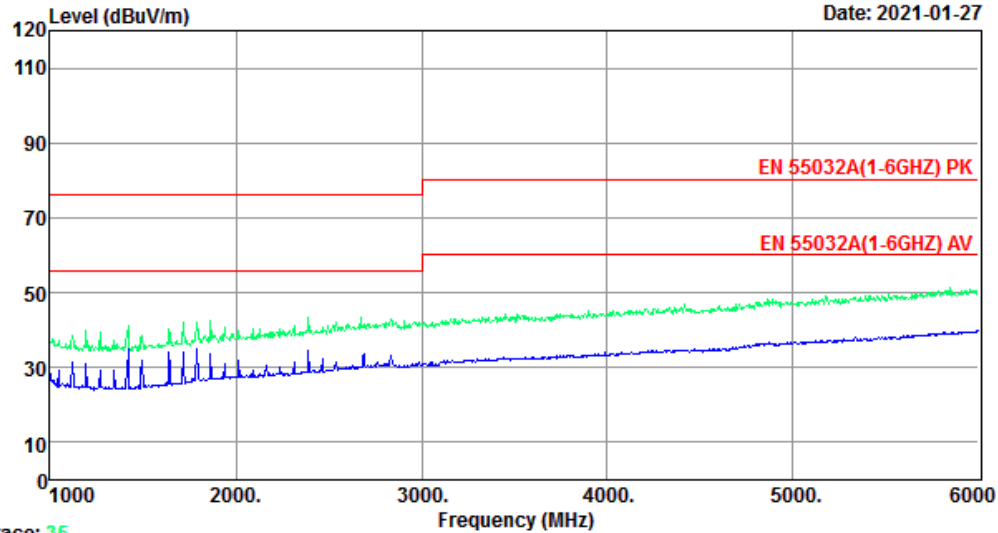


Trace: 33

Site no. : 1# 966 Chamber Data no. : 34
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 36 File: \\EMC-966-1\test data\2021\X\xin pu si.EM6 (64)

Date: 2021-01-27



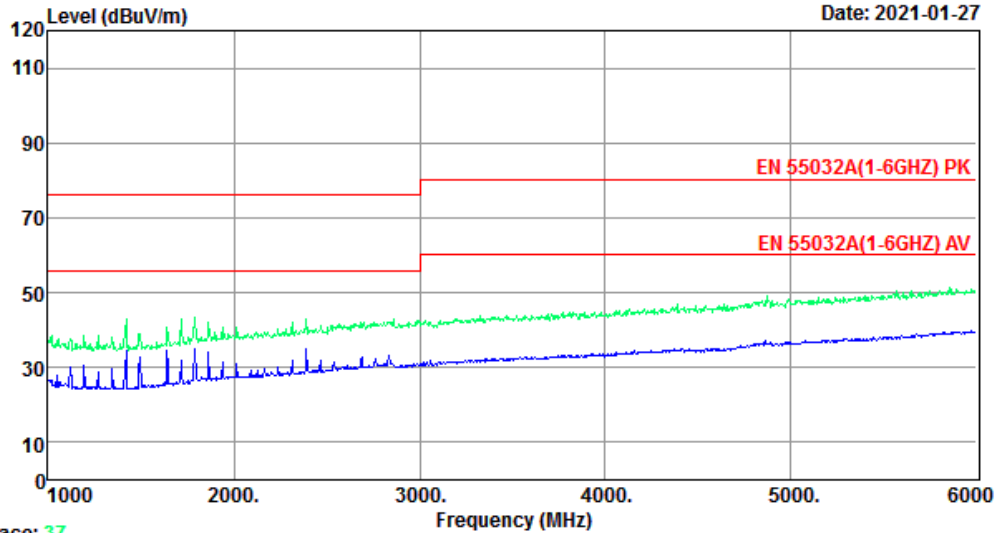
Trace: 35

Site no.	: 1# 966 Chamber	Data no.	: 36
Dis. / Ant.	: 3m 9120D 1-18G	Ant. pol.	: VERTICAL
Limit	: EN 55032A(1-6GHZ) PK		
Env. / Ins.	: Temp:24.5°C;Humi:48%;Press:101.82kPa		
Engineer	: Sho		
EUT	: Embedded Industrial Computer		
Power	: DC 24V From Adapter Input AC 230V/50Hz		
M/N	: CS19108R236P		
Test Mode	: Type-C Play		

Data: 38

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



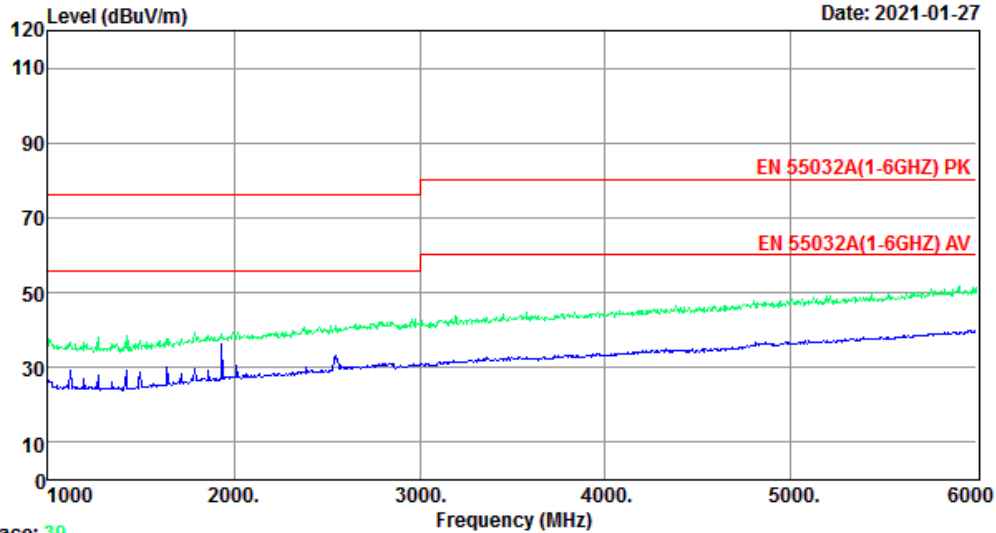
Trace: 37

Site no. : 1# 966 Chamber Data no. : 38
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 40

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27

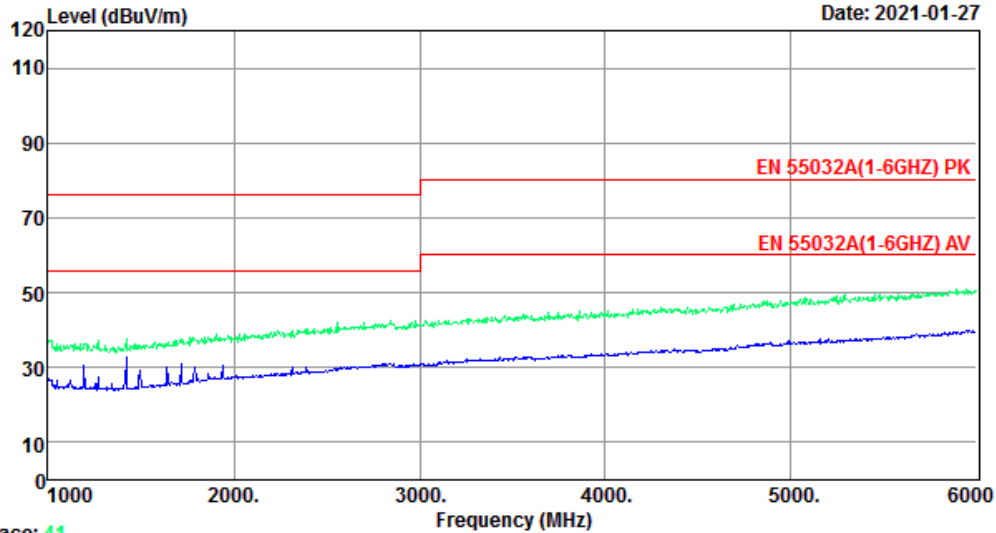


Site no. : 1# 966 Chamber Data no. : 40
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Type-C Play

Data: 42

File: \\EMC-966-1\test data\2021\X\xin pu si.EM6 (64)

Date: 2021-01-27



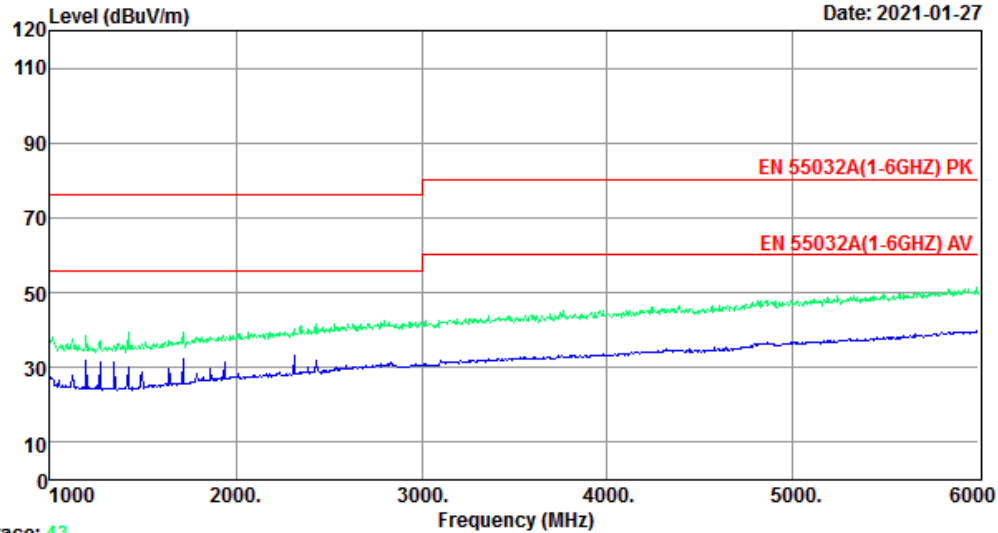
Trace: 41

Site no. : 1# 966 Chamber Data no. : 42
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 44

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



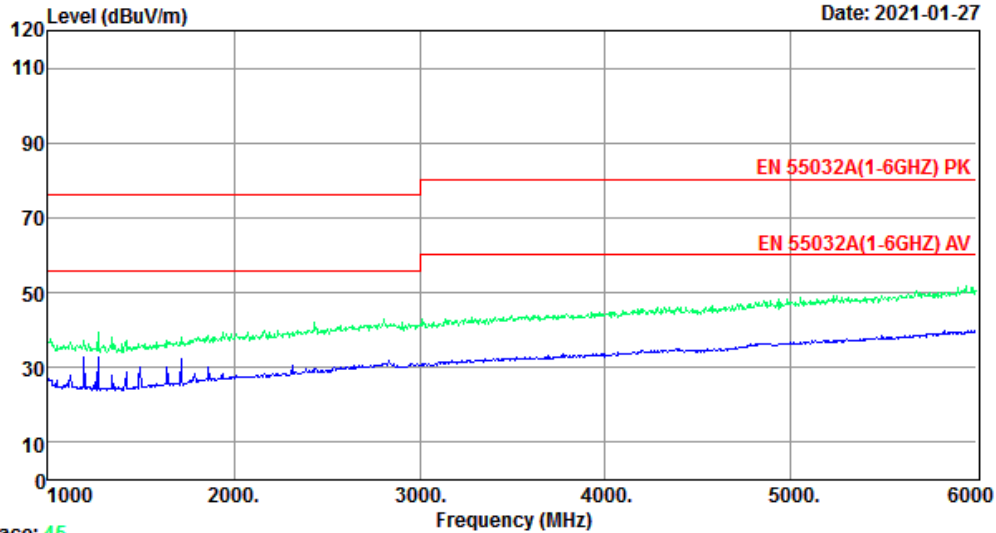
Trace: 43

Site no. : 1# 966 Chamber Data no. : 44
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 46

File: \\EMC-966-1\test data\2021\X\xin pu si.EM6 (64)

Date: 2021-01-27



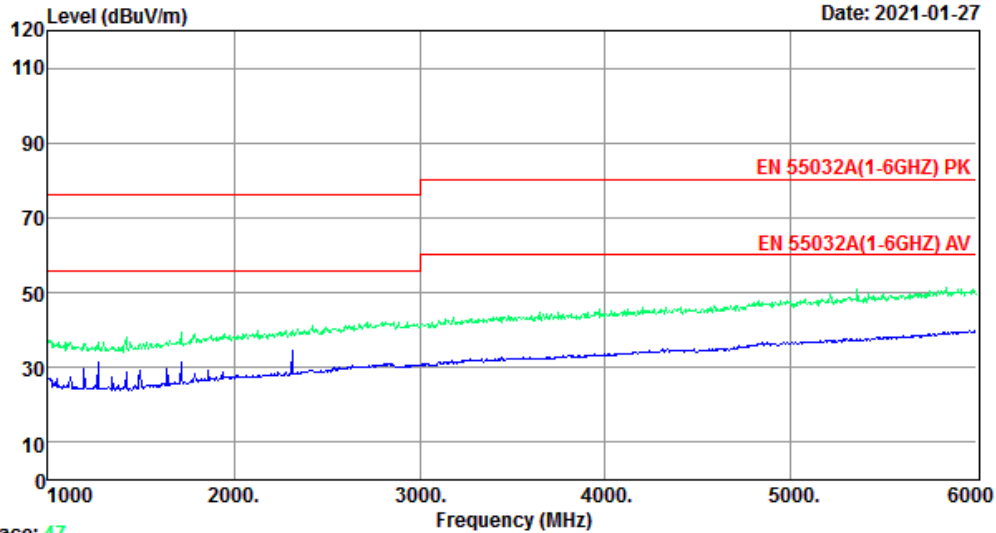
Trace: 45

Site no. : 1# 966 Chamber Data no. : 46
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 48

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



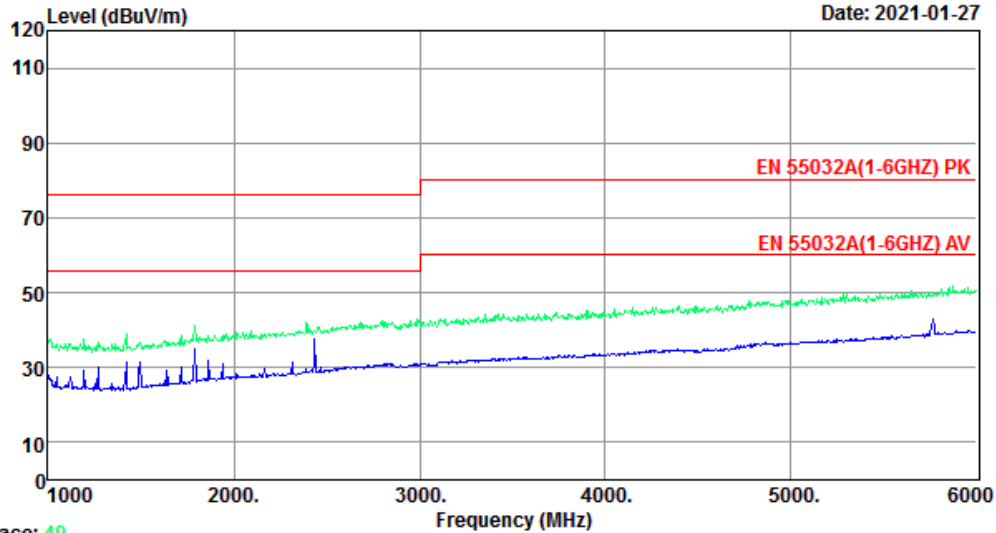
Trace: 47

Site no. : 1# 966 Chamber Data no. : 48
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : LAN Mode

Data: 50

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



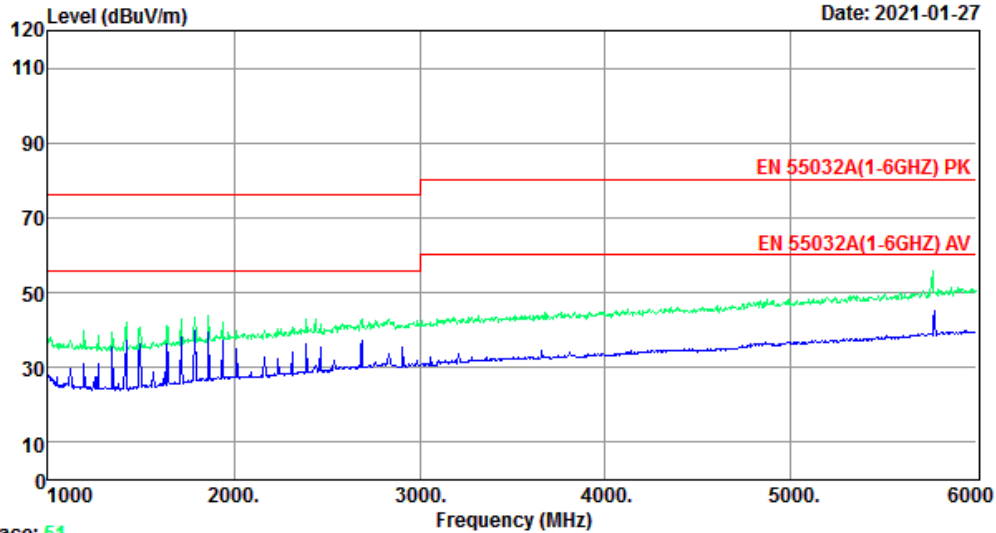
Trace: 49

Site no. : 1# 966 Chamber Data no. : 50
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode

Data: 52

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



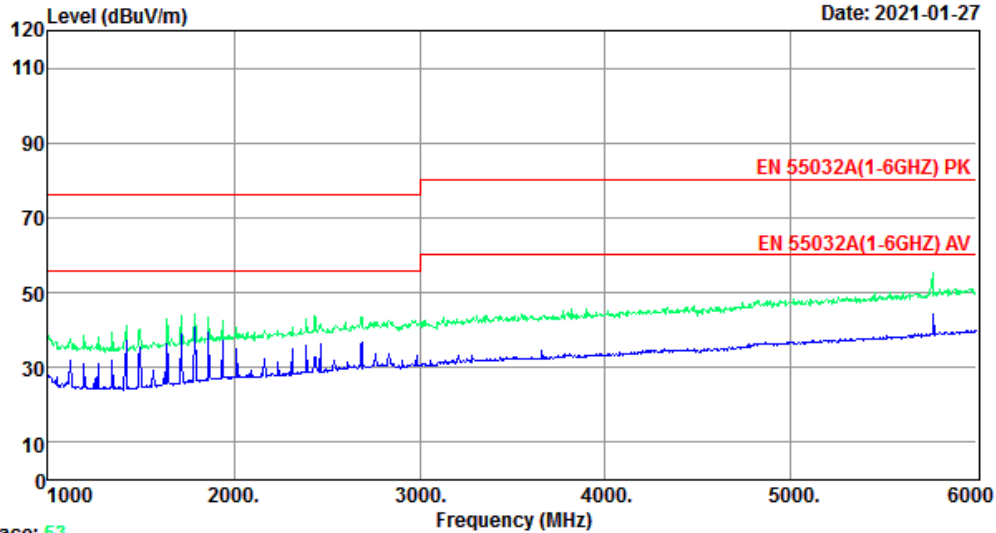
Trace: 51

Site no. : 1# 966 Chamber Data no. : 52
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode

Data: 54

File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



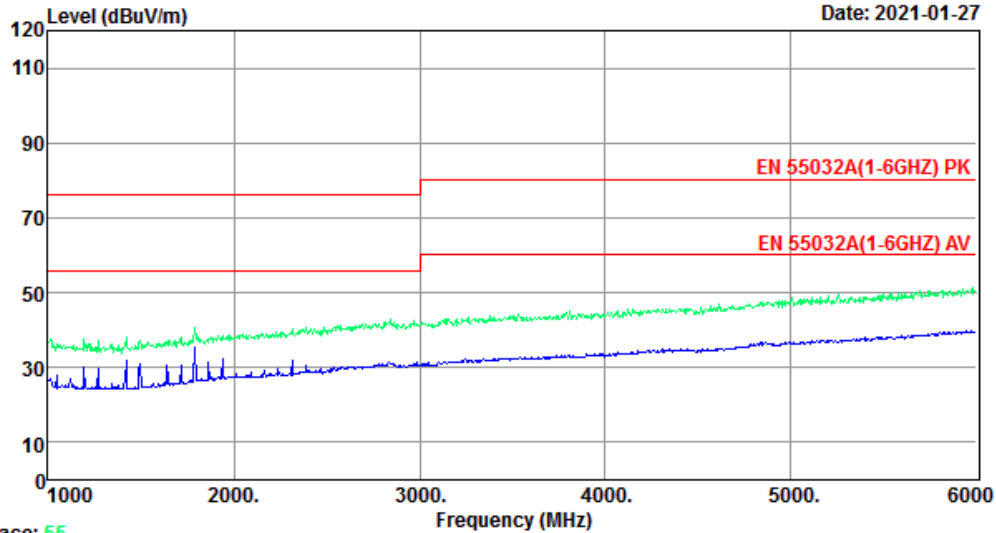
Trace: 53

Site no. : 1# 966 Chamber Data no. : 54
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode

Data: 56

File: \\EMC-966-1\test data\2021\X\xin pu si.EM6 (64)

Date: 2021-01-27



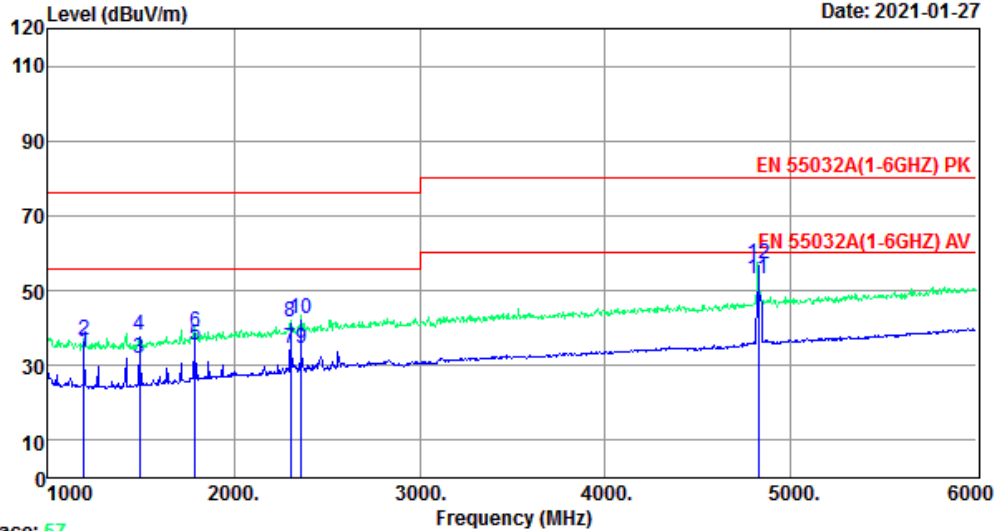
Trace: 55

Site no. : 1# 966 Chamber Data no. : 56
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 230V/50Hz
M/N : CS19108R236P
Test Mode : Bluetooth Mode

Data: 58

File: \\EMC-966-1\test data\2021\X\in pu si.EM6 (64)

Date: 2021-01-27



Trace: 57

Site no. : 1# 966 Chamber Data no. : 58
 Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
 Limit : EN 55032A(1-6GHZ) PK
 Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
 Engineer : Sho
 EUT : Embedded Industrial Computer
 Power : DC 24V From Adapter Input AC 230V/50Hz
 M/N : CS19108R236P
 Test Mode : Wifi Mode

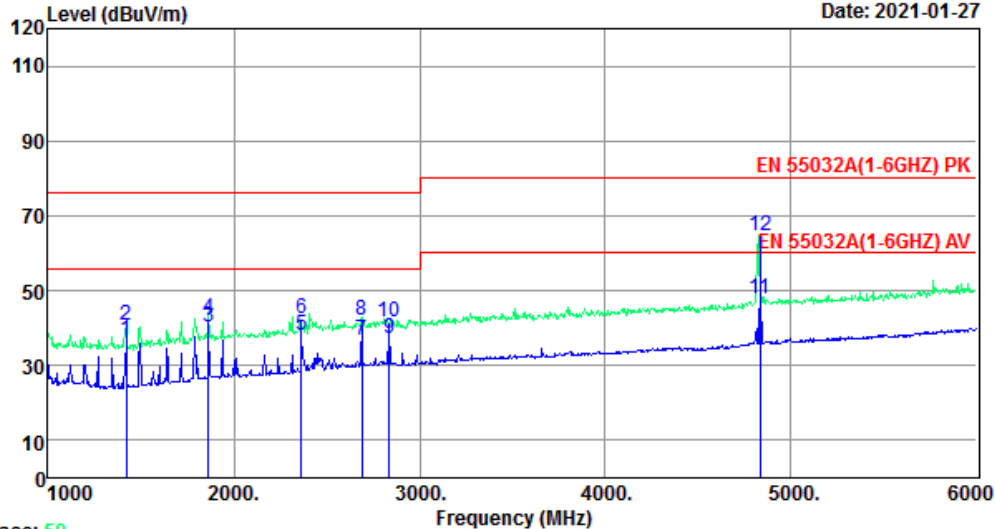
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	1195.00	24.76	1.08	7.73	33.57	56.00	22.43	Average
2	1195.00	24.76	1.08	10.85	36.69	76.00	39.31	Peak
3	1495.00	24.82	1.14	6.00	31.96	56.00	24.04	Average
4	1495.00	24.82	1.14	12.28	38.24	76.00	37.76	Peak
5	1790.00	25.75	1.23	8.61	35.59	56.00	20.41	Average
6	1790.00	25.75	1.23	11.92	38.90	76.00	37.10	Peak
7	2305.00	27.13	1.41	6.08	34.62	56.00	21.38	Average
8	2305.00	27.13	1.41	13.18	41.72	76.00	34.28	Peak
9	2365.00	27.21	1.43	5.89	34.53	56.00	21.47	Average
10	2365.00	27.21	1.43	13.73	42.37	76.00	33.63	Peak
11	4825.00	31.18	3.26	18.62	53.06	60.00	6.94	Average
12	4825.00	31.18	3.26	22.82	57.26	80.00	22.74	Peak

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.
 2. Margin= Limit - Emission Level.
 3. The emission levels that are 20dB below the official limit are not reported.

Data: 60

File: \\EMC-966-1\test data\2021\X\in pu si.EM6 (64)

Date: 2021-01-27



Trace: 59

Site no. : 1# 966 Chamber Data no. : 60
 Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : VERTICAL
 Limit : EN 55032A(1-6GHZ) PK
 Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
 Engineer : Sho
 EUT : Embedded Industrial Computer
 Power : DC 24V From Adapter Input AC 230V/50Hz
 M/N : CS19108R236P
 Test Mode : Wifi Mode

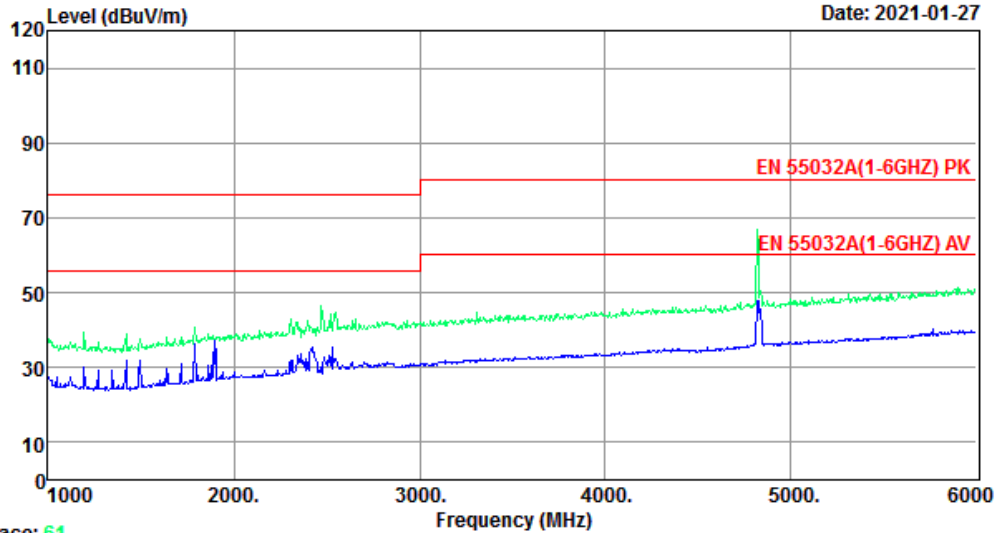
	Freq. (MHz)	ANT Factor (dB/m)	Cable Loss (dB)	Reading (dBuV)	Emission Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Remark
1	1420.00	24.56	1.13	11.18	36.87	56.00	19.13	Average
2	1420.00	24.56	1.13	14.96	40.65	76.00	35.35	Peak
3	1865.00	26.10	1.25	12.79	40.14	56.00	15.86	Average
4	1865.00	26.10	1.25	15.28	42.63	76.00	33.37	Peak
5	2365.00	27.21	1.43	9.63	38.27	56.00	17.73	Average
6	2365.00	27.21	1.43	13.92	42.56	76.00	33.44	Peak
7	2690.00	27.84	1.75	7.06	36.65	56.00	19.35	Average
8	2690.00	27.84	1.75	12.29	41.88	76.00	34.12	Peak
9	2835.00	28.20	1.96	6.92	37.08	56.00	18.92	Average
10	2835.00	28.20	1.96	11.38	41.54	76.00	34.46	Peak
11	4835.00	31.24	3.28	13.42	47.94	60.00	12.06	Average
12	4835.00	31.24	3.28	29.92	64.44	80.00	15.56	Peak

Remarks: 1. Emission Level= Antenna Factor + Cable Loss + Reading.
 2. Margin= Limit - Emission Level.
 3. The emission levels that are 20dB below the official limit are not reported.

Data: 62

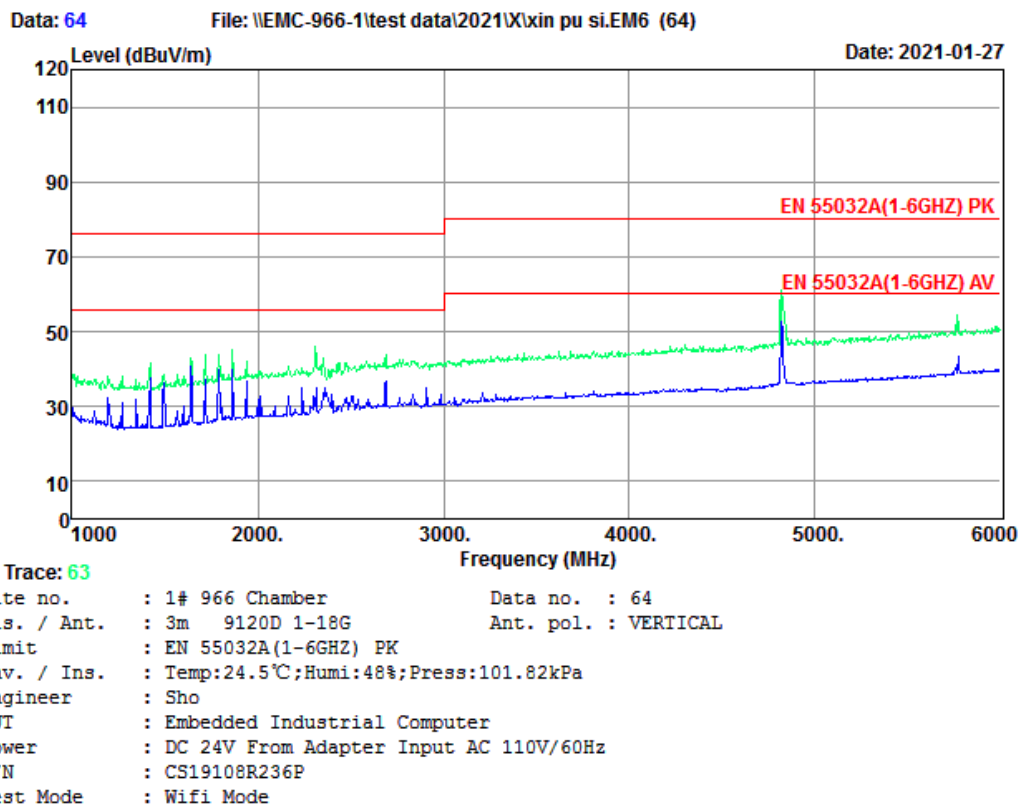
File: \\EMC-966-1\\test data\\2021\\X\\xin pu si.EM6 (64)

Date: 2021-01-27



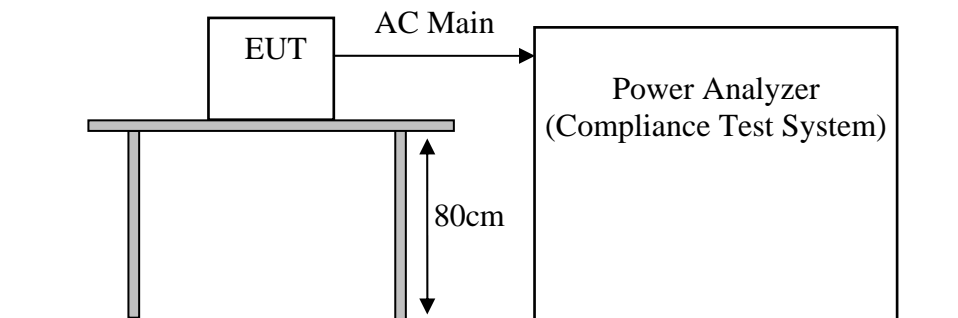
Trace: 61

Site no. : 1# 966 Chamber Data no. : 62
Dis. / Ant. : 3m 9120D 1-18G Ant. pol. : HORIZONTAL
Limit : EN 55032A(1-6GHZ) PK
Env. / Ins. : Temp:24.5°C;Humi:48%;Press:101.82kPa
Engineer : Sho
EUT : Embedded Industrial Computer
Power : DC 24V From Adapter Input AC 110V/60Hz
M/N : CS19108R236P
Test Mode : Wifi Mode



4.5. Harmonic Current Emissions on AC Mains Test

RESULT : N/A
Test procedure : EN IEC 61000-3-2:2019
Measured harmonics : 1~40th
Limits : EN IEC 61000-3-2:2019



There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN IEC 61000-3-2:2019

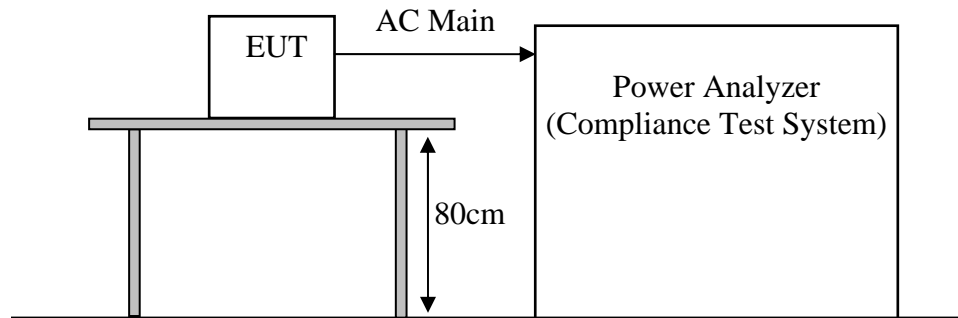
For further details, please refer to Clause 7 of EN IEC 61000-3-2:2019 which states:

“For the following categories of equipment, limits are not specified in this edition of the standard:

- equipment with a rated power of 75W or less, other than lighting equipment.”

4.6. Voltage Fluctuations and Flicker on AC Mains Test

RESULT : **Pass**(Please refer to the following page)
Test procedure : EN 61000-3-3:2013+A1:2019
Limits : EN 61000-3-3:2013+A1:2019



Test Data

Flicker Test Summary per EN/IEC61000-3-3 Ed. 3.0 (2013) (Run time)

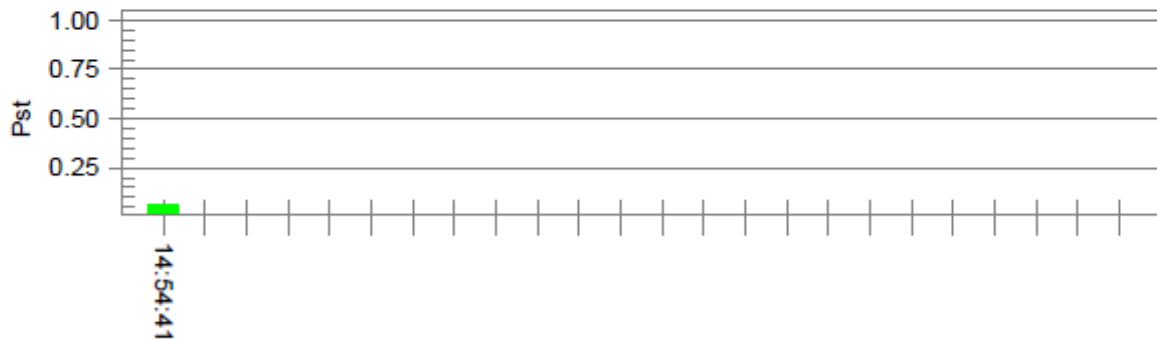
EUT: Embedded Industrial Computer M/N:CS19108R236P Tested by: ZANE
Test category: All parameters (European limits) Test Margin: 100
Test date: 2021/1/31 Start time: 14:44:20 End time: 14:54:47
Test duration (min): 10 Data file name: F-000193.cts_data
Comment: USB MODE
Customer: Xin Pu Si

Test Result: Pass

Status: Test Completed

Pst, and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:

Vrms at the end of test (Volt):	230.51		
T-max (mS):	0	Test limit (mS):	500.0 Pass
Highest dc (%):	0.00	Test limit (%):	3.30 Pass
Highest dmax (%):	0.00	Test limit (%):	4.00 Pass
Highest Pst (10 min. period):	0.064	Test limit:	1.000 Pass
Highest Plt (2 hr. period):	0.028	Test limit:	0.650 Pass

5. IMMUNITY TEST RESULT

5.1. Description of Performance Criteria:

Performance criteria A

The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

For audio output device: The measured acoustic interference ratio and/or the measured electrical interference during the test shall be -20dB or better(see note1)

Performance criteria B

During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.

After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criteria C

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.

Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

Note 1: This performance criterion only using for Continuous inducted RF disturbances and Continuous RF electromagnetic field disturbances item.

5.2. Electrostatic Discharge Immunity Test

RESULT : **Pass**

Test procedure : EN 55035:2017

Basic standard : EN 61000-4-2:2009

Test specification : +/-4.0kV(Contact discharge)
+/-8.0kV(Air discharge)

Number of discharges : ≥ 10 (Air discharge for single polarity discharge)
 ≥ 10 (Contact discharge for single polarity discharge)

Polarity : Positive/Negative

Performance criterion : B

Test Setup

Date of test : Feb. 02, 2021

Model No. : CS19108R236P

Input Voltage : DC 24V From Adapter Input AC 230V/50Hz

Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode, Type-C Mode

Temperature : 21.1°C

Humidity : 52%

Pressure : 101.10kPa

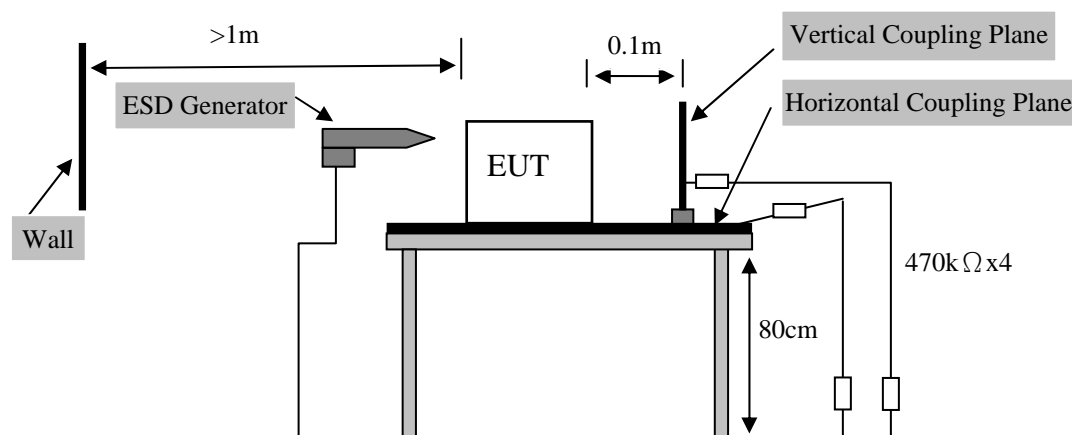


Table 1: Electrostatic Discharge Immunity Test Result

Discharge Location		Type of discharge	Result
HCP	4 points	Contact	Pass
VCP	4 points	Contact	Pass
LAN Port	1 point	Contact	Pass
USB Port	5 points	Contact	Pass
Type-C Port	1 point	Contact	Pass
AUX Port	1 point	Air	Pass
DC Port	1 point	Air	Pass
Metal decking	10 points	Contact	Pass
Screen	1 point	Air	Pass

*Remark: 1. The screen was flashing during the test, but self-recoverable after the test.
2. Discharge should be considered on Contact and Air and Horizontal Coupling Plane (HCP) and Vertical Coupling Plane (VCP).*

5.3. Radio Frequency Electromagnetic Field Immunity(R/S) Test

RESULT : **Pass**
Test procedure : EN 55035:2017
Basic standard : EN 61000-4-3:2006+A1:2008+A2:2010
Frequency Range : 80-1000MHz,1800MHz, 2600MHz, 3500MHz, 5000MHz
Performance criterion : A
Test site : 866 Chamber

Test Setup

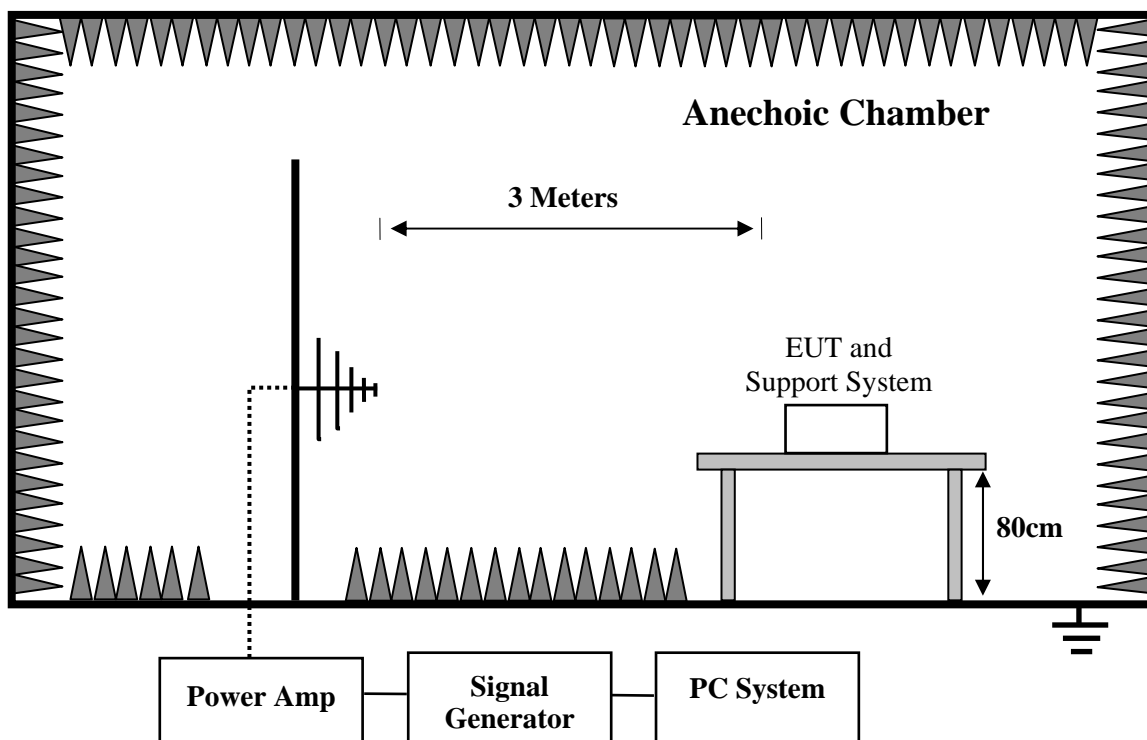
Date of test : Feb. 02, 2021
Model No. : CS19108R236P
Input Voltage : DC 24V From Adapter Input AC 230V/50Hz,
DC 24V From Adapter Input AC 110V/60Hz
Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode,
Type-C Mode
Temperature : 21.3°C
Humidity : 52%
Pressure : 101.10kPa

The EUT and its simulators were placed on a turn table which was 0.8 meter above the ground. The EUT was set 3 m away from the transmitting antenna which was mounted on an antenna tower. Both horizontal and vertical polarization of the antenna were set on test. Each of the four sides of EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a CCD camera was used to monitor EUT screen.

All the scanning conditions were as follows:

Condition of Test	Remarks
1. Field Strength	3 V/m (Severity Level 2)
2. Radiated Signal	Modulated
3. Scanning Frequency	80 - 1000 MHz
4. Sweeping time of radiated	0.0015 decade/s
5. Dwell Time	at least 3 seconds



Condition of Test

Remarks

6. Field Strength	3 V/m (Severity Level 2)
7. Radiated Signal	Modulated
8. Scanning Frequency	1800MHz,2600MHz,3500MHz,5000MHz
9. Sweeping time of radiated	0.0015 decade/s
10. Dwell Time	at least 3 seconds

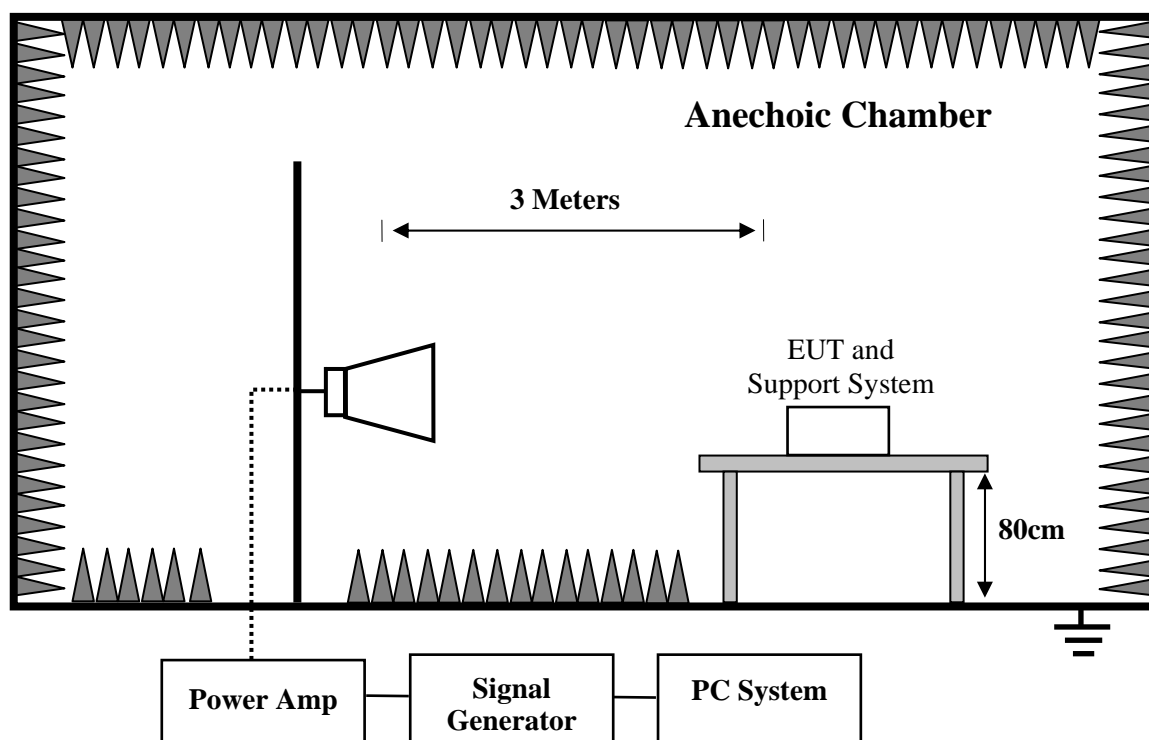


Table 2: Radio Frequency Electromagnetic Field Immunity Test Result

Field Strength (V/m)	Test Frequency (MHz)	Test mode	Polarization of antenna	Reference Level	Audio output	Limit	Interference Ratio (worst case)
3	80-1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz	Wi-Fi Mode	H	75dBSPL	Speaker	\leq -20dB	-57 dB
			V	75dBSPL	Speaker		-39 dB

5.4. Electrical Fast Transient/Burst Immunity Test

RESULT	: Pass
Test procedure	: EN 55035:2017
Basic standard	: EN 61000-4-4:2012
Pulseform	: Tr/Th = 5/50ns
Repetition Frequency	: 5 kHz ; (100 kHz : only for single lines of xDSL equipment)
Test Duration	: 120s
Performance criterion	: B

Test Setup

Date of test	: Feb. 02, 2021
Model No.	: CS19108R236P
Input Voltage	: DC 24V From Adapter Input AC 230V/50Hz, DC 24V From Adapter Input AC 110V/60Hz
Operation Mode	: LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode, Type-C Mode
Temperature	: 22.3°C
Humidity	: 51%
Pressure	: 101.10kPa

The EUT and its simulators were placed 0.1 m high above the ground reference plane which was a minimum 2m*2m metallic sheet with 0.65mm minimum thickness. This reference ground plane shall project beyond the EUT by at least 0.1 m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane beneath the EUT, shall be more than 0.5m.

1. For power input port:

The EUT was connected to the power mains by using a coupling device which coupled the EFT interference signal to AC power lines. Both polarities of the test voltage were applied during compliance test and the duration of the test were 2mins.

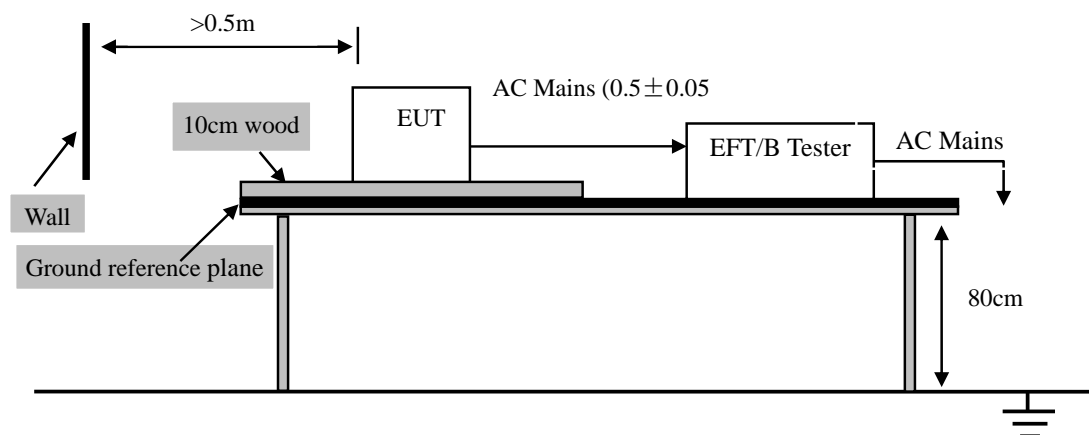


Table 5: Electrical Fast Transient/Burst Immunity Test Result

Coupling Ports		Coupling Voltage	Inject Method	Result
AC Power Ports	L	± 1 kV	Direct	Pass
	N	± 1 kV		Pass
	PE	± 1 kV		Pass
	L-N	± 1 kV		Pass
	L-PE	± 1 kV		Pass
	N-PE	± 1 kV		Pass
	L-N-PE	± 1 kV		Pass

Remark: The screen was flashing during the test, but self-recoverable after the test.

5.5. Surge Immunity Test

RESULT : **Pass**
Test procedure : EN 55035:2017
Basic standard : EN 61000-4-5:2014
Pulse form : $Tr/Td = 1.2/50\mu s$
Test Duration : 60s
Performance criterion : B

Test Setup

Date of test : Feb. 02, 2021
Model No. : CS19108R236P
Input Voltage : DC 24V From Adapter Input AC 230V/50Hz,
DC 24V From Adapter Input AC 110V/60Hz
Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode,
Type-C Mode
Temperature : 22.3°C
Humidity : 52%
Pressure : 101.10kPa

2 Ω effective output impedance of the generator was used for L-N test. 12 Ω effective output impedance of the generator was used for L-PE, N-PE test.

5 positive and 5 negative (polarity) tests were applied successively synchronized to the voltage phase 90°, 270° to L-N respectively. The repetition rate was 1 per minute during test.

1. For input and AC power ports:

The EUT was connected to the power mains by using a coupling device which coupled the surge interference signal to AC power lines. Both polarities of the test voltage should be applied during compliance test and the duration was 1 minute.

2. For signal lines and control lines ports:

None.

3. For DC input and DC output power ports:

None.

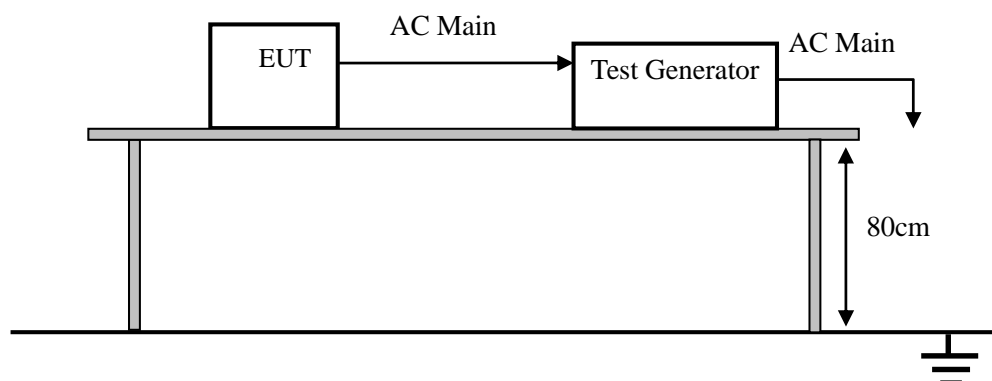


Table 4: Surge Immunity Test Result

Coupling Ports		Coupling Voltage	Coupling Phase / Result			
			0°	90°	180°	270°
AC power ports	L-N	+/-1kV Direct	/	Pass	/	Pass
	L-PE	+/-2kV Direct	/	Pass	/	Pass
	N-PE	+/-2kV Direct	/	Pass	/	Pass

Remark: The screen was flashing during the test, but self-recoverable after the test.

5.6. Injected Currents Susceptibility Test

RESULT	: Pass
Test procedure	: EN 55035:2017
Basic standard	: EN 61000-4-6:2014
Test specification	: 3 Vr.m.s, 3 Vr.m.s - 1Vr.m.s, 1Vr.m.s, AM 80%, 0.15 MHz - 10 MHz, 10 MHz – 30 MHz, 30 MHz – 80MHz
Performance criterion	: A

Test Setup

Date of test	: Feb. 02, 2021
Model No.	: CS19108R236P
Input Voltage	: DC 24V From Adapter Input AC 230V/50Hz, DC 24V From Adapter Input AC 110V/60Hz
Operation Mode	: LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode, Type-C Mode
Temperature	: 20.3°C
Humidity	: 50%
Pressure	: 101.10kPa

The EUT were placed on an insulating support 0.1m high above a ground reference plane. CDN (coupling and decoupling device) was placed on the ground plane about 0.3m from EUT. Cables between CDN and EUT were as short as possible, and their height above the ground reference plane were between 30 and 50 mm (where possible).

The frequency range was swept from 0.15 MHz - 10 MHz, 10 MHz – 30 MHz and 30 MHz – 80MHz using 3V, 3 V - 1V, 1V signal level, and with the disturbance signal 80% amplitude modulated with a 1KHz sine wave.

The rate of sweep shall not exceed 1.5×10^{-3} decades/s. Where the frequency was swept incrementally, the step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value.

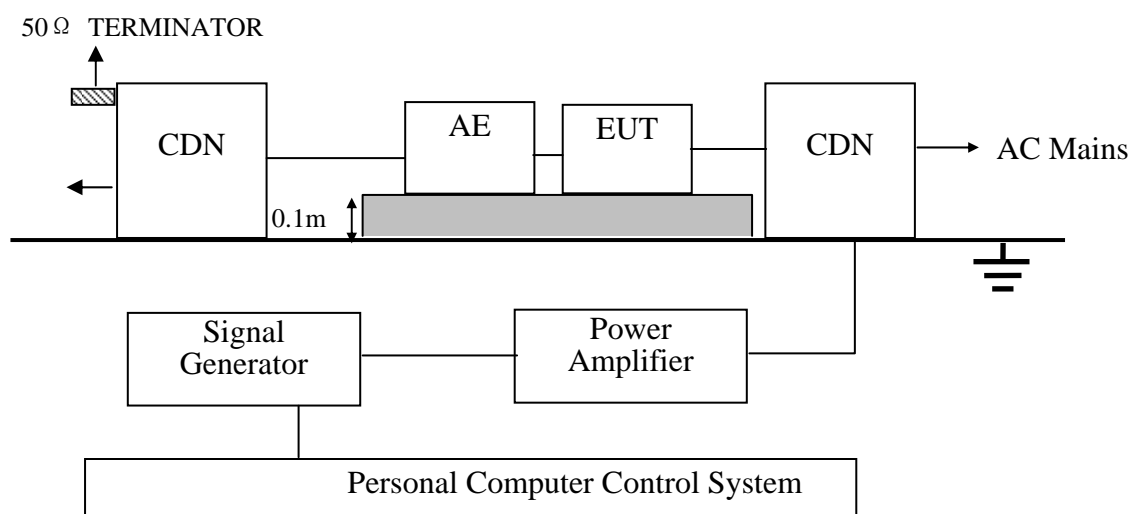


Table 5: Injected Currents Susceptibility Test Result

Voltage (V)	Test Frequency (MHz)	Test mode	Injection Method	Reference Level	Audio output	Limit	Interference Ratio (worst case)
3	0.15 –10 MHz	Wi-Fi Mode	CDN-M3	75dBSPL	Speaker	\leq -20dB	-35 dB
3 -1	10 –30 MHz						-38 dB
1	30 –80 MHz						-40 dB

5.7. Power Frequency Magnetic Field Immunity Test

RESULT : **Pass**
Test procedure : EN 55035:2017
Basic standard : EN 61000-4-8:2010
Test specification : 1 A/m
Performance criterion : A

Test Setup

Date of test : Feb. 02, 2021
Model No. : CS19108R236P
Input Voltage : DC 24V From Adapter Input AC 230V/50Hz,
DC 24V From Adapter Input AC 110V/60Hz
Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode,
Type-C Mode
Temperature : 20.3°C
Humidity : 52%
Pressure : 101.10kPa

The EUT was subjected to the test magnetic field by using the induction coil of standard dimensions (1m*1m). The induction coil then was rotated by 90° in order to expose the EUT to the test field with different orientations.

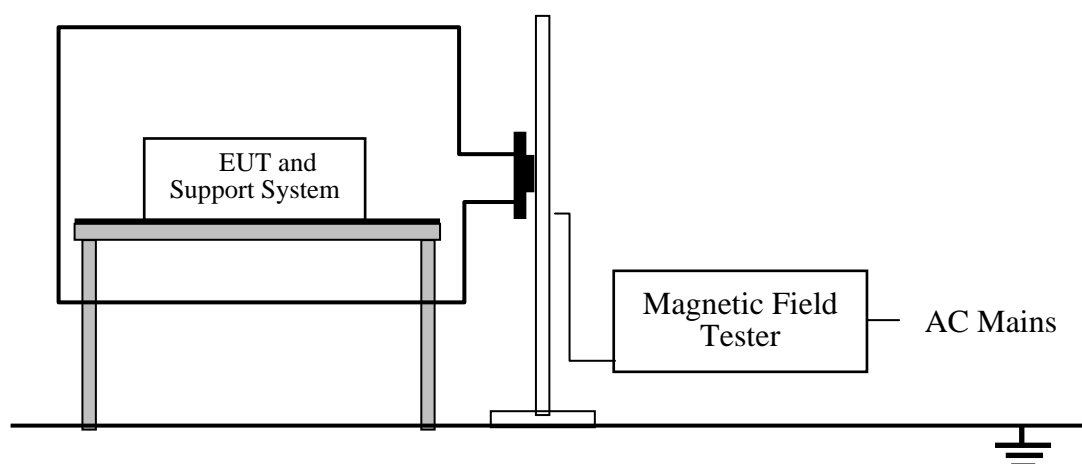


Table 6: Power Frequency Magnetic Field Immunity Test Result

Test Level	Testing Duration	Coil Orientation	Criterion	Result
1A/m	5 mins	X	A	Pass
1A/m	5 mins	Y	A	Pass
1A/m	5 mins	Z	A	Pass

Remark: There was no change compared with initial operation during the test

5.8. Voltage Dips and Short Interruptions Immunity Test

RESULT : **Pass**

Test procedure : EN 55035:2017

Basic standard : EN 61000-4-11:2004

Test specification : 0% UT ; 0.5P, Criterion: B
70% UT; 25P/30P, Criterion: C
0% UT; 250P/300P, Criterion: C

Test Setup

Date of test : Feb. 02, 2021

Model No. : CS19108R236P

Input Voltage : DC 24V From Adapter Input AC 230V/50Hz,
DC 24V From Adapter Input AC 110V/60Hz

Operation Mode : LAN Mode, Bluetooth Mode, Wi-Fi Mode, USB Mode,
Type-C Mode

Temperature : 21.5°C

Humidity : 52%

Pressure : 101.10kPa

The interruptions was introduced at selected phase angles with specified duration.
Recorded any degradation of performance.

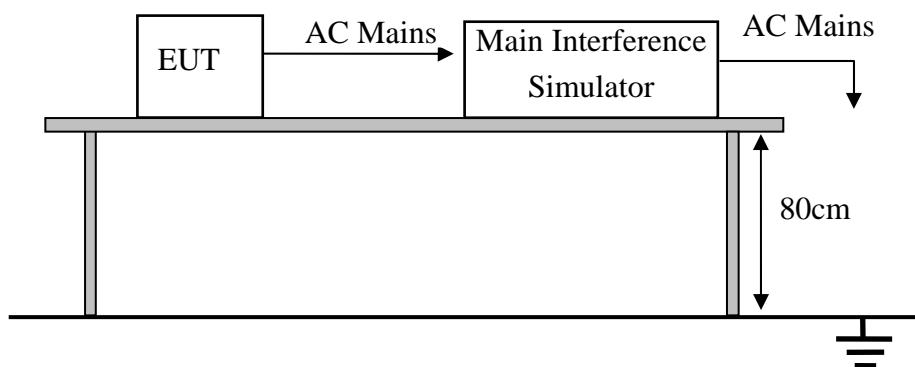


Table 7: Voltage Dips and Short Interruptions Immunity Test Result AC 230V/50Hz

Test Level % UT	Voltage Dips & Short Interruptions % UT	Duration (in period)	Criterion	Result
0	100	0.5P	B	PASS
70	30	25P	C	PASS
0	100	250P	C	PASS

Remark: The screen was flashing during the test, but self-recoverable after the test.

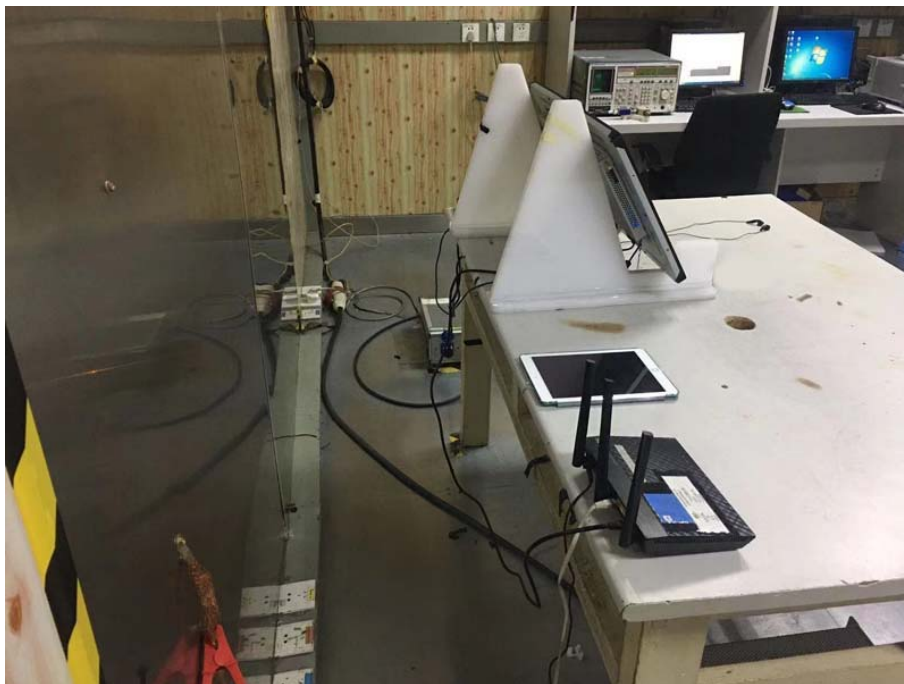
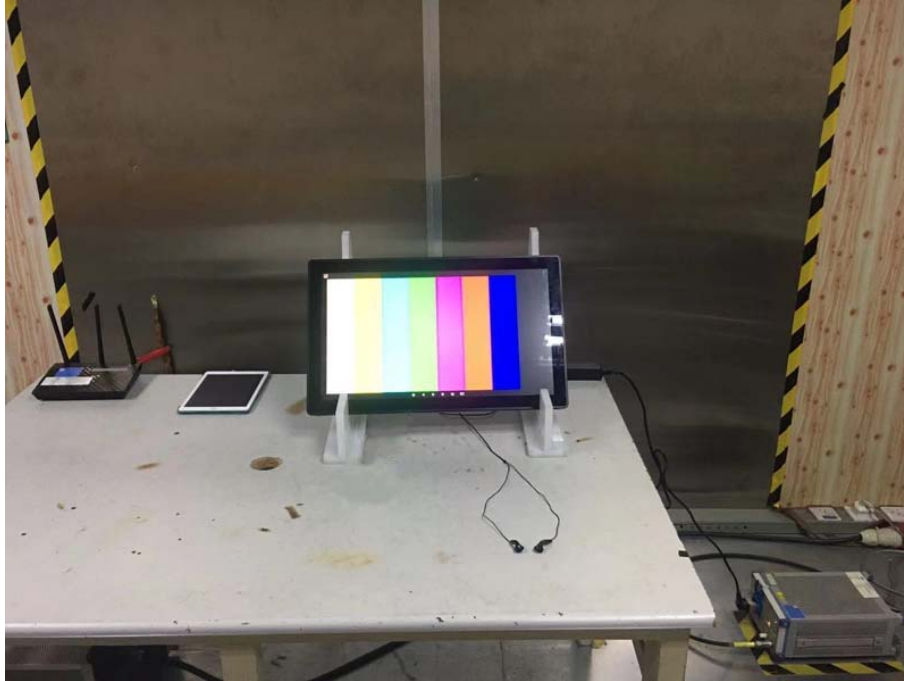
Table 8: Voltage Dips and Short Interruptions Immunity Test Result AC 110V/60Hz

Test Level % UT	Voltage Dips & Short Interruptions % UT	Duration (in period)	Criterion	Result
0	100	0.5P	B	PASS
70	30	30P	C	PASS
0	100	300P	C	PASS

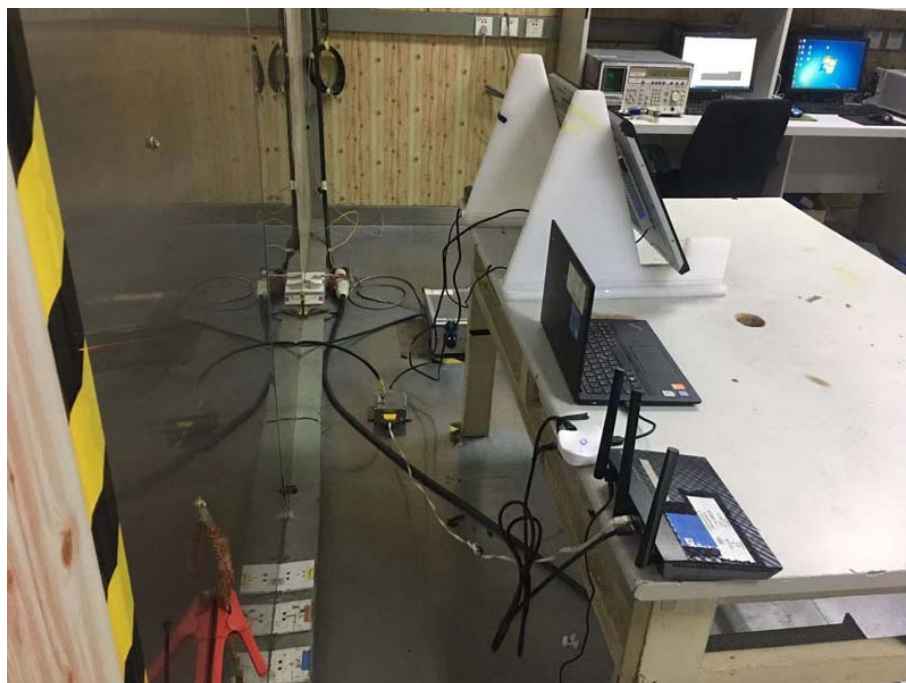
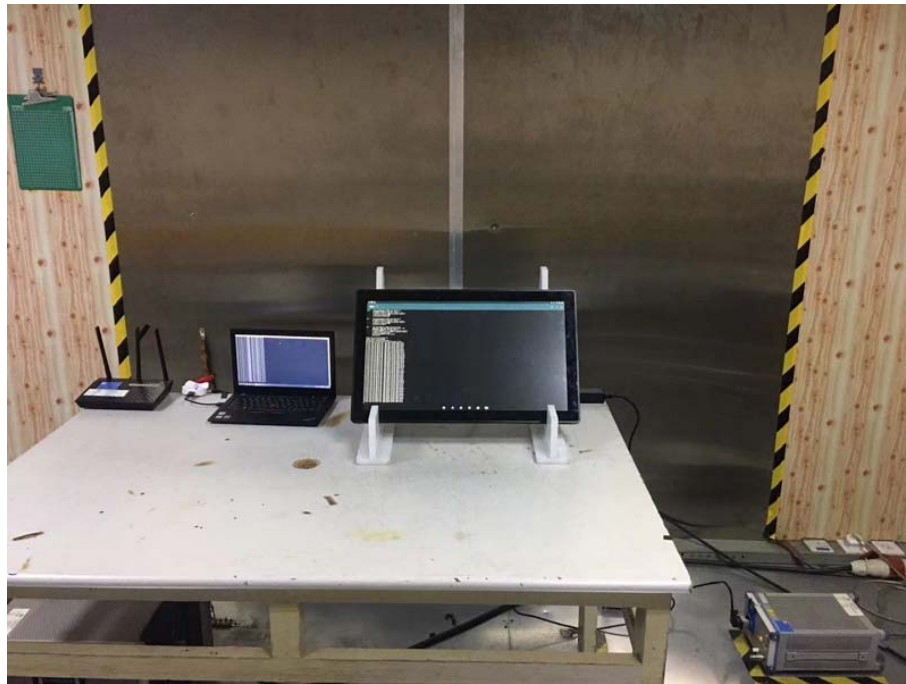
Remark: The screen was flashing during the test, but self-recoverable after the test.

6. PHOTOGRAPHS OF TEST SET-UP

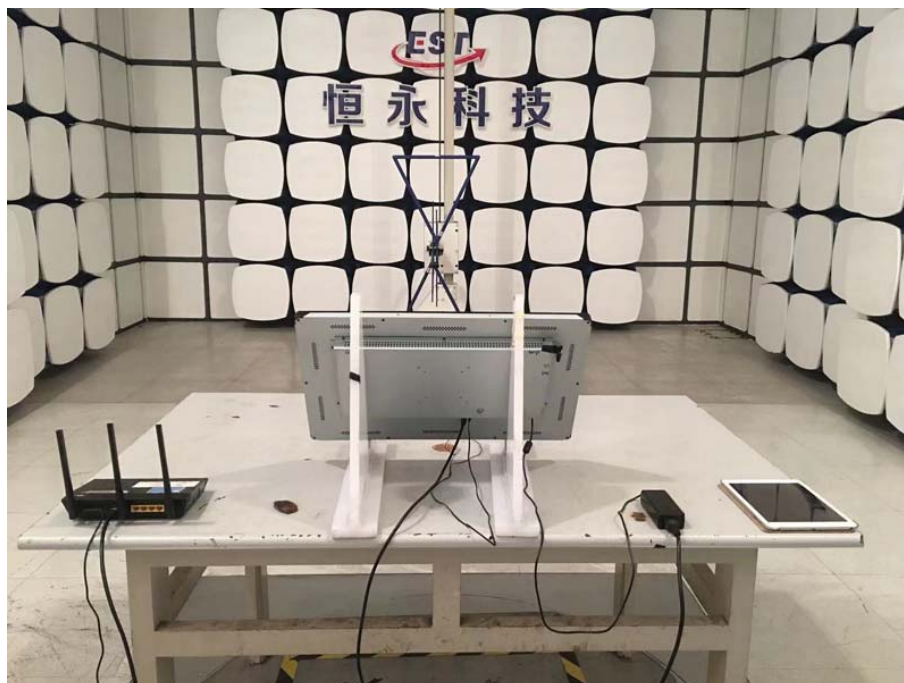
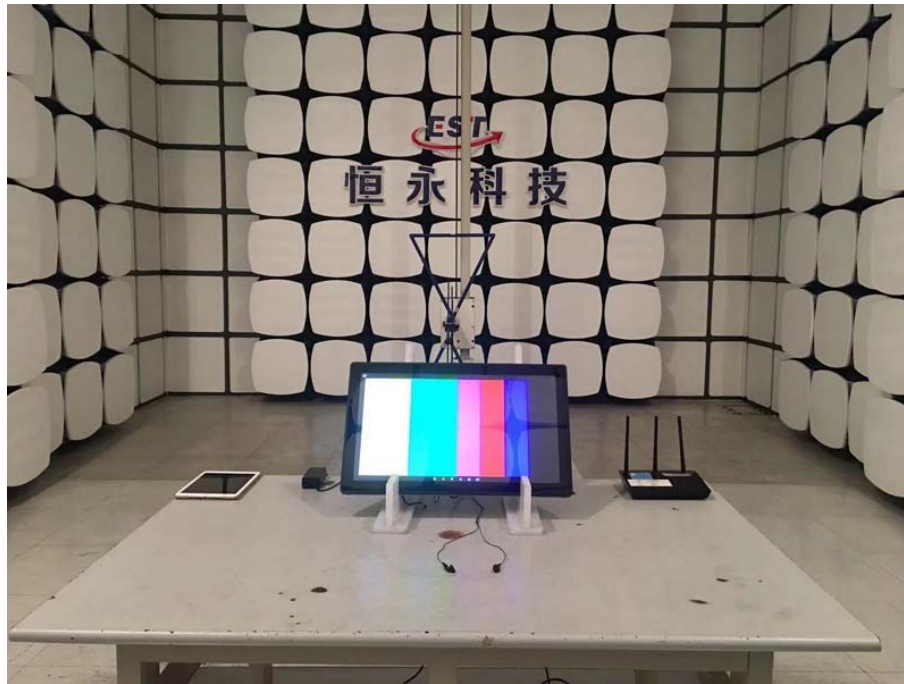
6.1.Set-up for Conducted Emission at the Mains Terminals Test



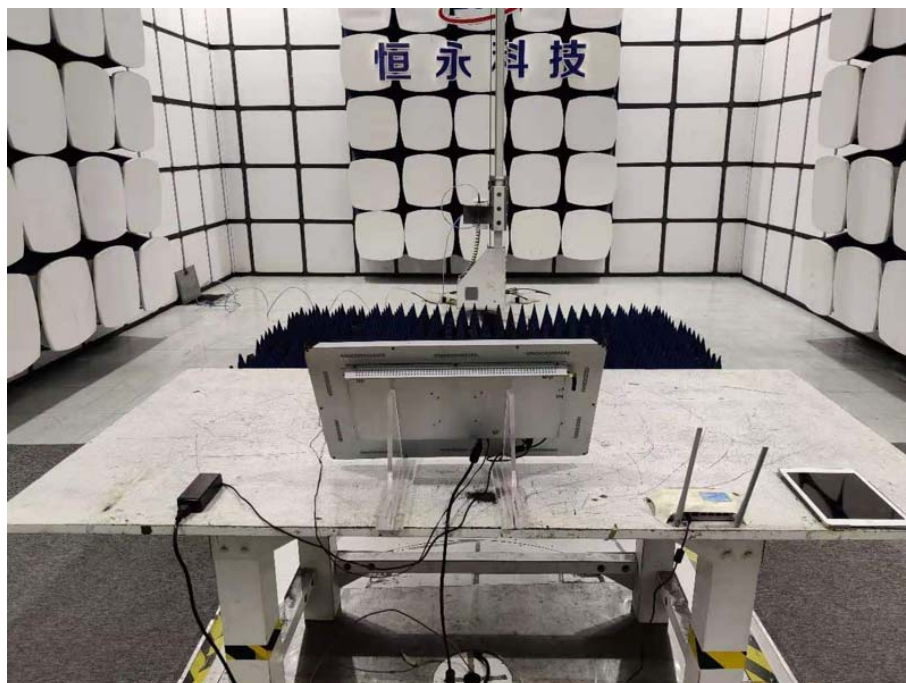
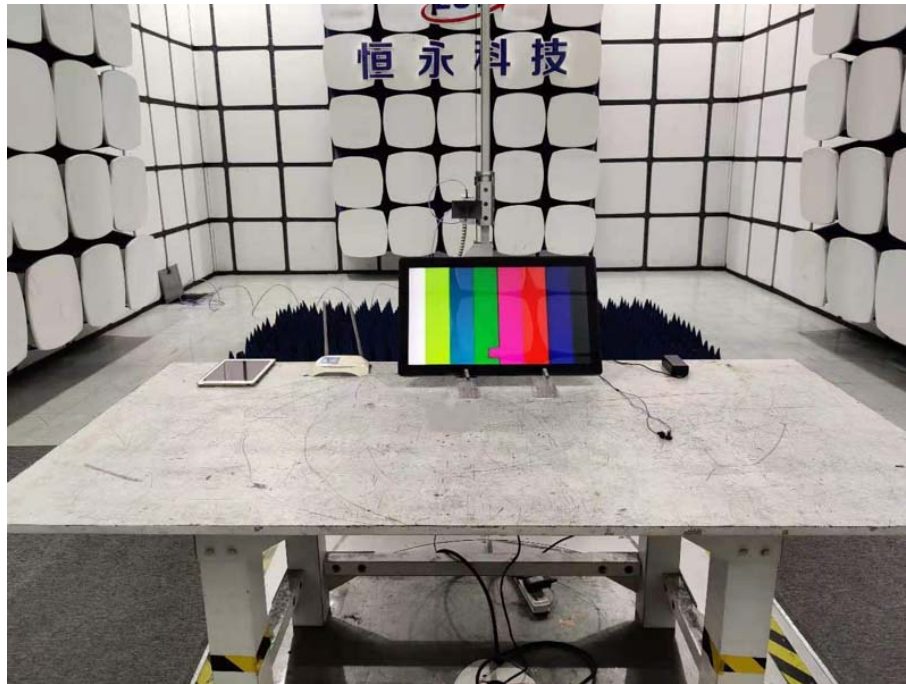
6.2.Set-up for Asymmetric Mode Conducted Emissions Test



6.3.Set-up for Radiated Emission Test



6.4.Set-up for Radiated Emission Test(above 1GHz)



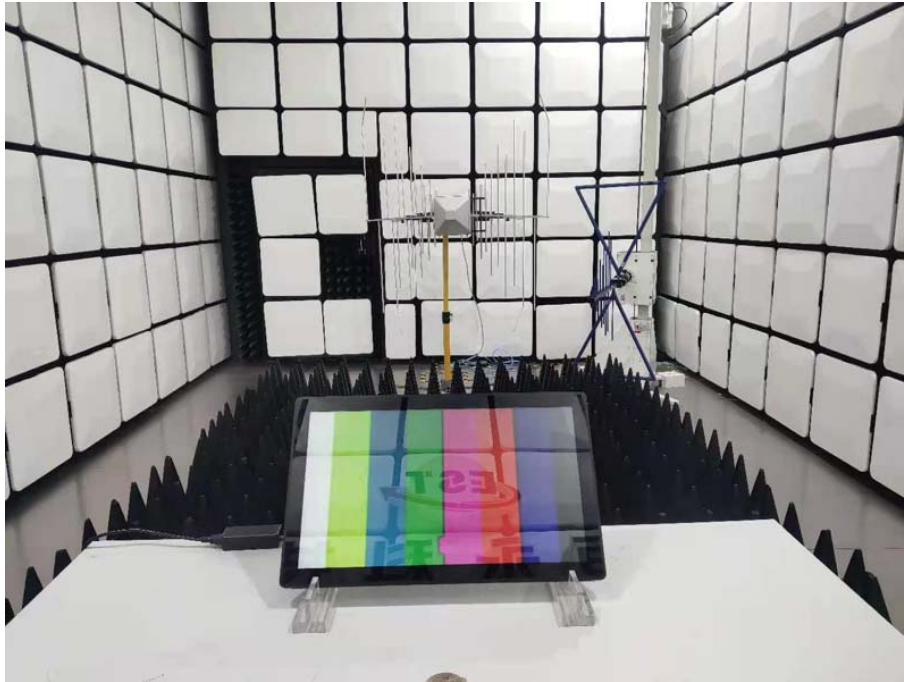
6.5.Set-up for Harmonic Current Emissions and Flicker on AC Mains Test



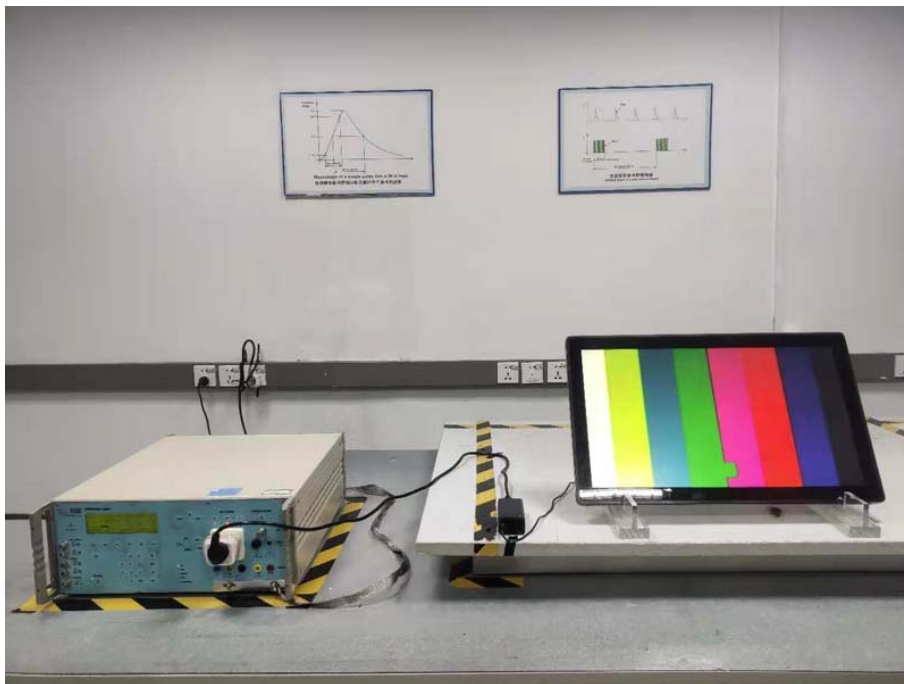
6.6.Set-up for Electrostatic Discharge Immunity Test



6.7.Set-up for Radio Frequency Electromagnetic Field Immunity(R/S) Test



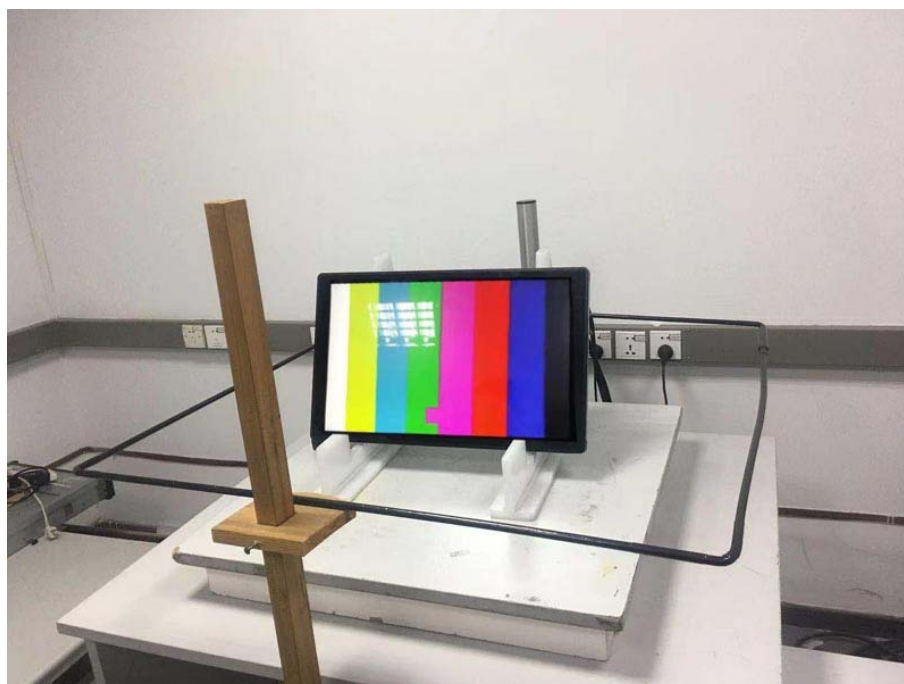
6.8.Set-up for Electrical Fast Transient/Burst Immunity Test



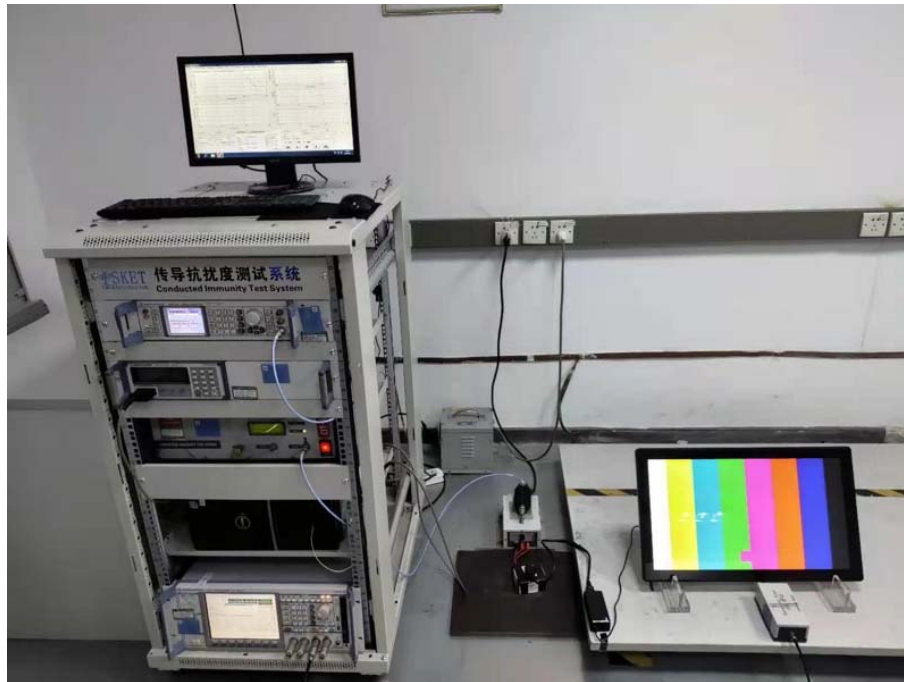
6.9.Set-up for Surge Immunity Test



6.10.Set-up for Power Frequency Magnetic Field Immunity Test



6.11.Set-up for Injected Currents Susceptibility Test



6.12.Set-up for Voltage Dips and Short Interruptions Immunity Test



7. PHOTOGRAPHS OF THE EUT

Figure 1
General Appearance of the EUT



Figure 2
General Appearance of the EUT



Figure 3
General Appearance of the EUT



Figure 4
General Appearance of the EUT



Figure 5
Inside View of the EUT



Figure 6
Inside View of the EUT



Figure 7
Inside View of the EUT



Figure 8
Inside View of the EUT

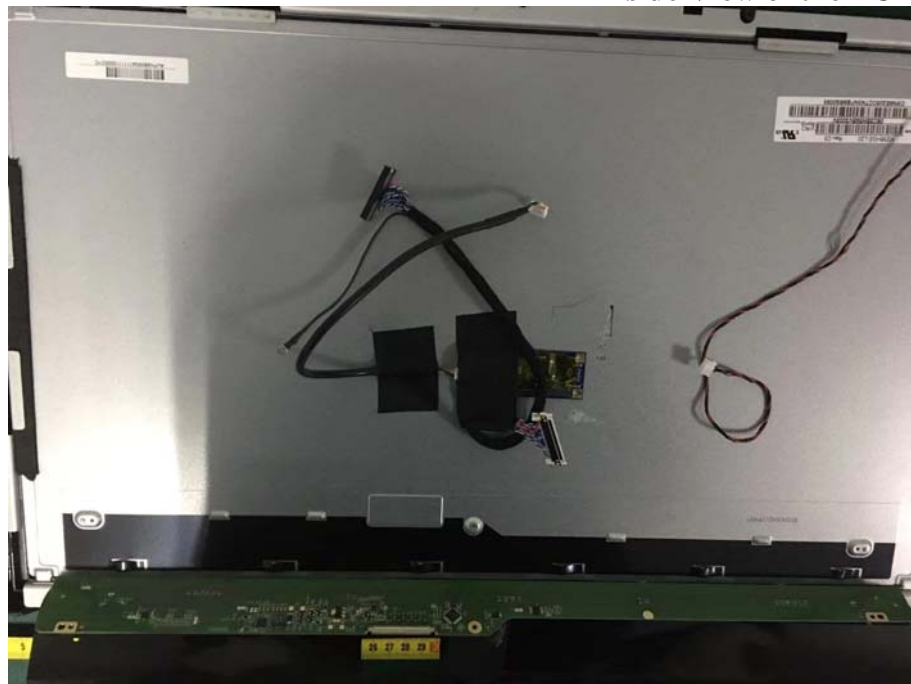


Figure 9
Inside View of the EUT

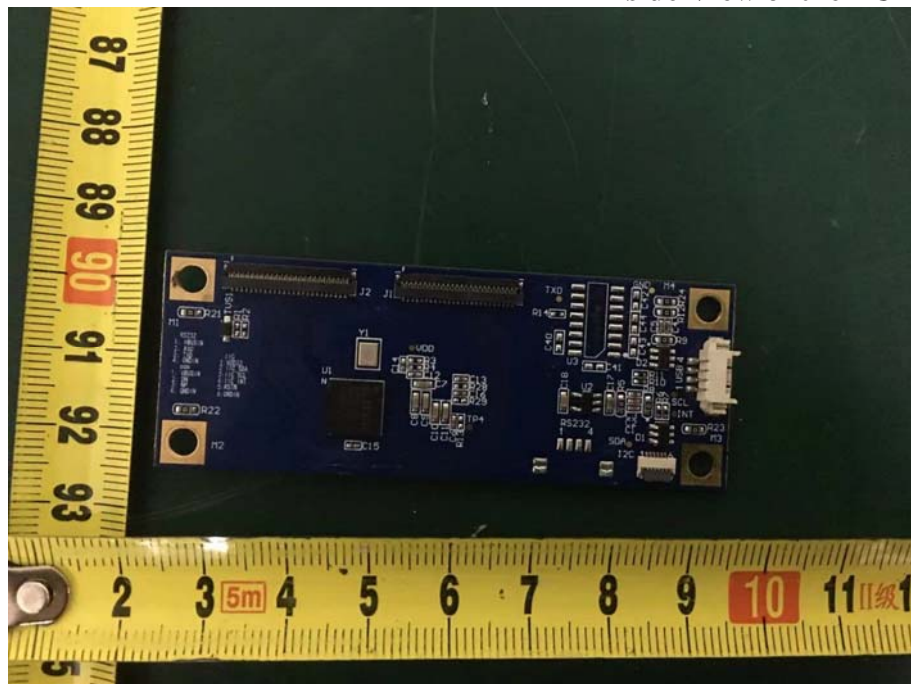


Figure 10
Inside View of the EUT

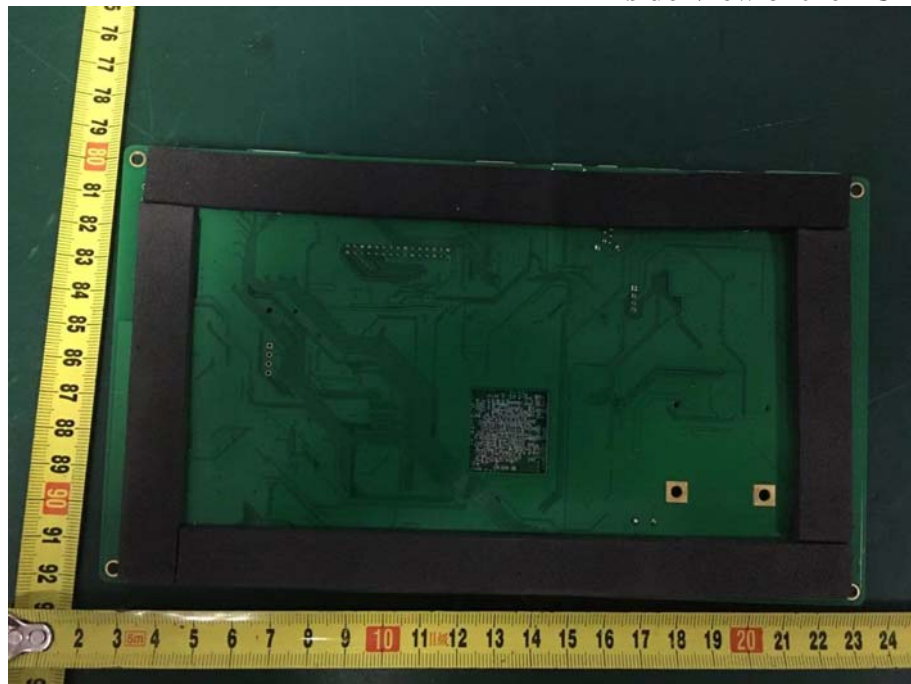


Figure 11
Inside View of the EUT



Figure 12
Inside View of the EUT

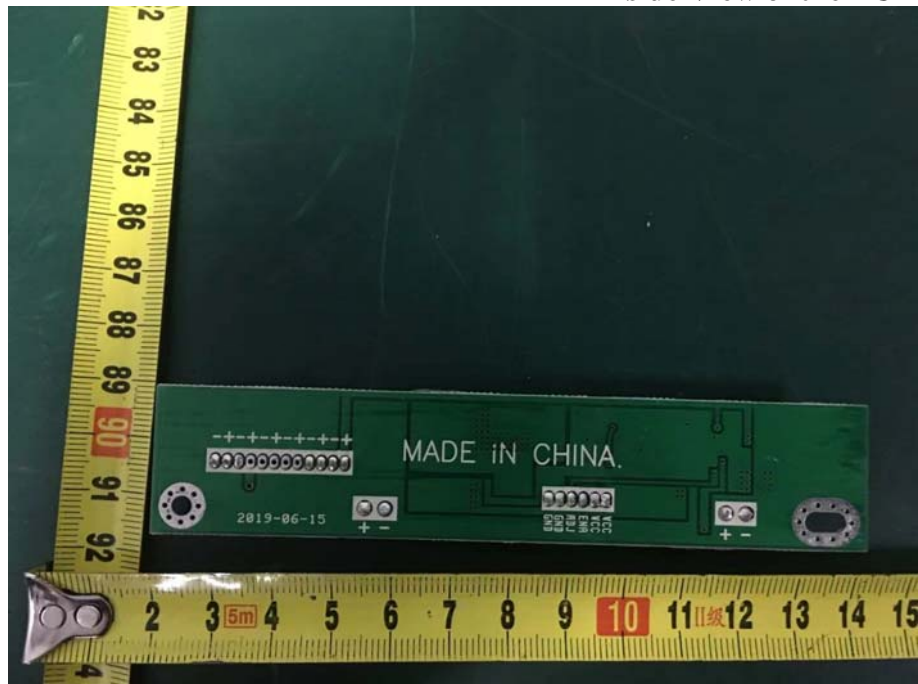


Figure 13
Inside View of the EUT

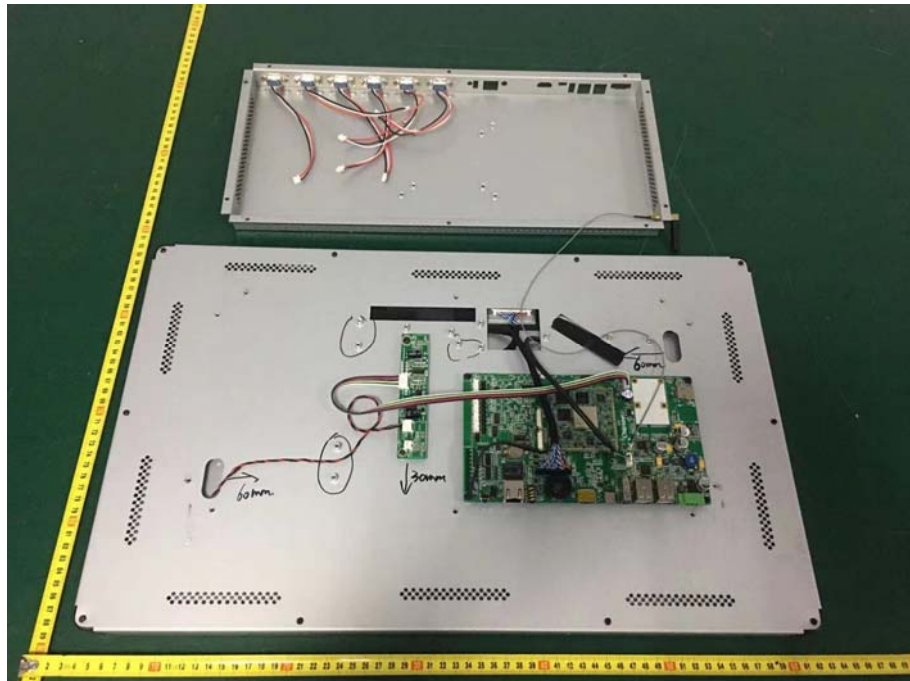


Figure 14
Inside View of the EUT

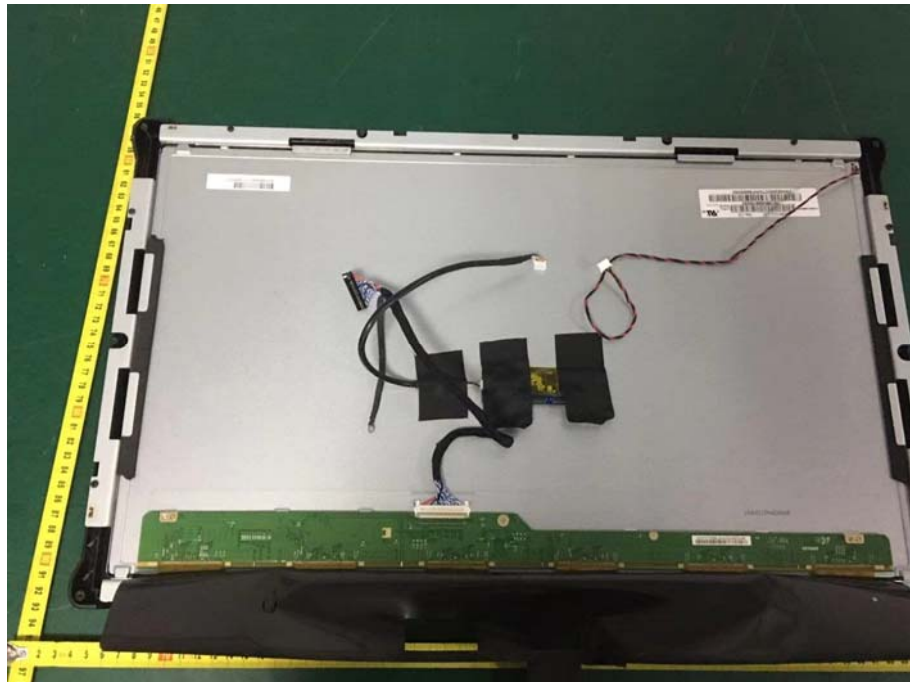
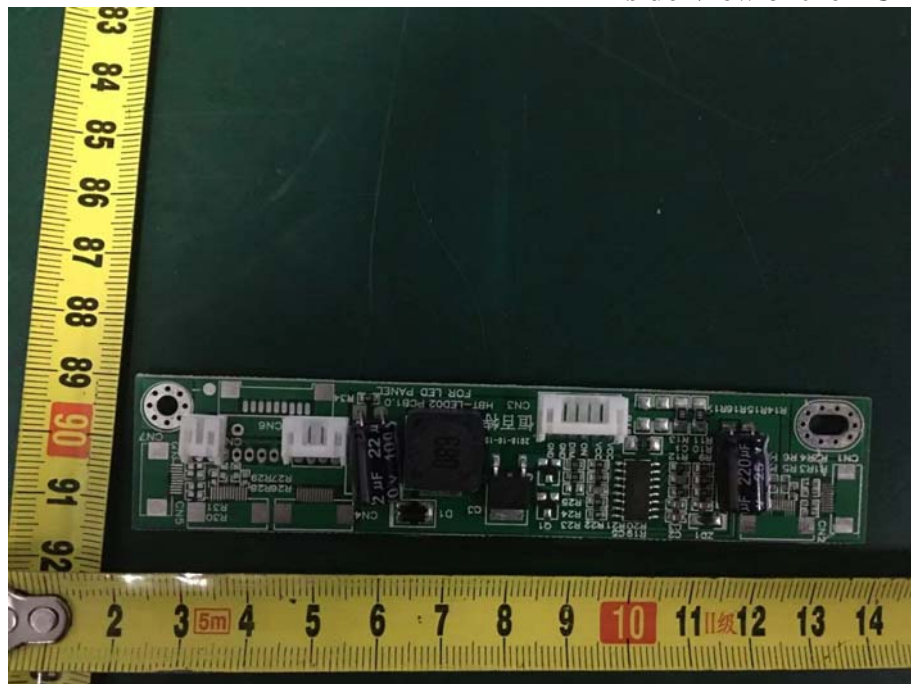


Figure 15
Inside View of the EUT



End of Test Report